

MSP430F663x 混合信号微控制器

1 特性

- 低电源电压范围：1.8V 至 3.6V
- 超低功耗
 - 激活模式 (AM)：
 - 所有系统时钟激活：
 - 8MHz 时为 270 μ A/MHz、3.0V、闪存程序执行 (典型值)
 - 待机模式 (LPM3)：
 - 含晶体的看门狗和电源监控器可用、完全 RAM 保持、快速唤醒：
 - 2.2V 时为 1.8 μ A、3.0V 时为 2.1 μ A (典型值)
 - 关断实时时钟 (RTC) 模式 (LPM3.5)：
 - 关断模式，含晶体的有源 RTC：
 - 3.0V 时为 1.1 μ A (典型值)
 - 关断模式 (LPM4.5)：
 - 3.0V 时为 0.3 μ A (典型值)
- 在 3 μ s (典型值) 内从待机模式唤醒
- 16 位 RISC 架构，扩展存储器，高达 20MHz 的系统时钟
- 灵活的电源管理系统
 - 具有可编程稳压内核电源电压的完全集成 LDO
 - 电源电压监控、监视和欠压保护
- 单一时钟系统
 - 针对频率稳定的锁相环 (FLL) 控制环路
 - 低功耗低频内部时钟源 (VLO)
 - 低频修整内部基准源 (REFO)
 - 32kHz 晶振 (XT1)
 - 高达 32MHz 的高频晶振 (XT2)
- 四个 16 位计时器，分别配有 3、5 或 7 个捕捉/比较寄存器
- 两个通用串行通信接口 (USCI)

- USCI_A0 和 USCI_A1 均支持：
 - 增强型通用异步收发器 (UART) 支持自动波特率检测
 - 红外数据通讯 (IrDA) 编码器和解码器
 - 同步 SPI
- USCI_B0 和 USCI_B1 均支持：
 - I²C
 - 同步串行外设接口 (SPI)
- 全速通用串行总线 (USB)
 - 集成的 USB - PHY
 - 集成 3.3V 和 1.8V USB 电源系统
 - 集成 USB 锁相环 (PLL)
 - 八输入和八输出端点
- 具有内部共用基准、采样保持和自动扫描功能的 12 位模数转换器 (ADC)
- 具有同步功能的双 12 位数模转换器 (DAC)
- 电压比较器
- 对比度控制高达 160 段的集成液晶显示器 (LCD) 驱动器
- 硬件乘法器支持 32 位运算
- 串行板载编程，无需外部编程电压，
- 6 通道内部 DMA
- 具有电源电压备用开关的 RTC 模块
- [器件比较](#)汇总了可用的产品系列成员

2 应用

- 模拟和数字传感器系统
- 数字电机控制
- 遥控
- 恒温器
- 数字计时器
- 手持式仪表

3 说明

TI MSP430™ 系列超低功耗微控制器种类繁多，各成员器件配备不同的外设集以满足各类应用的需求。此架构，与 5 种低功耗模式配合使用，是在便携式测量应用中实现延长电池寿命的最优选择。该器件具有一个强大的 16 位 RISC CPU，使用 16 位寄存器，以及常数发生器，以便于获得最大编码效率。该数控振荡器 (DCO) 可在 3 μ s (典型值) 内从低功率模式唤醒至激活模式。

MSP430F663x 器件为配有以下外设的微控制器：一个高性能 12 位 ADC、一个比较器、两个串行通信接口 (USCI)、USB 2.0、一个硬件乘法器、直接存储器访问 (DMA)、四个 16 位定时器、一个具有报警功能的 RTC 模块、一个 LCD 驱动器以及多达 74 个 I/O 引脚。

有关完整的模块说明，请参阅《MSP430F5xx 和 MSP430F6xx 系列用户指南》。

器件信息

器件型号 ⁽¹⁾	封装	封装尺寸 ⁽²⁾
MSP430F6638IPZ	LQFP (100)	14mm x 14mm
MSP430F6638IZCA	nFBGA (113)	7mm x 7mm



器件信息 (continued)

器件型号 ⁽¹⁾	封装	封装尺寸 ⁽²⁾
MSP430F6638IZQW ⁽³⁾	MicroStar Junior™ BGA (113)	7mm x 7mm

- (1) 要获得最新的器件、封装和订购信息，请参阅 *封装选项附录* ([节 11](#))，或者访问 TI 网站 www.ti.com.cn。
- (2) 这里显示的尺寸为近似值。要获得包含误差值的封装尺寸，请参阅 *机械数据* ([节 11](#) 中)。
- (3) 采用 ZQW (MicroStar Junior BGA) 封装的所有可订购器件型号均已更改为最晚可采购期限的状态。有关此状态的详细信息，请访问 [产品生命周期](#) 页面。

4 功能方框图

图 4-1 给出了 MSP430F6638、MSP430F6637 和 MSP430F6636 器件的功能框图。

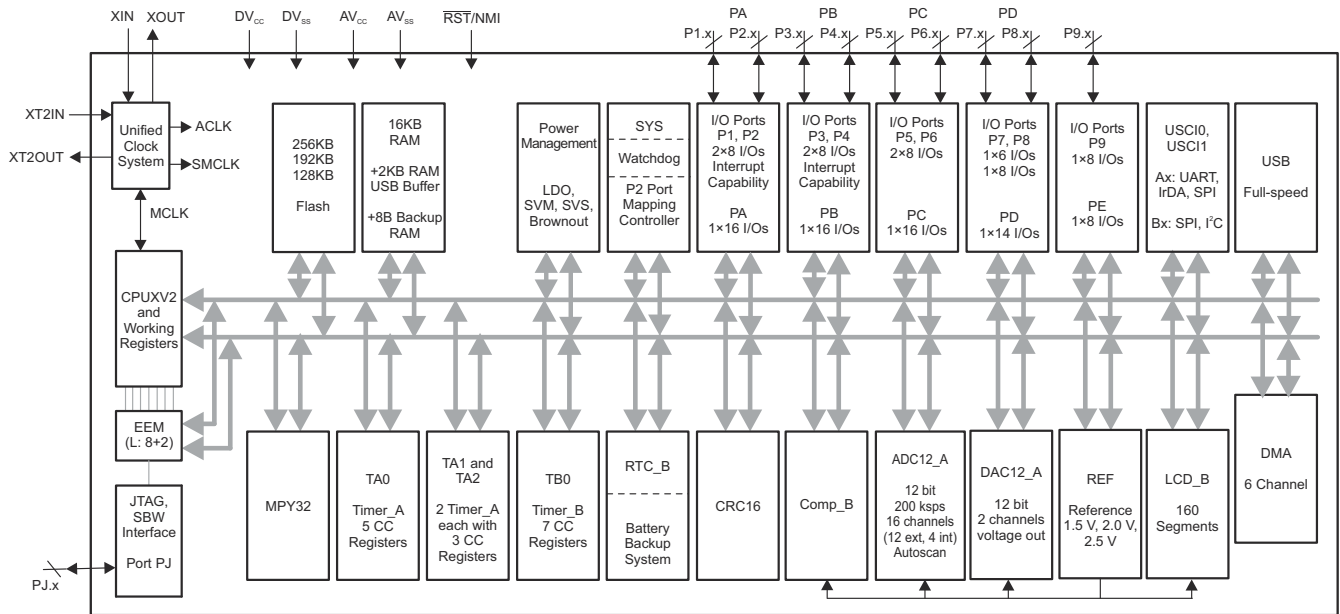


图 4-1. 功能框图 - MSP430F6638、MSP430F6637 和 MSP430F6636

图 4-2 给出了 MSP430F6635、MSP430F6634 和 MSP430F6633 器件的功能框图。

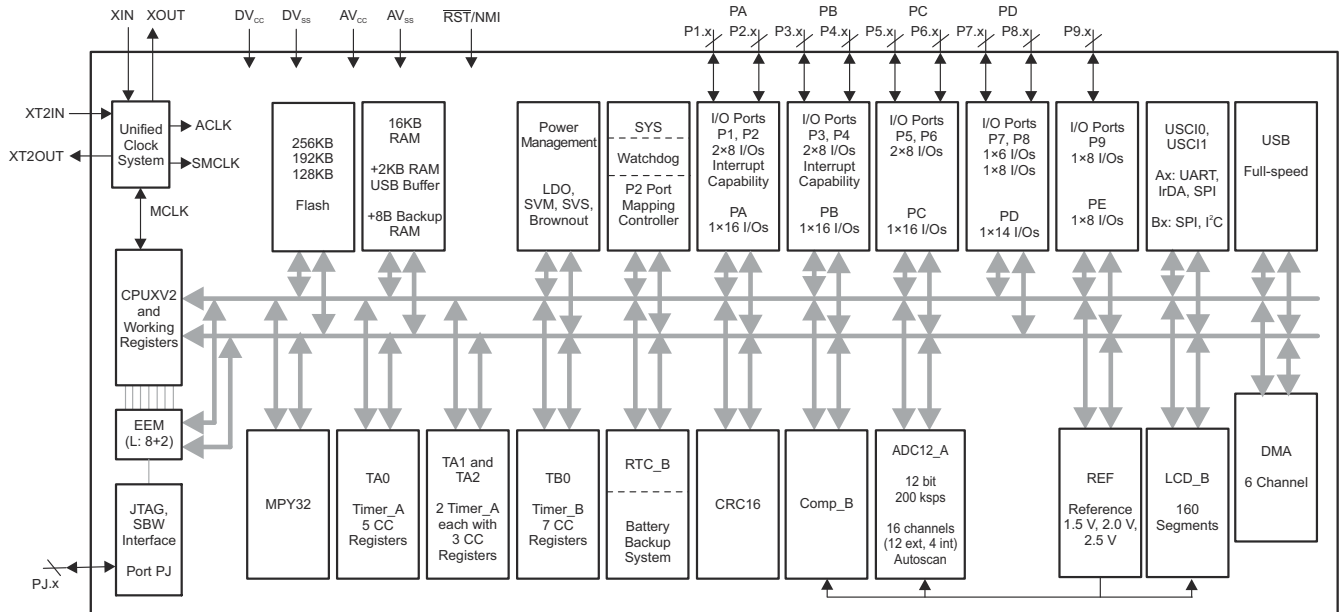


图 4-2. 功能框图 - MSP430F6635、MSP430F6634 和 MSP430F6633

图 4-3 给出了 MSP430F6632、MSP430F6631 和 MSP430F6630 器件的功能框图。

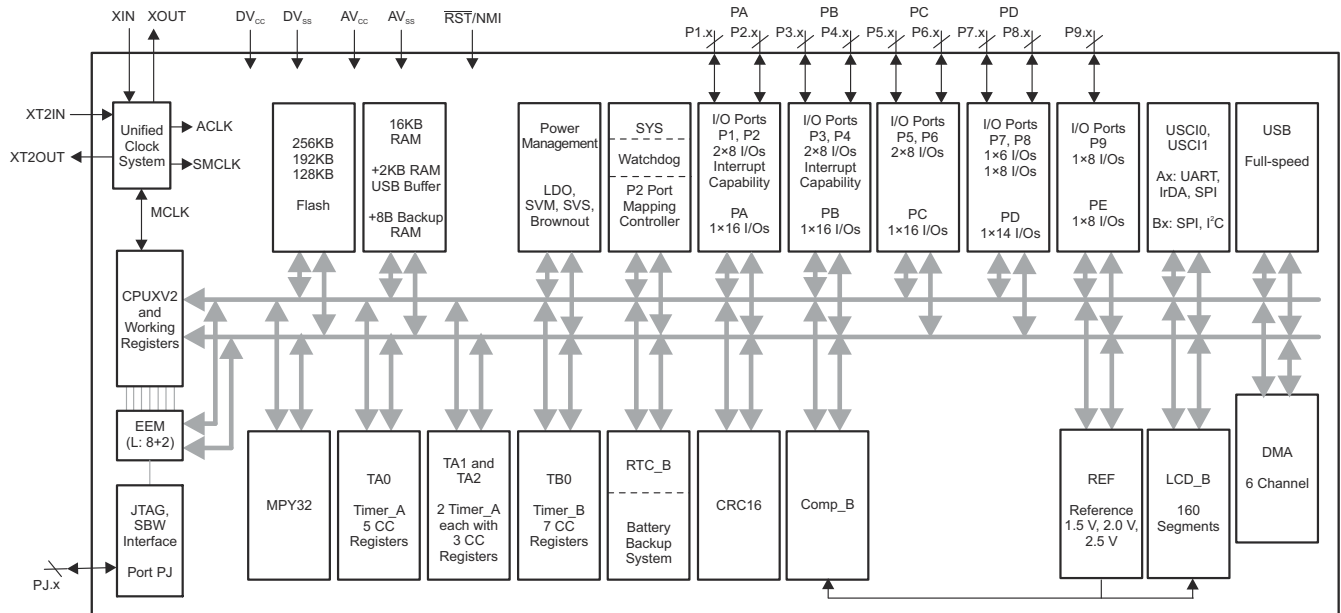


图 4-3. 功能框图 - MSP430F6632、MSP430F6631 和 MSP430F6630

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5 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from revision F to revision G

Changes from September 18, 2018 to September 10, 2020	Page
• 更新了整个文档中的章节、表格、图和交叉参考的编号	1
• 通篇增加了 nFBGA 封装 (ZCA) 信息	1
• Removed package options that are no longer available in 表 6-1, <i>Device Comparison</i> (MSP430F6637, MSP430F6632, MSP430F6631, and MSP430F6630 in ZQW)	8
• Updated the list of devices available in the 113-Pin ZQW package in the caption of 图 7-4	9
• Changed the MAX value of the I_{ERASE} and I_{MERASE} , I_{BANK} parameters in 节 8.57, <i>Flash Memory</i>	57
• Corrected the connection of the P7SEL.x signal in 图 9-11, <i>Port P7 (P7.4 to P7.7) Diagram</i>	102

Changes from revision E to revision F

Changes from December 9, 2015 to September 17, 2018	Page
• Added 节 6.1, <i>Related Products</i>	8
• Added typical conditions statements at the beginning of 节 8, <i>Specifications</i>	19
• Changed the MIN value of the $V_{(DVCC_BOR_hys)}$ parameter from 60 mV to 50 mV in 节 8.21, <i>PMM, Brownout Reset (BOR)</i>	32
• Updated notes (1) and (2) and added note (3) in 节 8.27, <i>Wake-up Times From Low-Power Modes and Reset</i>	34
• Removed ADC12DIV from the formula for the TYP value in the second row of the $t_{CONVERT}$ parameter in 节 8.38, <i>12-Bit ADC, Timing Parameters</i> , because ADC12CLK is after division	44
• Removed the note that started "This impedance depends on..." from the "Reference input resistance" parameter in 节 8.48, <i>12-Bit DAC, Reference Input Specifications</i>	52
• Added second row for t_{EN_CMP} with Test Conditions of "CBPWRMD = 10" and MAX value of 100 μ s in 节 8.51, <i>Comparator_B</i>	54
• Renamed FCTL4.MGR0 and MGR1 in the f_{MCLK_MGR} parameter in 节 8.57, <i>Flash Memory</i> to be consistent with header files	57
• Replaced former section <i>Development Tools Support</i> with 节 10.3, <i>Tools and Software</i>	114

Changes from revision D to revision E

Changes from August 6, 2013 to December 8, 2015	Page
• 通篇更改了格式和结构，包括添加了章节编号	1
• 已将全部功能框图移动至 节 4, <i>功能框图</i>	3
• Added USB column to 表 6-1, <i>Family Members</i>	8
• Added 节 6, <i>Device Comparison</i> , and moved 表 6-1 to it	8
• Added "Port U is supplied by the LDOO rail" to the PU.0 and PU.1 descriptions in 节 7.2, <i>Signal Descriptions</i>	13
• Added 节 8.2, <i>ESD Ratings</i>	19
• Added note to $C_{V_{CORE}}$	19
• Added note to R_{Pull}	24
• Changed TYP value of C_{L_eff} with Test Conditions of "XTS = 0, XCAPx = 0" from 2 pF to 1 pF	28
• In V_{BAT3} parameter description, changed from " $V_{BAT3} \neq V_{BAT}/3$ " to " $V_{BAT3} = V_{BAT}/3$ "	36
• Changed from f_{DAC12_0OUT} to f_{DAC12_1OUT} in the first row of the Test Conditions for the "Channel-to-channel crosstalk" parameter	53
• Changed the value of DAC12_xDAT from 7F7h to F7Fh and changed the x-axis label from f_{Toggle} to $1/f_{Toggle}$ in 图 8-22, <i>Crosstalk Test Conditions</i>	53

• Added note to R _{PUR}	56
• Corrected the spelling of the MRG bits in the f _{MCLK,MRG} parameter in 节 8.57, <i>Flash Memory</i>	57
• Removed RTC_B from LPM4.5 wake-up options.....	60
• Throughout document, changed all instances of "bootstrap loader" to "bootloader"	63
• Added the paragraph that starts " <i>Using the MSP430 RTC_B Module With Battery Backup Supply</i> describes how..."	67
• Corrected names of interrupt events PMMSWBOR (BOR) and PMMSWPOR (POR) in 表 9-11, <i>System Module Interrupt Vector Registers</i>	68
• Corrected spelling of NMIIFG (added missing "I") in 表 9-11, <i>System Module Interrupt Vector Registers</i>	68
• Corrected register acronyms (added "USB" prefix as required) in 表 9-50, <i>USB Control Registers</i>	75
• Added connection from "LCDS40...LCDS42" to AND gate in 图 9-7, <i>Port P5 (P5.2 to P5.7) Diagram</i>	97
• Added P7SEL.2 and XT2BYPASS inputs with AND and OR gates in 图 9-10, <i>Port P7 (P7.3) Diagram</i>	101
• Changed P7SEL.3 column from X to 0 for "P7.3 (I/O)" rows.....	101
• Added 节 10 and moved <i>Development Tools Support, Device and Development Tool Nomenclature, Trademarks, and Electrostatic Discharge Caution</i> sections to it.....	112
• Added 节 11, <i>Mechanical, Packaging, and Orderable Information</i>	119

The following table lists the changes to this data sheet from the original release through revision D.

REVISION	COMMENTS
SLAS566D August 2013	表 7-1, Added note regarding pullup resistor to $\overline{\text{RST}}/\text{NMI}/\text{SBWTDIO}$ pin. Added Applications, Development Tools Support, and Device and Development Tool Nomenclature 节 9.12.1, Changed the description of the number of I/Os in each port. 表 9-19, Added PM5CTL0 register. 节 8.45, Fixed typo in I_{DD} Test Conditions (changed from DAC12IOG to DAC12OG). 节 8.54, Corrected V_{IL} and V_{IH} limits. 节 8.57, Changed I_{ERASE} and I_{MERASE}, I_{BANK} limits.
SLAS566C August 2012	Changed description of ACLK and PUR in 表 7-1. Changed typos to Interrupt Flag names on Timer TA2 rows in 表 9-3. Changed SYSRSTIV, System Reset offset 1Ch to Reserved in 表 9-11. Corrected names of SVMLVLRIFG and SVMHVLRIIFG bits in 表 9-11. Added note regarding evaluation of PUR in 节 9.7.1. Changed notes on 节 8.44. Changed t_{SENSOR(sample)} MIN to 100 μs in 节 8.42. Changed note (2) in 节 8.42. Editorial changes throughout.
SLAS566B August 2011	Production Data release
SLAS566A July 2010	Updated Product Preview including electrical specifications
SLAS566 May 2010	Product Preview release

6 Device Comparison

表 6-1 summarizes the available family members.

表 6-1. Device Comparison

DEVICE ^{(1) (2)}	FLASH (KB)	SRAM (KB) ⁽⁵⁾	Timer_A ⁽³⁾	Timer_B ⁽⁴⁾	USCI_A: UART, IrDA, SPI	USCI_B: SPI, I ² C	ADC12_A (Ch)	DAC12_A (Ch)	Comp_B (Ch)	USB	I/O	PACKAGE
MSP430F6638	256	16 + 2	5, 3, 3	7	2	2	12 ext, 4 int	2	12	Yes	74	100 PZ, 113 ZCA, 113 ZQW
MSP430F6637	192	16 + 2	5, 3, 3	7	2	2	12 ext, 4 int	2	12	Yes	74	100 PZ
MSP430F6636	128	16 + 2	5, 3, 3	7	2	2	12 ext, 4 int	2	12	Yes	74	100 PZ, 113 ZCA, 113 ZQW
MSP430F6635	256	16 + 2	5, 3, 3	7	2	2	12 ext, 4 int	–	12	Yes	74	100 PZ, 113 ZQW
MSP430F6634	192	16 + 2	5, 3, 3	7	2	2	12 ext, 4 int	–	12	Yes	74	100 PZ, 113 ZCA, 113 ZQW
MSP430F6633	128	16 + 2	5, 3, 3	7	2	2	12 ext, 4 int	–	12	Yes	74	100 PZ, 113 ZCA, 113 ZQW
MSP430F6632	256	16 + 2	5, 3, 3	7	2	2	–	–	12	Yes	74	100 PZ
MSP430F6631	192	16 + 2	5, 3, 3	7	2	2	–	–	12	Yes	74	100 PZ
MSP430F6630	128	16 + 2	5, 3, 3	7	2	2	–	–	12	Yes	74	100 PZ

- (1) For the most current package and ordering information, see the *Package Option Addendum* in 节 11, or see the TI website at www.ti.com.
- (2) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/packaging.
- (3) Each number in the sequence represents an instantiation of Timer_A with its associated number of capture/compare registers and PWM output generators available. For example, a number sequence of 3, 5 would represent two instantiations of Timer_A, the first instantiation having 3 and the second instantiation having 5 capture/compare registers and PWM output generators, respectively.
- (4) Each number in the sequence represents an instantiation of Timer_B with its associated number of capture/compare registers and PWM output generators available. For example, a number sequence of 3, 5 would represent two instantiations of Timer_B, the first instantiation having 3 and the second instantiation having 5 capture/compare registers and PWM output generators, respectively.
- (5) The additional 2KB of USB SRAM that is listed can be used as general-purpose SRAM when USB is not in use.

6.1 Related Products

For information about other devices in this family of products or related products, see the following links.

[TI 16-bit and 32-bit microcontrollers](#)

High-performance, low-power solutions to enable the autonomous future

[Products for MSP430 ultra-low-power sensing & measurement MCUs](#)

One platform. One ecosystem. Endless possibilities.

[Companion products for MSP430F6638](#)

Review products that are frequently purchased or used in conjunction with this product.

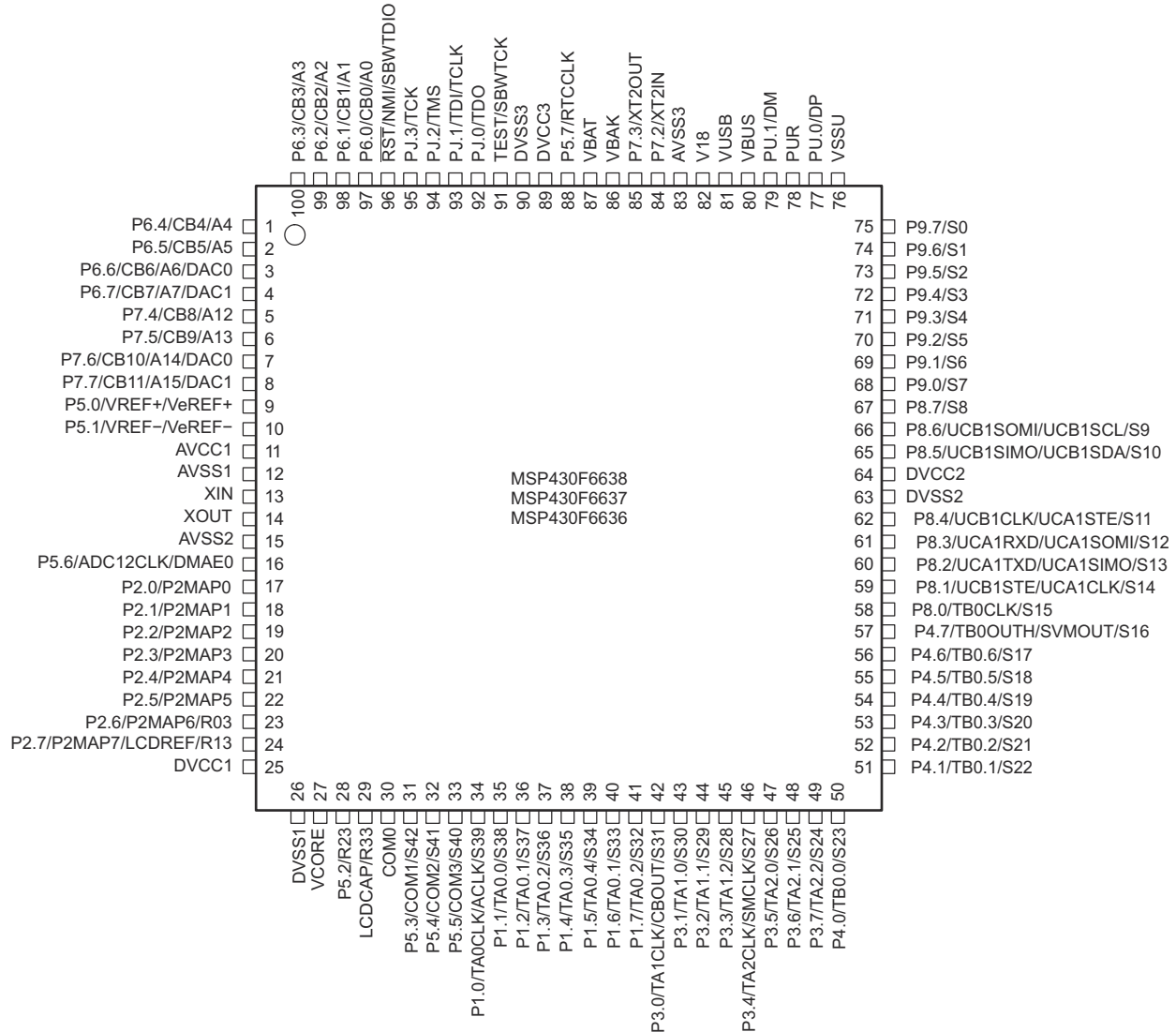
[Reference designs for MSP430F6638](#)

Find reference designs leveraging the best in TI technology to solve your system-level challenges

7 Terminal Configuration and Functions

7.1 Pin Diagrams

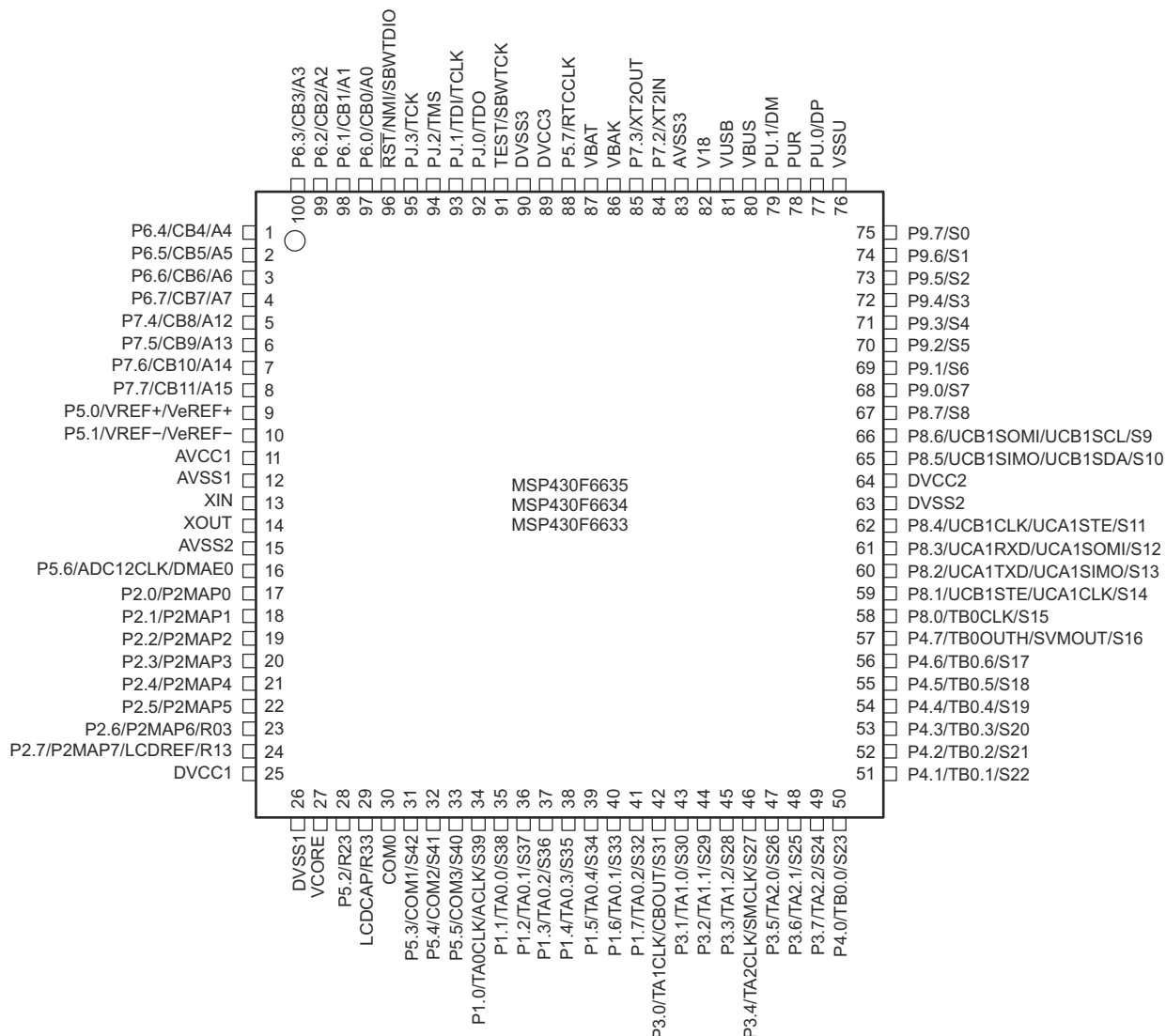
Figure 7-1 shows the pinout for the MSP430F6638, MSP430F6637, and MSP430F6636 devices in the 100-pin PZ package.



CAUTION: LCDCAP/R33 must be connected to DVSS if not used.

Figure 7-1. 100-Pin PZ Package (Top View) - MSP430F6638, MSP430F6637, MSP430F6636

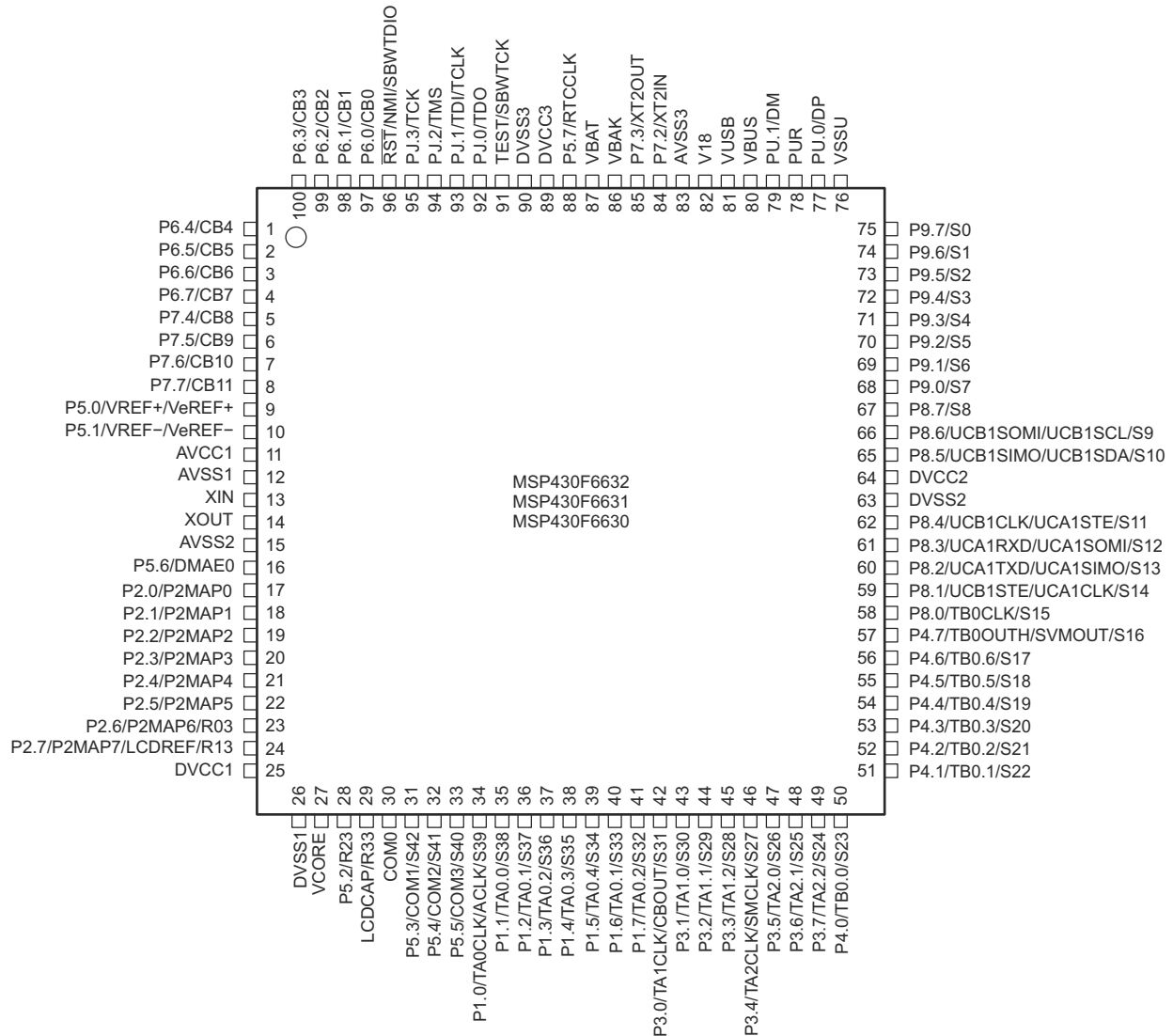
图 7-2 shows the pinout for the MSP430F6635, MSP430F6634, and MSP430F6633 devices in the 100-pin PZ package.



CAUTION: LCDAP/R33 must be connected to DVSS if not used.

图 7-2. 100-Pin PZ Package (Top View) - MSP430F6635, MSP430F6634, MSP430F6633

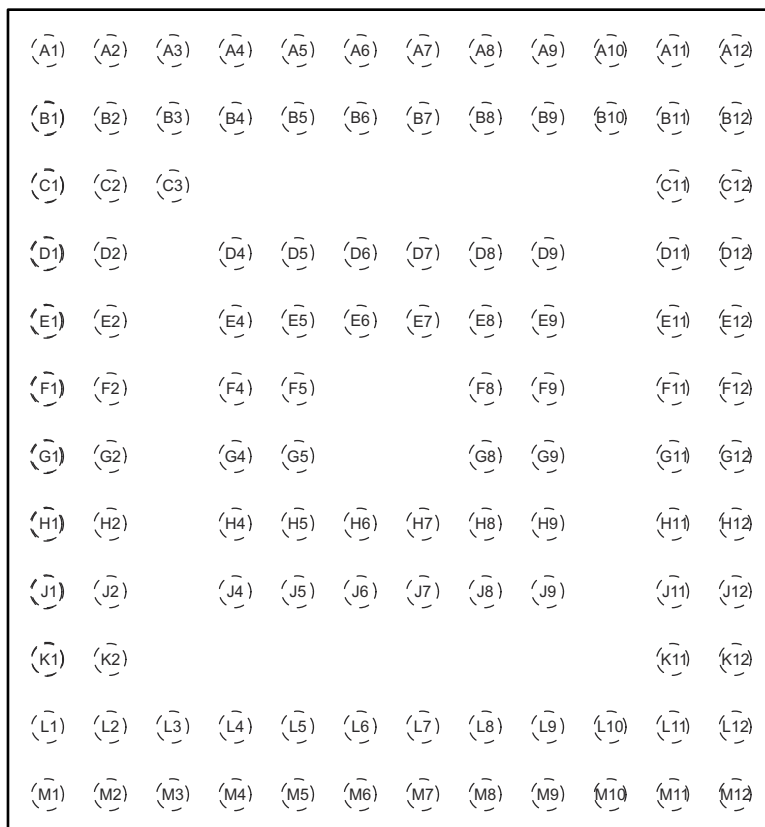
图 7-3 shows the pinout for the MSP430F6632, MSP430F6631, and MSP430F6630 devices in the 100-pin PZ package.



CAUTION: LCDAP/R33 must be connected to DVSS if not used.

图 7-3. 100-Pin PZ Package (Top View) - MSP430F6632, MSP430F6631, MSP430F6630

图 7-4 shows the pinout for devices in the 113-pin ZCA or ZQW package. See 表 7-1 for pin assignments and descriptions.



NOTE: For terminal assignments, see 表 7-1.

图 7-4. 113-Pin ZCA or ZQW Package (Top View) – MSP430F6638, MSP430F6636, MSP430F6635, MSP430F6634, MSP430F6633

7.2 Signal Descriptions

表 7-1 describes the signals for all device variants and packages.

表 7-1. Signal Descriptions

TERMINAL			I/O ⁽¹⁾	DESCRIPTION
NAME	NO. ⁽⁴⁾			
	PZ	ZCA, ZQW		
P6.4/CB4/A4	1	A1	I/O	General-purpose digital I/O Comparator_B input CB4 Analog input A4 – ADC (not available on F6632, F6631, and F6630 devices)
P6.5/CB5/A5	2	B2	I/O	General-purpose digital I/O Comparator_B input CB5 Analog input A5 – ADC (not available on F6632, F6631, and F6630 devices)
P6.6/CB6/A6/DAC0	3	B1	I/O	General-purpose digital I/O Comparator_B input CB6 Analog input A6 – ADC (not available on F6632, F6631, and F6630 devices) DAC12.0 output (not available on F6635, F6634, F6633, F6632, F6631, and F6630 devices)
P6.7/CB7/A7/DAC1	4	C2	I/O	General-purpose digital I/O Comparator_B input CB7 Analog input A7 – ADC (not available on F6632, F6631, and F6630 devices) DAC12.1 output (not available on F6635, F6634, F6633, F6632, F6631, and F6630 devices)
P7.4/CB8/A12	5	C1	I/O	General-purpose digital I/O Comparator_B input CB8 Analog input A12 – ADC (not available on F6632, F6631, and F6630 devices)
P7.5/CB9/A13	6	C3	I/O	General-purpose digital I/O Comparator_B input CB9 Analog input A13 – ADC (not available on F6632, F6631, and F6630 devices)
P7.6/CB10/A14/DAC0	7	D2	I/O	General-purpose digital I/O Comparator_B input CB10 Analog input A14 – ADC (not available on F6632, F6631, and F6630 devices) DAC12.0 output (not available on F6635, F6634, F6633, F6632, F6631, and F6630 devices)
P7.7/CB11/A15/DAC1	8	D1	I/O	General-purpose digital I/O Comparator_B input CB11 Analog input A15 – ADC (not available on F6632, F6631, and F6630 devices) DAC12.1 output (not available on F6635, F6634, F6633, F6632, F6631, and F6630 devices)
P5.0/VREF+/VeREF+	9	D4	I/O	General-purpose digital I/O Output of reference voltage to the ADC Input for an external reference voltage to the ADC
P5.1/VREF-/VeREF-	10	E4	I/O	General-purpose digital I/O Negative terminal for the reference voltage of the ADC for both sources, the internal reference voltage, or an external applied reference voltage
AVCC1	11	E1, E2		Analog power supply
AVSS1	12	F2		Analog ground supply
XIN	13	F1	I	Input terminal for crystal oscillator XT1
XOUT	14	G1	O	Output terminal of crystal oscillator XT1

表 7-1. Signal Descriptions (continued)

TERMINAL		NO. ⁽⁴⁾	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ ZCA, ZQW			
AVSS2	15	G2		Analog ground supply
P5.6/ADC12CLK/DMAE0	16	H1	I/O	General-purpose digital I/O Conversion clock output ADC (not available on F6632, F6631, and F6630 devices) DMA external trigger input
P2.0/P2MAP0	17	G4	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_B0 SPI slave transmit enable; USCI_A0 clock input/output
P2.1/P2MAP1	18	H2	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_B0 SPI slave in/master out; USCI_B0 I ² C data
P2.2/P2MAP2	19	J1	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_B0 SPI slave out/master in; USCI_B0 I ² C clock
P2.3/P2MAP3	20	H4	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_B0 clock input/output; USCI_A0 SPI slave transmit enable
P2.4/P2MAP4	21	J2	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_A0 UART transmit data; USCI_A0 SPI slave in/master out
P2.5/P2MAP5	22	K1	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: USCI_A0 UART receive data; USCI_A0 slave out/master in
P2.6/P2MAP6/R03	23	K2	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: no secondary function Input/output port of lowest analog LCD voltage (V5)
P2.7/P2MAP7/LCDREF/R13	24	L2	I/O	General-purpose digital I/O with port interrupt and mappable secondary function Default mapping: no secondary function External reference voltage input for regulated LCD voltage Input/output port of third most positive analog LCD voltage (V3 or V4)
DVCC1	25	L1		Digital power supply
DVSS1	26	M1		Digital ground supply
VCORE ⁽²⁾	27	M2		Regulated core power supply (internal use only, no external current loading)
P5.2/R23	28	L3	I/O	General-purpose digital I/O Input/output port of second most positive analog LCD voltage (V2)
LDCAP/R33	29	M3	I/O	LCD capacitor connection Input/output port of most positive analog LCD voltage (V1) CAUTION CAUTION: LDCAP/R33 must be connected to DV_{SS} if not used.
COM0	30	J4	O	LCD common output COM0 for LCD backplane
P5.3/COM1/S42	31	L4	I/O	General-purpose digital I/O LCD common output COM1 for LCD backplane LCD segment output S42
P5.4/COM2/S41	32	M4	I/O	General-purpose digital I/O LCD common output COM2 for LCD backplane LCD segment output S41
P5.5/COM3/S40	33	J5	I/O	General-purpose digital I/O LCD common output COM3 for LCD backplane LCD segment output S40

表 7-1. Signal Descriptions (continued)

TERMINAL			I/O ⁽¹⁾	DESCRIPTION
NAME	NO. ⁽⁴⁾			
	PZ	ZCA, ZQW		
P1.0/TA0CLK/ACLK/S39	34	L5	I/O	General-purpose digital I/O with port interrupt Timer TA0 clock signal TACLK input ACLK output (divided by 1, 2, 4, 8, 16, or 32) LCD segment output S39
P1.1/TA0.0/S38	35	M5	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR0 capture: CCI0A input, compare: Out0 output BSL transmit output LCD segment output S38
P1.2/TA0.1/S37	36	J6	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR1 capture: CCI1A input, compare: Out1 output BSL receive input LCD segment output S37
P1.3/TA0.2/S36	37	H6	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR2 capture: CCI2A input, compare: Out2 output LCD segment output S36
P1.4/TA0.3/S35	38	M6	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR3 capture: CCI3A input compare: Out3 output LCD segment output S35
P1.5/TA0.4/S34	39	L6	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR4 capture: CCI4A input, compare: Out4 output LCD segment output S34
P1.6/TA0.1/S33	40	J7	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR1 capture: CCI1B input, compare: Out1 output LCD segment output S33
P1.7/TA0.2/S32	41	M7	I/O	General-purpose digital I/O with port interrupt Timer TA0 CCR2 capture: CCI2B input, compare: Out2 output LCD segment output S32
P3.0/TA1CLK/CBOUT/S31	42	L7	I/O	General-purpose digital I/O with port interrupt Timer TA1 clock input Comparator_B output LCD segment output S31
P3.1/TA1.0/S30	43	H7	I/O	General-purpose digital I/O with port interrupt Timer TA1 capture CCR0: CCI0A/CCI0B input, compare: Out0 output LCD segment output S30
P3.2/TA1.1/S29	44	M8	I/O	General-purpose digital I/O with port interrupt Timer TA1 capture CCR1: CCI1A/CCI1B input, compare: Out1 output LCD segment output S29
P3.3/TA1.2/S28	45	L8	I/O	General-purpose digital I/O with port interrupt Timer TA1 capture CCR2: CCI2A/CCI2B input, compare: Out2 output LCD segment output S28
P3.4/TA2CLK/SMCLK/S27	46	J8	I/O	General-purpose digital I/O with port interrupt Timer TA2 clock input SMCLK output LCD segment output S27
P3.5/TA2.0/S26	47	M9	I/O	General-purpose digital I/O with port interrupt Timer TA2 capture CCR0: CCI0A/CCI0B input, compare: Out0 output LCD segment output S26

表 7-1. Signal Descriptions (continued)

TERMINAL			I/O ⁽¹⁾	DESCRIPTION
NAME	NO. ⁽⁴⁾			
	PZ	ZCA, ZQW		
P3.6/TA2.1/S25	48	L9	I/O	General-purpose digital I/O with port interrupt Timer TA2 capture CCR1: CCI1A/CCI1B input, compare: Out1 output LCD segment output S25
P3.7/TA2.2/S24	49	M10	I/O	General-purpose digital I/O with port interrupt Timer TA2 capture CCR2: CCI2A/CCI2B input, compare: Out2 output LCD segment output S24
P4.0/TB0.0/S23	50	J9	I/O	General-purpose digital I/O with port interrupt Timer TB0 capture CCR0: CCI0A/CCI0B input, compare: Out0 output LCD segment output S23
P4.1/TB0.1/S22	51	M11	I/O	General-purpose digital I/O with port interrupt Timer TB0 capture CCR1: CCI1A/CCI1B input, compare: Out1 output LCD segment output S22
P4.2/TB0.2/S21	52	L10	I/O	General-purpose digital I/O with port interrupt Timer TB0 capture CCR2: CCI2A/CCI2B input, compare: Out2 output LCD segment output S21
P4.3/TB0.3/S20	53	M12	I/O	General-purpose digital I/O with port interrupt Timer TB0 capture CCR3: CCI3A/CCI3B input, compare: Out3 output LCD segment output S20
P4.4/TB0.4/S19	54	L12	I/O	General-purpose digital I/O with port interrupt Timer TB0 capture CCR4: CCI4A/CCI4B input, compare: Out4 output LCD segment output S19
P4.5/TB0.5/S18	55	L11	I/O	General-purpose digital I/O with port interrupt Timer TB0 capture CCR5: CCI5A/CCI5B input, compare: Out5 output LCD segment output S18
P4.6/TB0.6/S17	56	K11	I/O	General-purpose digital I/O with port interrupt Timer TB0 capture CCR6: CCI6A/CCI6B input, compare: Out6 output LCD segment output S17
P4.7/TB0OUTH/SVMOUT/S16	57	K12	I/O	General-purpose digital I/O with port interrupt Timer TB0: Switch all PWM outputs high impedance SVM output LCD segment output S16
P8.0/TB0CLK/S15	58	J11	I/O	General-purpose digital I/O Timer TB0 clock input LCD segment output S15
P8.1/UCB1STE/UCA1CLK/S14	59	J12	I/O	General-purpose digital I/O USCI_B1 SPI slave transmit enable; USCI_A1 clock input/output LCD segment output S14
P8.2/UCA1TXD/UCA1SIMO/S13	60	H11	I/O	General-purpose digital I/O USCI_A1 UART transmit data; USCI_A1 SPI slave in/master out LCD segment output S13
P8.3/UCA1RXD/UCA1SOMI/S12	61	H12	I/O	General-purpose digital I/O USCI_A1 UART receive data; USCI_A1 SPI slave out/master in LCD segment output S12
P8.4/UCB1CLK/UCA1STE/S11	62	G11	I/O	General-purpose digital I/O USCI_B1 clock input/output; USCI_A1 SPI slave transmit enable LCD segment output S11
DVSS2	63	G12		Digital ground supply

表 7-1. Signal Descriptions (continued)

TERMINAL		NO. ⁽⁴⁾	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ ZCA, ZQW			
DVCC2	64	F12		Digital power supply
P8.5/UCB1SIMO/UCB1SDA/S10	65	F11	I/O	General-purpose digital I/O USCI_B1 SPI slave in/master out; USCI_B1 I ² C data LCD segment output S10
P8.6/UCB1SOMI/UCB1SCL/S9	66	G9	I/O	General-purpose digital I/O USCI_B1 SPI slave out/master in; USCI_B1 I ² C clock LCD segment output S9
P8.7/S8	67	E12	I/O	General-purpose digital I/O LCD segment output S8
P9.0/S7	68	E11	I/O	General-purpose digital I/O LCD segment output S7
P9.1/S6	69	F9	I/O	General-purpose digital I/O LCD segment output S6
P9.2/S5	70	D12	I/O	General-purpose digital I/O LCD segment output S5
P9.3/S4	71	D11	I/O	General-purpose digital I/O LCD segment output S4
P9.4/S3	72	E9	I/O	General-purpose digital I/O LCD segment output S3
P9.5/S2	73	C12	I/O	General-purpose digital I/O LCD segment output S2
P9.6/S1	74	C11	I/O	General-purpose digital I/O LCD segment output S1
P9.7/S0	75	D9	I/O	General-purpose digital I/O LCD segment output S0
VSSU	76	B11, B12		USB PHY ground supply
PU.0/DP	77	A12	I/O	General-purpose digital I/O, controlled by USB control register. Port U is supplied by the LDOO rail. USB data terminal DP
PUR	78	B10	I/O	USB pullup resistor pin (open drain). The voltage level at the PUR pin is used to invoke the default USB BSL. TI recommends a 1-M Ω resistor to ground. See 节 9.7.1 for more information.
PU.1/DM	79	A11	I/O	General-purpose digital I/O, controlled by USB control register. Port U is supplied by the LDOO rail. USB data terminal DM
VBUS	80	A10		USB LDO input (connect to USB power source)
VUSB	81	A9		USB LDO output
V18	82	B9		USB regulated power (internal use only, no external current loading)
AVSS3	83	A8		Analog ground supply
P7.2/XT2IN	84	B8	I/O	General-purpose digital I/O Input terminal for crystal oscillator XT2
P7.3/XT2OUT	85	B7	I/O	General-purpose digital I/O Output terminal of crystal oscillator XT2
VBAK	86	A7		Capacitor for backup subsystem. Do not load this pin externally. For capacitor values, see C _{BAK} in 节 8.3 .

表 7-1. Signal Descriptions (continued)

TERMINAL		NO. ⁽⁴⁾	I/O ⁽¹⁾	DESCRIPTION
NAME	PZ			
VBAT	87	D8		Backup or secondary supply voltage. If backup voltage is not supplied, connect to DVCC externally.
P5.7/RTCCLK	88	D7	I/O	General-purpose digital I/O RTCCLK output
DVCC3	89	A6		Digital power supply
DVSS3	90	A5		Digital ground supply
TEST/SBWTCK	91	B6	I	Test mode pin; selects digital I/O on JTAG pins Spy-Bi-Wire input clock
PJ.0/TDO	92	B5	I/O	General-purpose digital I/O Test data output port
PJ.1/TDI/TCLK	93	A4	I/O	General-purpose digital I/O Test data input or test clock input
PJ.2/TMS	94	E7	I/O	General-purpose digital I/O Test mode select
PJ.3/TCK	95	D6	I/O	General-purpose digital I/O Test clock
RST/NMI/SBWDIO	96	A3	I/O	Reset input (active low) ⁽³⁾ Nonmaskable interrupt input Spy-Bi-Wire data input/output
P6.0/CB0/A0	97	B4	I/O	General-purpose digital I/O Comparator_B input CB0 Analog input A0 – ADC (not available on F6632, F6631, and F6630 devices)
P6.1/CB1/A1	98	B3	I/O	General-purpose digital I/O Comparator_B input CB1 Analog input A1 – ADC (not available on F6632, F6631, and F6630 devices)
P6.2/CB2/A2	99	A2	I/O	General-purpose digital I/O Comparator_B input CB2 Analog input A2 – ADC (not available on F6632, F6631, and F6630 devices)
P6.3/CB3/A3	100	D5	I/O	General-purpose digital I/O Comparator_B input CB3 Analog input A3 – ADC (not available on F6632, F6631, and F6630 devices)
Reserved	N/A	E5, E6, E8, F4, F5, F8, G5, G8, H5, H8, H9		Reserved. TI recommends connecting to ground (DVSS, AVSS).

(1) I = input, O = output, N/A = not available on this package offering

(2) V_{CORE} is for internal use only. No external current loading is possible. V_{CORE} should only be connected to the recommended capacitor value, C_{V_{CORE}}.

(3) When this pin is configured as reset, the internal pullup resistor is enabled by default.

(4) See the *Package Option Addendum* in 节 11 to determine which devices are available in each package.

8 Specifications

All graphs in this section are for typical conditions, unless otherwise noted.

Typical (TYP) values are specified at $V_{CC} = 3.3\text{ V}$ and $T_A = 25^\circ\text{C}$, unless otherwise noted.

8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

	MIN	MAX	UNIT
Voltage applied at V_{CC} to V_{SS}	- 0.3	4.1	V
Voltage applied to any pin (excluding V _{CORE} , V _{BUS} , V18) ⁽²⁾	- 0.3	$V_{CC} + 0.3$	V
Diode current at any device pin		±2	mA
Maximum junction temperature, T_J		95	°C
Storage temperature, T_{stg} ⁽³⁾	- 55	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages referenced to V_{SS} . V_{CORE} is for internal device use only. No external DC loading or voltage should be applied.

(3) Higher temperature may be applied during board soldering according to the current JEDEC J-STD-020 specification with peak reflow temperatures not higher than classified on the device label on the shipping boxes or reels.

8.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±1000	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±250	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±1000 V may actually have higher performance.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as ±250 V may actually have higher performance.

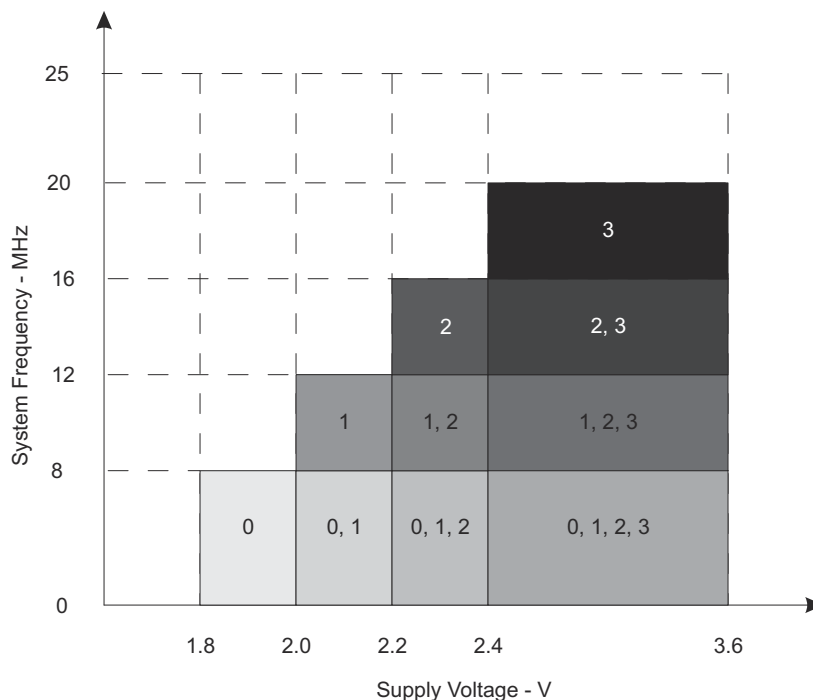
8.3 Recommended Operating Conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage during program execution and flash programming (AVCC1 = DVCC1 = DVCC2 = DVCC3 = DV _{CC} = V _{CC}) ^{(1) (2)}	PMMCOREVx = 0	1.8	3.6	V
		PMMCOREVx = 0, 1	2.0	3.6	
		PMMCOREVx = 0, 1, 2	2.2	3.6	
		PMMCOREVx = 0, 1, 2, 3	2.4	3.6	
$V_{CC,USB}$	Supply voltage during USB operation, USB PLL disabled (USB_EN = 1, UPLLEN = 0)	PMMCOREVx = 0	1.8	3.6	V
		PMMCOREVx = 0, 1	2.0	3.6	
		PMMCOREVx = 0, 1, 2	2.2	3.6	
		PMMCOREVx = 0, 1, 2, 3	2.4	3.6	
	Supply voltage during USB operation, USB PLL enabled ⁽⁶⁾ (USB_EN = 1, UPLLEN = 1)	PMMCOREVx = 2	2.2	3.6	
		PMMCOREVx = 2, 3	2.4	3.6	
V_{SS}	Supply voltage (AVSS1 = AVSS2 = AVSS3 = DVSS1 = DVSS2 = DVSS3 = V _{SS})		0		V
$V_{BAT,RTC}$	Backup-supply voltage with RTC operational	$T_A = 0^\circ\text{C}$ to 85°C	1.55	3.6	V
		$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	1.70	3.6	
$V_{BAT,MEM}$	Backup-supply voltage with backup memory retained	$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$	1.20	3.6	V
T_A	Operating free-air temperature	I version	- 40	85	°C
T_J	Operating junction temperature	I version	- 40	85	°C
C_{BAK}	Capacitance at pin VBAK		1	4.7	10 nF
C_{VCORE}	Capacitor at V _{CORE} ⁽⁴⁾		470		nF

8.3 Recommended Operating Conditions (continued)

			MIN	NOM	MAX	UNIT
C_{DVCC}/C_{VCORE}	Capacitor ratio of DVCC to VCORE		10			
f_{SYSTEM}	Processor frequency (maximum MCLK frequency) ^{(3) (5)} (see 图 8-1)	PMMCOREVx = 0, $1.8\text{ V} \leq V_{CC} \leq 3.6\text{ V}$ (default condition)	0		8.0	MHz
		PMMCOREVx = 1, $2\text{ V} \leq V_{CC} \leq 3.6\text{ V}$	0		12.0	
		PMMCOREVx = 2, $2.2\text{ V} \leq V_{CC} \leq 3.6\text{ V}$	0		16.0	
		PMMCOREVx = 3, $2.4\text{ V} \leq V_{CC} \leq 3.6\text{ V}$	0		20.0	
f_{SYSTEM_USB}	Minimum processor frequency for USB operation		1.5			MHz
USB_wait	Wait state cycles during USB operation			16		cycles

- (1) TI recommends powering AV_{CC} and DV_{CC} from the same source. A maximum difference of 0.3 V between AV_{CC} and DV_{CC} can be tolerated during power up and operation.
- (2) The minimum supply voltage is defined by the supervisor SVS levels when it is enabled. See the threshold parameters in 节 8.23 for the exact values and more details.
- (3) The MSP430 CPU is clocked directly with MCLK. Both the high and low phase of MCLK must not exceed the pulse duration of the specified maximum frequency.
- (4) A capacitor tolerance of $\pm 20\%$ or better is required.
- (5) Modules may have a different maximum input clock specification. See the specification of the respective module in this data sheet.
- (6) USB operation with USB PLL enabled requires $PMMCOREVx \geq 2$ for proper operation.



NOTE: The numbers within the fields denote the supported PMMCOREVx settings.

图 8-1. Frequency vs Supply Voltage

8.4 Active Mode Supply Current Into V_{CC} Excluding External Current

over recommended operating free-air temperature (unless otherwise noted)^{(1) (2) (3)}

PARAMETER	EXECUTION MEMORY	V _{CC}	PMMCOREVx	FREQUENCY (f _{DCO} = f _{MCLK} = f _{SMCLK})								UNIT
				1 MHz		8 MHz		12 MHz		20 MHz		
				TYP	MAX	TYP	MAX	TYP	MAX	TYP	MAX	
I _{AM, Flash}	Flash	3 V	0	0.32	0.36	2.1	2.4					mA
			1	0.36		2.4		3.6	4.0			
			2	0.37		2.5		3.8				
			3	0.39		2.7		4.0		6.6		
I _{AM, RAM}	RAM	3 V	0	0.18	0.21	1.0	1.2					mA
			1	0.20		1.2		1.7	1.9			
			2	0.22		1.3		2.0				
			3	0.23		1.4		2.1		3.6		

- (1) All inputs are tied to 0 V or to V_{CC} . Outputs do not source or sink any current.
(2) The currents are characterized with a Micro Crystal MS1V-T1K crystal with a load capacitance of 12.5 pF. The internal and external load capacitance are chosen to closely match the required 12.5 pF.
(3) Characterized with program executing typical data processing. USB disabled ($V_{USBEN} = 0$, $SLDOEN = 0$).
 $f_{ACLK} = 32786$ Hz, $f_{DCO} = f_{MCLK} = f_{SMCLK}$ at specified frequency.
XTS = CPUOFF = SCG0 = SCG1 = OSCOFF = SMCLKOFF = 0.

8.5 Low-Power Mode Supply Currents (Into V_{CC}) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)^{(1) (2)}

PARAMETER	V _{CC}	PMMCOREVx	TEMPERATURE (T _A)								UNIT
			– 40°C		25°C		60°C		85°C		
			TYP	MAX	TYP	MAX	TYP	MAX	TYP	MAX	
I _{LPM0,1MHz} Low-power mode 0 ⁽³⁾ ⁽⁹⁾	2.2 V	0	71		75	87	81		85	99	μA
	3 V	3	78		83	98	89		94	108	
I _{LPM2} Low-power mode 2 ⁽⁴⁾ ⁽⁹⁾	2.2 V	0	6.3		6.7	9.9	9.0		11	16	μA
	3 V	3	6.6		7.0	11	10		12	18	
I _{LPM3,XT1LF} Low-power mode 3, crystal mode ⁽⁵⁾ ⁽⁹⁾	2.2 V	0	1.6		1.8	2.4	4.7		6.5	10.5	μA
		1	1.6		1.9		4.8		6.6		
		2	1.7		2.0		4.9		6.7		
	3 V	0	1.9		2.1	2.7	5.0		6.8	10.8	
		1	1.9		2.1		5.1		7.0		
		2	2.0		2.2		5.2		7.1		
		3	2.0		2.2	2.9	5.4		7.3	12.6	
I _{LPM3, VLO,WDT} Low-power mode 3, VLO mode, Watchdog enabled ⁽⁶⁾ ⁽⁹⁾	3 V	0	0.9		1.2	1.9	4.0		5.9	10.3	μA
		1	0.9		1.2		4.1		6.0		
		2	1.0		1.3		4.2		6.1		
		3	1.0		1.3	2.2	4.3		6.3	11.3	
I _{LPM4} Low-power mode 4 ⁽⁷⁾ ⁽⁹⁾	3 V	0	0.9		1.1	1.8	3.9		5.8	10	μA
		1	0.9		1.1		4.0		5.9		
		2	1.0		1.2		4.1		6.1		
		3	1.0		1.2	2.1	4.2		6.2	11	
I _{LPM3.5, RTC,VCC} Low-power mode 3.5 (LPM3.5) current with active RTC into primary supply pin DV _{CC} ⁽¹⁰⁾	3 V				0.5				0.8	1.4	μA

8.5 Low-Power Mode Supply Currents (Into V_{CC}) Excluding External Current (continued)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)^{(1) (2)}

PARAMETER		V _{CC}	PMMCOREV _x	TEMPERATURE (T _A)								UNIT
				− 40°C		25°C		60°C		85°C		
				TYP	MAX	TYP	MAX	TYP	MAX	TYP	MAX	
I _{LPM3.5, RTC,VBAT}	Low-power mode 3.5 (LPM3.5) current with active RTC into backup supply pin VBAT ⁽¹¹⁾	3 V				0.6				0.8	1.4	μA
I _{LPM3.5, RTC,TOT}	Total low-power mode 3.5 (LPM3.5) current with active RTC ⁽¹²⁾	3 V		1.0		1.1		1.3		1.6	2.8	μA
I _{LPM4.5}	Low-power mode 4.5 (LPM4.5) ⁽⁸⁾	3 V		0.2		0.3	0.6	0.7		0.9	1.4	μA

- (1) All inputs are tied to 0 V or to V_{CC} . Outputs do not source or sink any current.
- (2) The currents are characterized with a Micro Crystal CC4V-T1A SMD crystal with a load capacitance of 9 pF. The internal and external load capacitance are chosen to closely match the required 9 pF.
- (3) Current for watchdog timer clocked by SMCLK included. ACLK = low-frequency crystal operation (XTS = 0, XT1DRIVE_x = 0). CPUOFF = 1, SCG0 = 0, SCG1 = 0, OSCOFF = 0 (LPM0), f_{ACLK} = 32768 Hz, f_{MCLK} = 0 MHz, f_{SMCLK} = f_{DCO} = 1 MHz USB disabled (VUSBEN = 0, SLDOEN = 0).
- (4) Current for watchdog timer clocked by ACLK and RTC clocked by LFXT1 (32768 Hz) included. ACLK = low-frequency crystal operation (XTS = 0, XT1DRIVE_x = 0). CPUOFF = 1, SCG0 = 0, SCG1 = 1, OSCOFF = 0 (LPM2), f_{ACLK} = 32768 Hz, f_{MCLK} = 0 MHz, f_{SMCLK} = f_{DCO} = 0 MHz; DCO setting = 1 MHz operation, DCO bias generator enabled. USB disabled (VUSBEN = 0, SLDOEN = 0).
- (5) Current for watchdog timer clocked by ACLK and RTC clocked by LFXT1 (32768 Hz) included. ACLK = low-frequency crystal operation (XTS = 0, XT1DRIVE_x = 0). CPUOFF = 1, SCG0 = 1, SCG1 = 1, OSCOFF = 0 (LPM3), f_{ACLK} = 32768 Hz, f_{MCLK} = f_{SMCLK} = f_{DCO} = 0 MHz USB disabled (VUSBEN = 0, SLDOEN = 0).
- (6) Current for watchdog timer clocked by VLO included. CPUOFF = 1, SCG0 = 1, SCG1 = 1, OSCOFF = 0 (LPM3), f_{ACLK} = f_{MCLK} = f_{SMCLK} = f_{DCO} = 0 MHz USB disabled (VUSBEN = 0, SLDOEN = 0).
- (7) CPUOFF = 1, SCG0 = 1, SCG1 = 1, OSCOFF = 1 (LPM4), f_{DCO} = f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0 MHz USB disabled (VUSBEN = 0, SLDOEN = 0).
- (8) Internal regulator disabled. No data retention. CPUOFF = 1, SCG0 = 1, SCG1 = 1, OSCOFF = 1, PMMREGOFF = 1 (LPM4.5), f_{DCO} = f_{ACLK} = f_{MCLK} = f_{SMCLK} = 0 MHz
- (9) Current for brownout included. Low-side supervisor (SVS_L) and low-side monitor (SVM_L) disabled. High-side supervisor (SVS_H) and high-side monitor (SVM_H) disabled. RAM retention enabled.
- (10) V_{VBAT} = V_{CC} - 0.2 V, f_{DCO} = f_{MCLK} = f_{SMCLK} = 0 MHz, f_{ACLK} = 32768 Hz, PMMREGOFF = 1, RTC in backup domain active
- (11) V_{VBAT} = V_{CC} - 0.2 V, f_{DCO} = f_{MCLK} = f_{SMCLK} = 0 MHz, f_{ACLK} = 32768 Hz, PMMREGOFF = 1, RTC in backup domain active, no current drawn on VBAK
- (12) f_{DCO} = f_{MCLK} = f_{SMCLK} = 0 MHz, f_{ACLK} = 32768 Hz, PMMREGOFF = 1, RTC in backup domain active, no current drawn on VBAK

8.6 Low-Power Mode With LCD Supply Currents (Into V_{CC}) Excluding External Current

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)^{(1) (2)}

PARAMETER	V _{CC}	PMMCOREVx	TEMPERATURE (T _A)								UNIT
			- 40°C		25°C		60°C		85°C		
			TYP	MAX	TYP	MAX	TYP	MAX	TYP	MAX	
I _{LPM3} , LCD, ext. bias Low-power mode 3 (LPM3) current, LCD 4-mux mode, external biasing ^{(1) (2)}	3 V	0	2.3		2.7	3.1	5.4		7.4	11.5	μA
		1	2.3		2.7		5.6		7.5		
		2	2.4		2.8		5.8		7.7		
		3	2.4		2.8	3.5	5.9		7.9	13.2	
I _{LPM3} , LCD, int. bias Low-power mode 3 (LPM3) current, LCD 4-mux mode, internal biasing, charge pump disabled ^{(1) (3)}	3 V	0	2.7		3.2	3.8	5.9		7.9	12.2	μA
		1	2.7		3.2		6.1		8.1		
		2	2.8		3.3		6.2		8.3		
		3	2.8		3.3	4.9	6.4		8.4	13.7	
I _{LPM3} LCD, CP Low-power mode 3 (LPM3) current, LCD 4-mux mode, internal biasing, charge pump enabled ^{(1) (4)}	2.2 V	0			3.8						μA
		1			3.9						
		2			4.0						
	3 V	0			4.0						μA
		1			4.1						
		2			4.2						
		3			4.2						

- (1) Current for watchdog timer clocked by ACLK and RTC clocked by LFXT1 (32768 Hz) included. ACLK = low-frequency crystal operation (XTS = 0, XT1DRIVE = 0).
CPUOFF = 1, SCG0 = 1, SCG1 = 1, OSCOFF = 0 (LPM3), f_{ACLK} = 32768 Hz, f_{MCLK} = f_{SMCLK} = f_{DCO} = 0 MHz
Current for brownout included. Low-side supervisor and monitors disabled (SVSL, SVM_L). High-side supervisor and monitor disabled (SVSH, SVM_H). RAM retention enabled.
- (2) LCDMx = 11 (4-mux mode), LCDREXT = 1, LCDEXTBIAS = 1 (external biasing), LCD2B = 0 (1/3 bias), LCDCPEN = 0 (charge pump disabled), LCDSSEL = 0, LCDPREx = 101, LCDDIVx = 00011 (f_{LCD} = 32768 Hz/32/4 = 256 Hz)
Current through external resistors not included (voltage levels are supplied by test equipment).
Even segments S0, S2,... = 0, odd segments S1, S3,... = 1. No LCD panel load.
- (3) LCDMx = 11 (4-mux mode), LCDREXT = 0, LCDEXTBIAS = 0 (internal biasing), LCD2B = 0 (1/3 bias), LCDCPEN = 0 (charge pump disabled), LCDSSEL = 0, LCDPREx = 101, LCDDIVx = 00011 (f_{LCD} = 32768 Hz/32/4 = 256 Hz)
Even segments S0, S2,... = 0, odd segments S1, S3,... = 1. No LCD panel load.
- (4) LCDMx = 11 (4-mux mode), LCDREXT = 0, LCDEXTBIAS = 0 (internal biasing), LCD2B = 0 (1/3 bias), LCDCPEN = 1 (charge pump enabled), VLCDx = 1000 (V_{LCD} = 3 V, typical), LCDSSEL = 0, LCDPREx = 101, LCDDIVx = 00011 (f_{LCD} = 32768 Hz/32/4 = 256 Hz)
Even segments S0, S2,... = 0, odd segments S1, S3,... = 1. No LCD panel load.

8.7 Thermal Resistance Characteristics

PARAMETER		VALUE		UNIT
$R_{\theta JA}$ Junction-to-ambient thermal resistance, still air ⁽¹⁾	LQFP (PZ)	122		°C/W
	BGA (ZQW)	108		
$R_{\theta JC(TOP)}$ Junction-to-case (top) thermal resistance ⁽²⁾	LQFP (PZ)	83		°C/W
	BGA (ZQW)	72		
$R_{\theta JB}$ Junction-to-board thermal resistance ⁽³⁾	LQFP (PZ)	98		°C/W
	BGA (ZQW)	76		

- (1) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, High-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
- (2) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.
- (3) The junction-to-board thermal resistance is obtained by simulating in an environment with a ring cold plate fixture to control the PCB temperature, as described in JESD51-8.

8.8 Schmitt-Trigger Inputs – General-Purpose I/O

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
V _{IT+} Positive-going input threshold voltage		1.8 V	0.80		1.40	V
		3 V	1.50		2.10	
V _{IT-} Negative-going input threshold voltage		1.8 V	0.45		1.00	V
		3 V	0.75		1.65	
V _{hys} Input voltage hysteresis (V _{IT+} – V _{IT-})		1.8 V	0.3		0.8	V
		3 V	0.4		1.0	
R _{Pull} Pullup or pulldown resistor ⁽²⁾	For pullup: V _{IN} = V _{SS} For pulldown: V _{IN} = V _{CC}		20	35	50	kΩ
C _I Input capacitance	V _{IN} = V _{SS} or V _{CC}			5		pF

(1) Same parametrics apply to clock input pin when crystal bypass mode is used on XT1 (XIN) or XT2 (XT2IN).

(2) Also applies to RST pin when pullup or pulldown resistor is enabled.

8.9 Inputs – Ports P1, P2, P3, and P4

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
t _(int) External interrupt timing ⁽²⁾	Port P1, P2, P3, P4: P1.x to P4.x, External trigger pulse duration to set interrupt flag	2.2 V, 3 V	20		ns

(1) Some devices may contain additional ports with interrupts. See the block diagram and terminal function descriptions.

(2) An external signal sets the interrupt flag every time the minimum interrupt pulse duration t_(int) is met. It may be set by trigger signals shorter than t_(int).

8.10 Leakage Current – General-Purpose I/O

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
I _{lkg} (Px.x) High-impedance leakage current	See ⁽¹⁾ ⁽²⁾	1.8 V, 3 V		±50	nA

(1) The leakage current is measured with V_{SS} or V_{CC} applied to the corresponding pins, unless otherwise noted.

(2) The leakage of the digital port pins is measured individually. The port pin is selected for input and the pullup or pulldown resistor is disabled.

8.11 Outputs – General-Purpose I/O (Full Drive Strength)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
V _{OH} High-level output voltage	I _(OHmax) = – 3 mA ⁽¹⁾	1.8 V	V _{CC} – 0.25	V _{CC}	V
	I _(OHmax) = – 10 mA ⁽²⁾		V _{CC} – 0.60	V _{CC}	
	I _(OHmax) = – 5 mA ⁽¹⁾	3 V	V _{CC} – 0.25	V _{CC}	
	I _(OHmax) = – 15 mA ⁽²⁾		V _{CC} – 0.60	V _{CC}	
V _{OL} Low-level output voltage	I _(OLmax) = 3 mA ⁽¹⁾	1.8 V	V _{SS}	V _{SS} + 0.25	V
	I _(OLmax) = 10 mA ⁽²⁾		V _{SS}	V _{SS} + 0.60	
	I _(OLmax) = 5 mA ⁽¹⁾	3 V	V _{SS}	V _{SS} + 0.25	
	I _(OLmax) = 15 mA ⁽²⁾		V _{SS}	V _{SS} + 0.60	

(1) The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined should not exceed ±48 mA to hold the maximum voltage drop specified.

(2) The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined should not exceed ±100 mA to hold the maximum voltage drop specified.

8.12 Outputs - General-Purpose I/O (Reduced Drive Strength)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽³⁾

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
V _{OH} High-level output voltage	I _(OHmax) = - 1 mA ⁽¹⁾	1.8 V	V _{CC} - 0.25	V _{CC}	V
	I _(OHmax) = - 3 mA ⁽²⁾		V _{CC} - 0.60	V _{CC}	
	I _(OHmax) = - 2 mA ⁽¹⁾	3 V	V _{CC} - 0.25	V _{CC}	
	I _(OHmax) = - 6 mA ⁽²⁾		V _{CC} - 0.60	V _{CC}	
V _{OL} Low-level output voltage	I _(OLmax) = 1 mA ⁽¹⁾	1.8 V	V _{SS}	V _{SS} + 0.25	V
	I _(OLmax) = 3 mA ⁽²⁾		V _{SS}	V _{SS} + 0.60	
	I _(OLmax) = 2 mA ⁽¹⁾	3 V	V _{SS}	V _{SS} + 0.25	
	I _(OLmax) = 6 mA ⁽²⁾		V _{SS}	V _{SS} + 0.60	

- (1) The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined, should not exceed ±48 mA to hold the maximum voltage drop specified.
- (2) The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined, should not exceed ±100 mA to hold the maximum voltage drop specified.
- (3) Selecting reduced drive strength may reduce EMI.

8.13 Output Frequency - Ports P1, P2, and P3

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
f _{Px.y} Port output frequency (with load)	P3.4/TA2CLK/SMCLK/S27, C _L = 20 pF, R _L = 1 kΩ ⁽¹⁾ or 3.2 kΩ ^{(2) (3)}	V _{CC} = 1.8 V, PMMCOREV _x = 0	8	MHz
		V _{CC} = 3 V, PMMCOREV _x = 3	20	
f _{Port_CLK} Clock output frequency	P1.0/TA0CLK/ACLK/S39, P3.4/TA2CLK/SMCLK/S27, P2.0/P2MAP0 (P2MAP0 = PM_MCLK), C _L = 20 pF ⁽³⁾	V _{CC} = 1.8 V, PMMCOREV _x = 0	8	MHz
		V _{CC} = 3 V, PMMCOREV _x = 3	20	

- (1) Full drive strength of port: A resistive divider with 2 × 0.5 kΩ between V_{CC} and V_{SS} is used as load. The output is connected to the center tap of the divider.
- (2) Reduced drive strength of port: A resistive divider with 2 × 1.6 kΩ between V_{CC} and V_{SS} is used as load. The output is connected to the center tap of the divider.
- (3) The output voltage reaches at least 10% and 90% V_{CC} at the specified toggle frequency.

8.14 Typical Characteristics – Outputs, Reduced Drive Strength (PxDS.y = 0)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

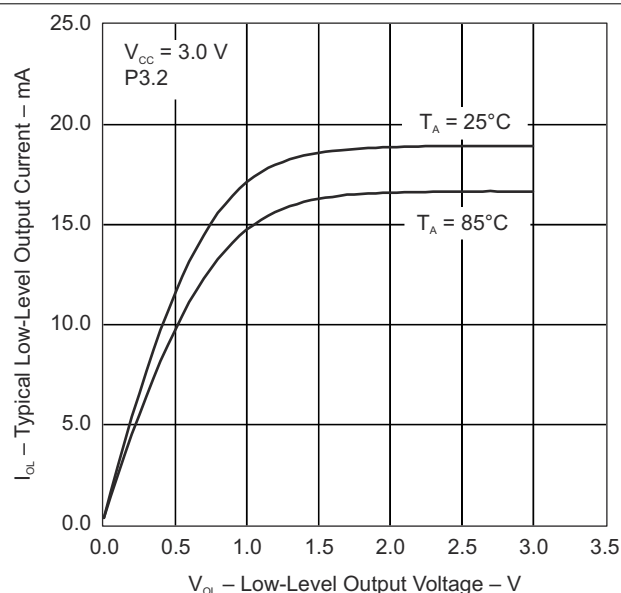


图 8-2. Typical Low-Level Output Current vs Low-Level Output Voltage

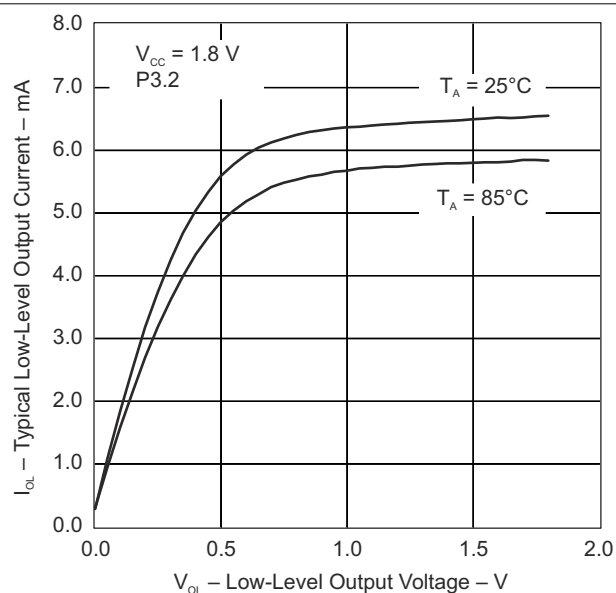


图 8-3. Typical Low-Level Output Current vs Low-Level Output Voltage

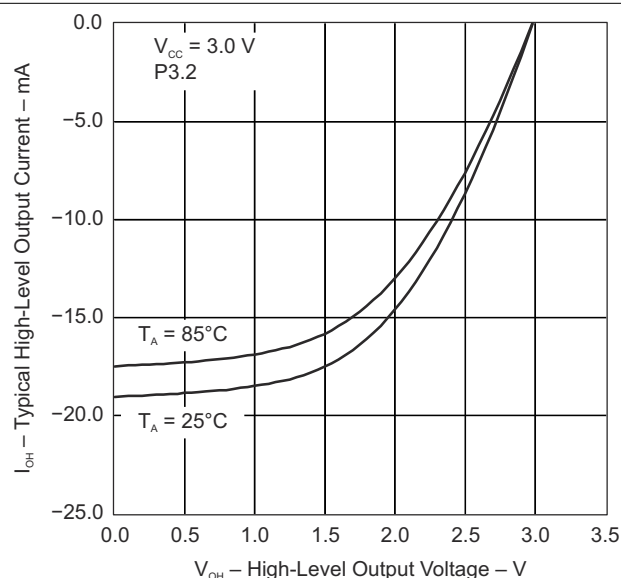


图 8-4. Typical High-Level Output Current vs High-Level Output Voltage

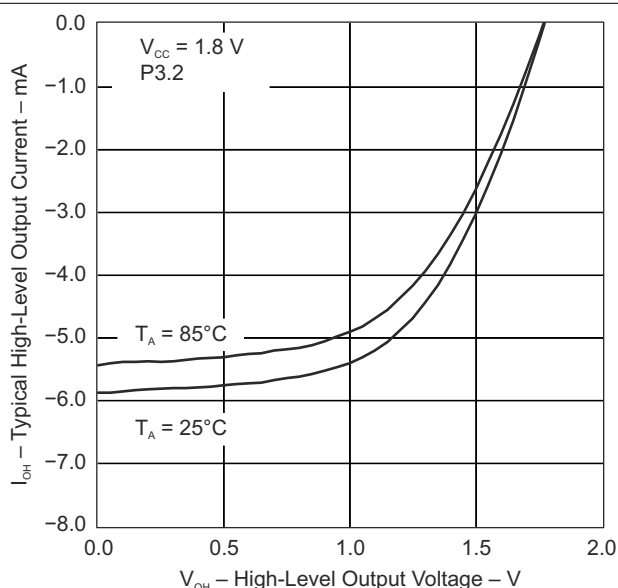


图 8-5. Typical High-Level Output Current vs High-Level Output Voltage

8.15 Typical Characteristics - Outputs, Full Drive Strength (PxDS.y = 1)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

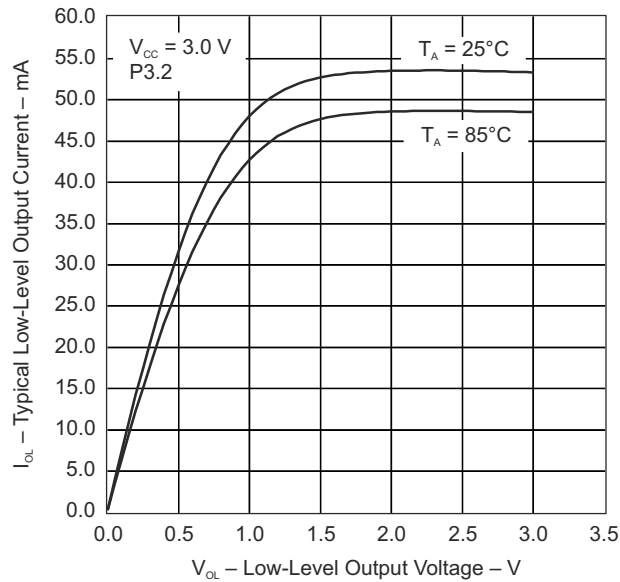


图 8-6. Typical Low-Level Output Current vs Low-Level Output Voltage

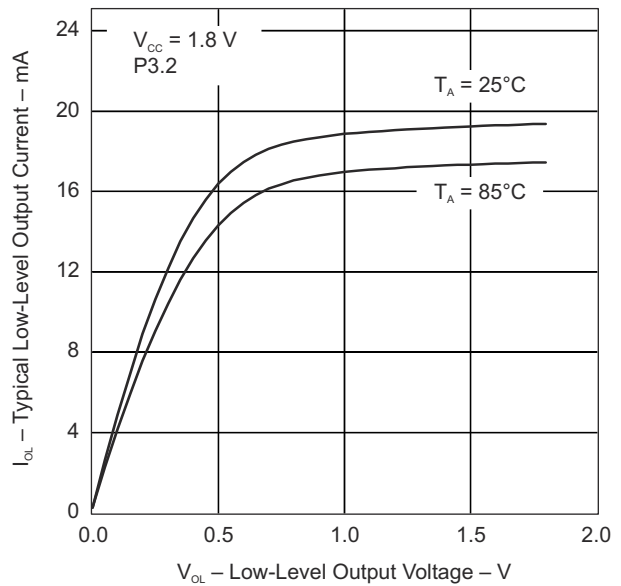


图 8-7. Typical Low-Level Output Current vs Low-Level Output Voltage

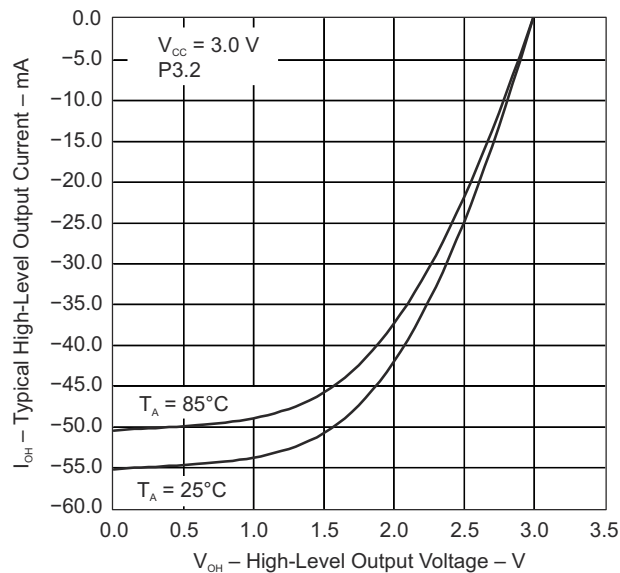


图 8-8. Typical High-Level Output Current vs High-Level Output Voltage

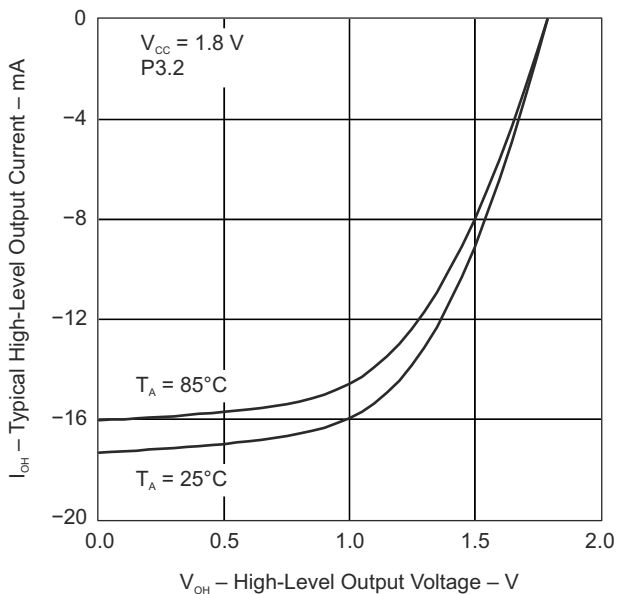


图 8-9. Typical High-Level Output Current vs High-Level Output Voltage

8.16 Crystal Oscillator, XT1, Low-Frequency Mode

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽⁵⁾

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
$\Delta I_{DVCC,LF}$	Differential XT1 oscillator crystal current consumption from lowest drive setting, LF mode $f_{OSC} = 32768 \text{ Hz}$, $XTS = 0$, $XT1BYPASS = 0$, $XT1DRIVEx = 1$, $T_A = 25^\circ\text{C}$	3 V		0.075		μA
	$f_{OSC} = 32768 \text{ Hz}$, $XTS = 0$, $XT1BYPASS = 0$, $XT1DRIVEx = 2$, $T_A = 25^\circ\text{C}$			0.170		
	$f_{OSC} = 32768 \text{ Hz}$, $XTS = 0$, $XT1BYPASS = 0$, $XT1DRIVEx = 3$, $T_A = 25^\circ\text{C}$			0.290		
$f_{XT1,LF0}$	XT1 oscillator crystal frequency, LF mode $XTS = 0$, $XT1BYPASS = 0$			32768		Hz
$f_{XT1,LF,SW}$	XT1 oscillator logic-level square-wave input frequency, LF mode $XTS = 0$, $XT1BYPASS = 1^{(6) (7)}$		10	32.768	50	kHz
OA_{LF}	Oscillation allowance for LF crystals ⁽⁸⁾ $XTS = 0$, $XT1BYPASS = 0$, $XT1DRIVEx = 0$, $f_{XT1,LF} = 32768 \text{ Hz}$, $C_{L,eff} = 6 \text{ pF}$			210		k Ω
	$XTS = 0$, $XT1BYPASS = 0$, $XT1DRIVEx = 1$, $f_{XT1,LF} = 32768 \text{ Hz}$, $C_{L,eff} = 12 \text{ pF}$			300		
$C_{L,eff}$	Integrated effective load capacitance, LF mode ⁽¹⁾ $XTS = 0$, $XCAPx = 0^{(2)}$			1		pF
	$XTS = 0$, $XCAPx = 1$			5.5		
	$XTS = 0$, $XCAPx = 2$			8.5		
	$XTS = 0$, $XCAPx = 3$			12.0		
	Duty cycle, LF mode $XTS = 0$, Measured at ACLK, $f_{XT1,LF} = 32768 \text{ Hz}$		30%		70%	
$f_{Fault,LF}$	Oscillator fault frequency, LF mode ⁽⁴⁾ $XTS = 0^{(3)}$		10		10000	Hz
$t_{START,LF}$	Start-up time, LF mode $f_{OSC} = 32768 \text{ Hz}$, $XTS = 0$, $XT1BYPASS = 0$, $XT1DRIVEx = 0$, $T_A = 25^\circ\text{C}$, $C_{L,eff} = 6 \text{ pF}$	3 V		1000		ms
	$f_{OSC} = 32768 \text{ Hz}$, $XTS = 0$, $XT1BYPASS = 0$, $XT1DRIVEx = 3$, $T_A = 25^\circ\text{C}$, $C_{L,eff} = 12 \text{ pF}$			500		

- (1) Includes parasitic bond and package capacitance (approximately 2 pF per pin). Because the PCB adds additional capacitance, TI recommends verifying the correct load by measuring the ACLK frequency. For a correct setup, the effective load capacitance should always match the specification of the used crystal.
- (2) Requires external capacitors at both terminals. Values are specified by crystal manufacturers.
- (3) Measured with logic-level input frequency but also applies to operation with crystals.
- (4) Frequencies below the MIN specification set the fault flag. Frequencies above the MAX specification do not set the fault flag. Frequencies in between might set the flag.
- (5) To improve EMI on the XT1 oscillator, the following guidelines should be observed.
 - Keep the trace between the device and the crystal as short as possible.
 - Design a good ground plane around the oscillator pins.
 - Prevent crosstalk from other clock or data lines into oscillator pins XIN and XOUT.
 - Avoid running PCB traces underneath or adjacent to the XIN and XOUT pins.
 - Use assembly materials and processes that avoid any parasitic load on the oscillator XIN and XOUT pins.
 - If conformal coating is used, make sure that it does not induce capacitive or resistive leakage between the oscillator pins.
- (6) When XT1BYPASS is set, XT1 circuit is automatically powered down. Input signal is a digital square wave with parametrics defined in the Schmitt-trigger Inputs section of this datasheet.
- (7) Maximum frequency of operation of the entire device cannot be exceeded.

- (8) Oscillation allowance is based on a safety factor of 5 for recommended crystals. The oscillation allowance is a function of the XT1DRIVE_x settings and the effective load. In general, comparable oscillator allowance can be achieved based on the following guidelines, but should be evaluated based on the actual crystal selected for the application:

- For XT1DRIVE_x = 0, $C_{L,eff} \leq 6$ pF.
- For XT1DRIVE_x = 1, $6 \text{ pF} \leq C_{L,eff} \leq 9$ pF.
- For XT1DRIVE_x = 2, $6 \text{ pF} \leq C_{L,eff} \leq 10$ pF.
- For XT1DRIVE_x = 3, $C_{L,eff} \geq 6$ pF.

8.17 Crystal Oscillator, XT2

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)^{(2) (5)}

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
I _{DVCC,XT2} XT2 oscillator crystal current consumption	f _{OSC} = 4 MHz, XT2OFF = 0, XT2BYPASS = 0, XT2DRIVE _x = 0, T _A = 25°C	3 V		200		μA
	f _{OSC} = 12 MHz, XT2OFF = 0, XT2BYPASS = 0, XT2DRIVE _x = 1, T _A = 25°C			260		
	f _{OSC} = 20 MHz, XT2OFF = 0, XT2BYPASS = 0, XT2DRIVE _x = 2, T _A = 25°C			325		
	f _{OSC} = 32 MHz, XT2OFF = 0, XT2BYPASS = 0, XT2DRIVE _x = 3, T _A = 25°C			450		
f _{XT2,HF0} XT2 oscillator crystal frequency, mode 0	XT2DRIVE _x = 0, XT2BYPASS = 0 ⁽⁷⁾		4		8	MHz
f _{XT2,HF1} XT2 oscillator crystal frequency, mode 1	XT2DRIVE _x = 1, XT2BYPASS = 0 ⁽⁷⁾		8		16	MHz
f _{XT2,HF2} XT2 oscillator crystal frequency, mode 2	XT2DRIVE _x = 2, XT2BYPASS = 0 ⁽⁷⁾		16		24	MHz
f _{XT2,HF3} XT2 oscillator crystal frequency, mode 3	XT2DRIVE _x = 3, XT2BYPASS = 0 ⁽⁷⁾		24		32	MHz
f _{XT2,HF,SW} XT2 oscillator logic-level square-wave input frequency	XT2BYPASS = 1 ^{(6) (7)}		0.7		32	MHz
O _{AHF} Oscillation allowance for HF crystals ⁽⁸⁾	XT2DRIVE _x = 0, XT2BYPASS = 0, f _{XT2,HF0} = 6 MHz, C _{L,eff} = 15 pF			450		Ω
	XT2DRIVE _x = 1, XT2BYPASS = 0, f _{XT2,HF1} = 12 MHz, C _{L,eff} = 15 pF			320		
	XT2DRIVE _x = 2, XT2BYPASS = 0, f _{XT2,HF2} = 20 MHz, C _{L,eff} = 15 pF			200		
	XT2DRIVE _x = 3, XT2BYPASS = 0, f _{XT2,HF3} = 32 MHz, C _{L,eff} = 15 pF			200		
t _{START,HF} Start-up time	f _{OSC} = 6 MHz, XT2BYPASS = 0, XT2DRIVE _x = 0, T _A = 25°C, C _{L,eff} = 15 pF	3 V		0.5		ms
	f _{OSC} = 20 MHz, XT2BYPASS = 0, XT2DRIVE _x = 3, T _A = 25°C, C _{L,eff} = 15 pF			0.3		
C _{L,eff} Integrated effective load capacitance, HF mode ^{(1) (2)}				1		pF
Duty cycle	Measured at ACLK, f _{XT2,HF2} = 20 MHz		40%	50%	60%	
f _{Fault,HF} Oscillator fault frequency ⁽⁴⁾	XT2BYPASS = 1 ⁽³⁾		30		300	kHz

- (1) Includes parasitic bond and package capacitance (approximately 2 pF per pin). Because the PCB adds additional capacitance, TI recommends verifying the correct load by measuring the ACLK frequency. For a correct setup, the effective load capacitance should always match the specification of the used crystal.
- (2) Requires external capacitors at both terminals. Values are specified by crystal manufacturers.
- (3) Measured with logic-level input frequency but also applies to operation with crystals.

- (4) Frequencies below the MIN specification set the fault flag. Frequencies above the MAX specification do not set the fault flag. Frequencies between the MIN and MAX specifications might set the flag.
- (5) To improve EMI on the XT2 oscillator the following guidelines should be observed.
 - Keep the traces between the device and the crystal as short as possible.
 - Design a good ground plane around the oscillator pins.
 - Prevent crosstalk from other clock or data lines into oscillator pins XT2IN and XT2OUT.
 - Avoid running PCB traces underneath or adjacent to the XT2IN and XT2OUT pins.
 - Use assembly materials and processes that avoid any parasitic load on the oscillator XT2IN and XT2OUT pins.
 - If conformal coating is used, make sure that it does not induce capacitive or resistive leakage between the oscillator pins.
- (6) When XT2BYPASS is set, the XT2 circuit is automatically powered down.
- (7) Maximum frequency of operation of the entire device cannot be exceeded.
- (8) Oscillation allowance is based on a safety factor of 5 for recommended crystals.

8.18 Internal Very-Low-Power Low-Frequency Oscillator (VLO)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
f _{VLO}	VLO frequency	Measured at ACLK	1.8 V to 3.6 V	6	9.4	14	kHz
df _{VLO} /dT	VLO frequency temperature drift	Measured at ACLK ⁽¹⁾	1.8 V to 3.6 V		0.5		%/°C
df _{VLO} /dV _{CC}	VLO frequency supply voltage drift	Measured at ACLK ⁽²⁾	1.8 V to 3.6 V		4		%/V
	Duty cycle	Measured at ACLK	1.8 V to 3.6 V	40%	50%	60%	

(1) Calculated using the box method: (MAX(–40°C to +85°C) – MIN(–40°C to +85°C)) / MIN(–40°C to +85°C) / (85°C – (–40°C))

(2) Calculated using the box method: (MAX(1.8 V to 3.6 V) – MIN(1.8 V to 3.6 V)) / MIN(1.8 V to 3.6 V) / (3.6 V – 1.8 V)

8.19 Internal Reference, Low-Frequency Oscillator (REFO)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
I _{REFO}	REFO oscillator current consumption	T _A = 25°C	1.8 V to 3.6 V	3			μA
f _{REFO}	REFO frequency calibrated	Measured at ACLK	1.8 V to 3.6 V	32768			Hz
	REFO absolute tolerance calibrated	Full temperature range	1.8 V to 3.6 V	±3.5%			
		T _A = 25°C	3 V	±1.5%			
df _{REFO} /dT	REFO frequency temperature drift	Measured at ACLK ⁽¹⁾	1.8 V to 3.6 V	0.01			%/°C
df _{REFO} /dV _{CC}	REFO frequency supply voltage drift	Measured at ACLK ⁽²⁾	1.8 V to 3.6 V	1.0			%/V
	Duty cycle	Measured at ACLK	1.8 V to 3.6 V	40%	50%	60%	
t _{START}	REFO start-up time	40%/60% duty cycle	1.8 V to 3.6 V	25			μs

(1) Calculated using the box method: (MAX(–40°C to +85°C) – MIN(–40°C to +85°C)) / MIN(–40°C to +85°C) / (85°C – (–40°C))

(2) Calculated using the box method: (MAX(1.8 V to 3.6 V) – MIN(1.8 V to 3.6 V)) / MIN(1.8 V to 3.6 V) / (3.6 V – 1.8 V)

8.20 DCO Frequency

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$f_{\text{DCO}(0,0)}$	DCO frequency (0, 0)	DCORSELx = 0, DCOx = 0, MODx = 0	0.07	0.20	MHz
$f_{\text{DCO}(0,31)}$	DCO frequency (0, 31)	DCORSELx = 0, DCOx = 31, MODx = 0	0.70	1.70	MHz
$f_{\text{DCO}(1,0)}$	DCO frequency (1, 0)	DCORSELx = 1, DCOx = 0, MODx = 0	0.15	0.36	MHz
$f_{\text{DCO}(1,31)}$	DCO frequency (1, 31)	DCORSELx = 1, DCOx = 31, MODx = 0	1.47	3.45	MHz
$f_{\text{DCO}(2,0)}$	DCO frequency (2, 0)	DCORSELx = 2, DCOx = 0, MODx = 0	0.32	0.75	MHz
$f_{\text{DCO}(2,31)}$	DCO frequency (2, 31)	DCORSELx = 2, DCOx = 31, MODx = 0	3.17	7.38	MHz
$f_{\text{DCO}(3,0)}$	DCO frequency (3, 0)	DCORSELx = 3, DCOx = 0, MODx = 0	0.64	1.51	MHz
$f_{\text{DCO}(3,31)}$	DCO frequency (3, 31)	DCORSELx = 3, DCOx = 31, MODx = 0	6.07	14.0	MHz
$f_{\text{DCO}(4,0)}$	DCO frequency (4, 0)	DCORSELx = 4, DCOx = 0, MODx = 0	1.3	3.2	MHz
$f_{\text{DCO}(4,31)}$	DCO frequency (4, 31)	DCORSELx = 4, DCOx = 31, MODx = 0	12.3	28.2	MHz
$f_{\text{DCO}(5,0)}$	DCO frequency (5, 0)	DCORSELx = 5, DCOx = 0, MODx = 0	2.5	6.0	MHz
$f_{\text{DCO}(5,31)}$	DCO frequency (5, 31)	DCORSELx = 5, DCOx = 31, MODx = 0	23.7	54.1	MHz
$f_{\text{DCO}(6,0)}$	DCO frequency (6, 0)	DCORSELx = 6, DCOx = 0, MODx = 0	4.6	10.7	MHz
$f_{\text{DCO}(6,31)}$	DCO frequency (6, 31)	DCORSELx = 6, DCOx = 31, MODx = 0	39.0	88.0	MHz
$f_{\text{DCO}(7,0)}$	DCO frequency (7, 0)	DCORSELx = 7, DCOx = 0, MODx = 0	8.5	19.6	MHz
$f_{\text{DCO}(7,31)}$	DCO frequency (7, 31)	DCORSELx = 7, DCOx = 31, MODx = 0	60	135	MHz
S_{DCORSEL}	Frequency step between range DCORSEL and DCORSEL + 1	$S_{\text{RSEL}} = f_{\text{DCO}(\text{DCORSEL}+1, \text{DCO})} / f_{\text{DCO}(\text{DCORSEL}, \text{DCO})}$	1.2	2.3	ratio
S_{DCO}	Frequency step between tap DCO and DCO + 1	$S_{\text{DCO}} = f_{\text{DCO}(\text{DCORSEL}, \text{DCO}+1)} / f_{\text{DCO}(\text{DCORSEL}, \text{DCO})}$	1.02	1.12	ratio
	Duty cycle	Measured at SMCLK	40%	50%	60%
df_{DCO}/dT	DCO frequency temperature drift	$f_{\text{DCO}} = 1 \text{ MHz}$	0.1		%/°C
$df_{\text{DCO}}/dV_{\text{CC}}$	DCO frequency voltage drift	$f_{\text{DCO}} = 1 \text{ MHz}$	1.9		%/V

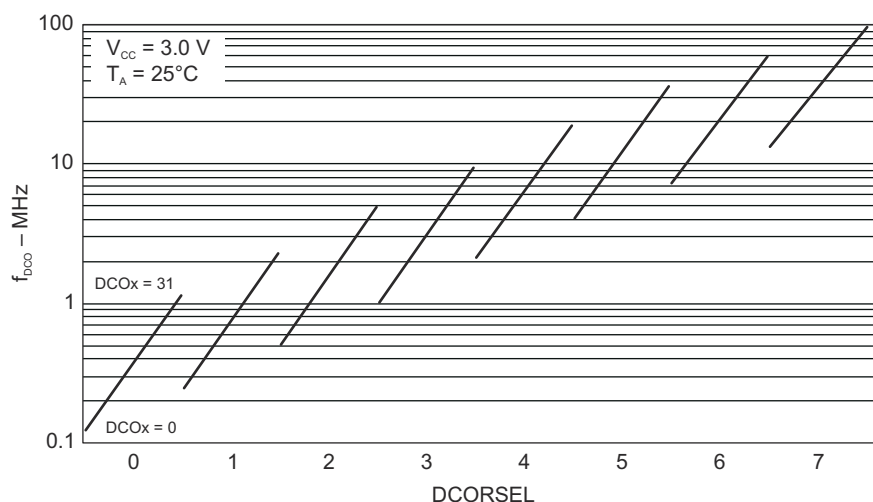


图 8-10. Typical DCO Frequency

8.21 PMM, Brownout Reset (BOR)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{(DVCC_BOR_IT-)}$	BOR _H on voltage, DV _{CC} falling level	$ dDV_{CC}/dt < 3 \text{ V/s}$			1.45	V
$V_{(DVCC_BOR_IT+)}$	BOR _H off voltage, DV _{CC} rising level	$ dDV_{CC}/dt < 3 \text{ V/s}$	0.80	1.30	1.50	V
$V_{(DVCC_BOR_hys)}$	BOR _H hysteresis		50		250	mV
t_{RESET}	Pulse duration required at RST/NMI pin to accept a reset		2			μs

8.22 PMM, Core Voltage

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
$V_{CORE3(AM)}$	Core voltage, active mode, PMMCOREV = 3	$2.4 \text{ V} \leq DV_{CC} \leq 3.6 \text{ V}, 0 \text{ mA} \leq I(V_{CORE}) \leq 21 \text{ mA}$		1.90		V
$V_{CORE2(AM)}$	Core voltage, active mode, PMMCOREV = 2	$2.2 \text{ V} \leq DV_{CC} \leq 3.6 \text{ V}, 0 \text{ mA} \leq I(V_{CORE}) \leq 21 \text{ mA}$		1.80		V
$V_{CORE1(AM)}$	Core voltage, active mode, PMMCOREV = 1	$2 \text{ V} \leq DV_{CC} \leq 3.6 \text{ V}, 0 \text{ mA} \leq I(V_{CORE}) \leq 17 \text{ mA}$		1.60		V
$V_{CORE0(AM)}$	Core voltage, active mode, PMMCOREV = 0	$1.8 \text{ V} \leq DV_{CC} \leq 3.6 \text{ V}, 0 \text{ mA} \leq I(V_{CORE}) \leq 13 \text{ mA}$		1.40		V
$V_{CORE3(LPM)}$	Core voltage, low-current mode, PMMCOREV = 3	$2.4 \text{ V} \leq DV_{CC} \leq 3.6 \text{ V}, 0 \mu\text{A} \leq I(V_{CORE}) \leq 30 \mu\text{A}$		1.94		V
$V_{CORE2(LPM)}$	Core voltage, low-current mode, PMMCOREV = 2	$2.2 \text{ V} \leq DV_{CC} \leq 3.6 \text{ V}, 0 \mu\text{A} \leq I(V_{CORE}) \leq 30 \mu\text{A}$		1.84		V
$V_{CORE1(LPM)}$	Core voltage, low-current mode, PMMCOREV = 1	$2 \text{ V} \leq DV_{CC} \leq 3.6 \text{ V}, 0 \mu\text{A} \leq I(V_{CORE}) \leq 30 \mu\text{A}$		1.64		V
$V_{CORE0(LPM)}$	Core voltage, low-current mode, PMMCOREV = 0	$1.8 \text{ V} \leq DV_{CC} \leq 3.6 \text{ V}, 0 \mu\text{A} \leq I(V_{CORE}) \leq 30 \mu\text{A}$		1.44		V

8.23 PMM, SVS High Side

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{(SVSH)}$ SVS current consumption	SVSHE = 0, DV _{CC} = 3.6 V		0		nA
	SVSHE = 1, DV _{CC} = 3.6 V, SVSHFP = 0		200		
	SVSHE = 1, DV _{CC} = 3.6 V, SVSHFP = 1		2.0		μA
$V_{(SVSH_IT-)}$ SVS _H on voltage level ⁽¹⁾	SVSHE = 1, SVSHRVL = 0	1.59	1.64	1.69	V
	SVSHE = 1, SVSHRVL = 1	1.79	1.84	1.91	
	SVSHE = 1, SVSHRVL = 2	1.98	2.04	2.11	
	SVSHE = 1, SVSHRVL = 3	2.10	2.16	2.23	
$V_{(SVSH_IT+)}$ SVS _H off voltage level ⁽¹⁾	SVSHE = 1, SVSMHRRRL = 0	1.62	1.74	1.81	V
	SVSHE = 1, SVSMHRRRL = 1	1.88	1.94	2.01	
	SVSHE = 1, SVSMHRRRL = 2	2.07	2.14	2.21	
	SVSHE = 1, SVSMHRRRL = 3	2.20	2.26	2.33	
	SVSHE = 1, SVSMHRRRL = 4	2.32	2.40	2.48	
	SVSHE = 1, SVSMHRRRL = 5	2.56	2.70	2.84	
	SVSHE = 1, SVSMHRRRL = 6	2.85	3.00	3.15	
	SVSHE = 1, SVSMHRRRL = 7	2.85	3.00	3.15	
$t_{pd(SVSH)}$ SVS _H propagation delay	SVSHE = 1, dV _{DVCC} /dt = 10 mV/μs, SVSHFP = 1		2.5		μs
	SVSHE = 1, dV _{DVCC} /dt = 1 mV/μs, SVSHFP = 0		20		
$t_{(SVSH)}$ SVS _H on or off delay time	SVSHE = 0→1, SVSHFP = 1		12.5		μs
	SVSHE = 0→1, SVSHFP = 0		100		
dV _{DVCC} /dt DV _{CC} rise time		0		1000	V/s

(1) The SVS_H settings available depend on the VCORE (PMMCOREVx) setting. See the *Power Management Module and Supply Voltage Supervisor* chapter in the *MSP430F5xx and MSP430F6xx Family User's Guide* on recommended settings and usage.

8.24 PMM, SVM High Side

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{(SVMH)}$ SVM _H current consumption	SVMHE = 0, DV _{CC} = 3.6 V		0		nA
	SVMHE = 1, DV _{CC} = 3.6 V, SVMHFP = 0		200		
	SVMHE = 1, DV _{CC} = 3.6 V, SVMHFP = 1		2.0		μA
$V_{(SVMH)}$ SVM _H on or off voltage level ⁽¹⁾	SVMHE = 1, SVSMHRRRL = 0	1.65	1.74	1.86	V
	SVMHE = 1, SVSMHRRRL = 1	1.85	1.94	2.02	
	SVMHE = 1, SVSMHRRRL = 2	2.02	2.14	2.22	
	SVMHE = 1, SVSMHRRRL = 3	2.18	2.26	2.35	
	SVMHE = 1, SVSMHRRRL = 4	2.32	2.40	2.48	
	SVMHE = 1, SVSMHRRRL = 5	2.56	2.70	2.84	
	SVMHE = 1, SVSMHRRRL = 6	2.85	3.00	3.15	
	SVMHE = 1, SVSMHRRRL = 7	2.85	3.00	3.15	
	SVMHE = 1, SVMHOVPE = 1		3.75		
$t_{pd(SVMH)}$ SVM _H propagation delay	SVMHE = 1, dV _{DVCC} /dt = 10 mV/μs, SVMHFP = 1		2.5		μs
	SVMHE = 1, dV _{DVCC} /dt = 1 mV/μs, SVMHFP = 0		20		
$t_{(SVMH)}$ SVM _H on or off delay time	SVMHE = 0→1, SVSMF = 1		12.5		μs
	SVMHE = 0→1, SVMHFP = 0		100		

(1) The SVM_H settings available depend on the VCORE (PMMCOREVx) setting. See the *Power Management Module and Supply Voltage Supervisor* chapter in the *MSP430F5xx and MSP430F6xx Family User's Guide* on recommended settings and usage.

8.25 PMM, SVS Low Side

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{(SVSL)}$ SVS _L current consumption	SVSLE = 0, PMMCOREV = 2		0		nA
	SVSLE = 1, PMMCOREV = 2, SVSLFP = 0		200		
	SVSLE = 1, PMMCOREV = 2, SVSLFP = 1		2.0		μA
$t_{pd(SVSL)}$ SVS _L propagation delay	SVSLE = 1, $dV_{CORE}/dt = 10 \text{ mV}/\mu\text{s}$, SVSLFP = 1		2.5		μs
	SVSLE = 1, $dV_{CORE}/dt = 1 \text{ mV}/\mu\text{s}$, SVSLFP = 0		20		
$t_{(SVSL)}$ SVS _L on or off delay time	SVSLE = 0 → 1, SVSLFP = 1		12.5		μs
	SVSLE = 0 → 1, SVSLFP = 0		100		

8.26 PMM, SVM Low Side

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{(SVM_L)}$ SVM _L current consumption	SVMLE = 0, PMMCOREV = 2		0		nA
	SVMLE = 1, PMMCOREV = 2, SVMLEFP = 0		200		
	SVMLE = 1, PMMCOREV = 2, SVMLEFP = 1		2.0		μA
$t_{pd(SVM_L)}$ SVM _L propagation delay	SVMLE = 1, $dV_{CORE}/dt = 10 \text{ mV}/\mu\text{s}$, SVMLEFP = 1		2.5		μs
	SVMLE = 1, $dV_{CORE}/dt = 1 \text{ mV}/\mu\text{s}$, SVMLEFP = 0		20		
$t_{(SVM_L)}$ SVM _L on or off delay time	SVMLE = 0 → 1, SVMLEFP = 1		12.5		μs
	SVMLE = 0 → 1, SVMLEFP = 0		100		

8.27 Wake-up Times From Low-Power Modes and Reset

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{\text{WAKE-UP-FAST}}$ Wake-up time from LPM2, LPM3, or LPM4 to active mode ⁽¹⁾	PMMCOREV = SVSMLRRL = n (where n = 0, 1, 2, or 3), SVSLFP = 1	$f_{\text{MCLK}} \geq 4 \text{ MHz}$	3	6.5	μs
		$1 \text{ MHz} < f_{\text{MCLK}} < 4 \text{ MHz}$	4	8.0	
$t_{\text{WAKE-UP-SLOW}}$ Wake-up time from LPM2, LPM3, or LPM4 to active mode ^{(2) (3)}	PMMCOREV = SVSMLRRL = n (where n = 0, 1, 2, or 3), SVSLFP = 0		150	165	μs
$t_{\text{WAKE-UP-LPM5}}$ Wake-up time from LPM3.5 or LPM4.5 to active mode ⁽⁴⁾			2	3	ms
$t_{\text{WAKE-UP-RESET}}$ Wake-up time from RST or BOR event to active mode ⁽⁴⁾			2	3	ms

- (1) This value represents the time from the wake-up event to the first active edge of MCLK. The wake-up time depends on the performance mode of the low-side supervisor (SVS_L) and low-side monitor (SVM_L). $t_{\text{WAKE-UP-FAST}}$ is possible with SVS_L and SVM_L in full performance mode or disabled. For specific register settings, see the *Low-Side SVS and SVM Control and Performance Mode Selection* section in the *Power Management Module and Supply Voltage Supervisor* chapter of the [MSP430F5xx and MSP430F6xx Family User's Guide](#).
- (2) This value represents the time from the wake-up event to the first active edge of MCLK. The wake-up time depends on the performance mode of the low-side supervisor (SVS_L) and low-side monitor (SVM_L). $t_{\text{WAKE-UP-SLOW}}$ is set with SVS_L and SVM_L in normal mode (low current mode). For specific register settings, see the *Low-Side SVS and SVM Control and Performance Mode Selection* section in the *Power Management Module and Supply Voltage Supervisor* chapter of the [MSP430F5xx and MSP430F6xx Family User's Guide](#).
- (3) The wake-up times from LPM0 and LPM1 to AM are not specified. They are proportional to MCLK cycle time but are not affected by the performance mode settings as for LPM2, LPM3, and LPM4.
- (4) This value represents the time from the wake-up event to the reset vector execution.

8.28 Timer_A, Timers TA0, TA1, and TA2

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
f _{TA}	Timer_A input clock frequency	Internal: SMCLK or ACLK, External: TACLK, Duty cycle = 50% ±10%	1.8 V, 3 V		20	MHz
t _{TA,cap}	Timer_A capture timing	All capture inputs, Minimum pulse duration required for capture	1.8 V, 3 V	20		ns

8.29 Timer_B, Timer TB0

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
f _{TB}	Timer_B input clock frequency	Internal: SMCLK or ACLK, External: TBCLK, Duty cycle = 50% ±10%	1.8 V, 3 V		20	MHz
t _{TB,cap}	Timer_B capture timing	All capture inputs, Minimum pulse duration required for capture	1.8 V, 3 V	20		ns

8.30 Battery Backup

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		V _{CC}	MIN	TYP	MAX	UNIT
I _{VBAT}	Current into VBAT terminal if no primary battery is connected	VBAT = 1.7 V, DVCC not connected, RTC running	T _A = - 40°C			0.43		μA
			T _A = 25°C			0.52		
			T _A = 60°C			0.58		
			T _A = 85°C			0.64		
		VBAT = 2.2 V, DVCC not connected, RTC running	T _A = - 40°C			0.50		
			T _A = 25°C			0.59		
			T _A = 60°C			0.64		
			T _A = 85°C			0.71		
		VBAT = 3 V, DVCC not connected, RTC running	T _A = - 40°C			0.68		
			T _A = 25°C			0.75		
			T _A = 60°C			0.79		
			T _A = 85°C			0.86		
V _{SWITCH}	Switch-over level (V _{CC} to VBAT)	C _{VCC} = 4.7 μF	General		V _{SVSH_IT-}			V
			SVSHRL = 0		1.59		1.69	
			SVSHRL = 1		1.79		1.91	
			SVSHRL = 2		1.98		2.11	
			SVSHRL = 3		2.10		2.23	
R _{ON_VBAT}	ON-resistance of switch between VBAT and VBAK	V _{BAT} = 1.8 V		0 V		0.35	1	kΩ
V _{BAT3}	VBAT to ADC input channel 12: V _{BAT} divided, V _{BAT3} = V _{BAT} /3			1.8 V		0.6	±5%	V
				3 V		1.0	±5%	
				3.6 V		1.2	±5%	
t _{Sample, VBAT3}	VBAT to ADC: Sampling time required if VBAT3 selected	ADC12ON = 1, Error of conversion result ≤ 1 LSB			1000			ns
V _{CHVx}	Charger end voltage	CHVx = 2			2.65	2.7	2.9	V
R _{CHARGE}	Charge limiting resistor	CHCx = 1					5	kΩ
		CHCx = 2					10	
		CHCx = 3					20	

8.31 USCI (UART Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
f _{USCI} USCI input clock frequency	Internal: SMCLK or ACLK, External: UCLK, Duty cycle = 50% ±10%		f _{SYSTEM}		MHz
f _{BITCLK} BITCLK clock frequency (equals baud rate in MBaud)			1		MHz
t _τ UART receive deglitch time ⁽¹⁾		2.2 V	50	600	ns
		3 V	50	600	

- (1) Pulses on the UART receive input (UCxRX) shorter than the UART receive deglitch time are suppressed. To ensure that pulses are correctly recognized their width should exceed the maximum specification of the deglitch time.

8.32 USCI (SPI Master Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

(see [图 8-11](#) and [图 8-12](#))

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
f _{USCI} USCI input clock frequency	SMCLK or ACLK, Duty cycle = 50% ±10%		f _{SYSTEM}		MHz
t _{SU,MI} SOMI input data setup time	PMMCOREV = 0	1.8 V	55		ns
		3 V	38		
	PMMCOREV = 3	2.4 V	30		
		3 V	25		
t _{HD,MI} SOMI input data hold time	PMMCOREV = 0	1.8 V	0		ns
		3 V	0		
	PMMCOREV = 3	2.4 V	0		
		3 V	0		
t _{VALID,MO} SIMO output data valid time ⁽²⁾	UCLK edge to SIMO valid, C _L = 20 pF, PMMCOREV = 0	1.8 V		20	ns
		3 V		18	
	UCLK edge to SIMO valid, C _L = 20 pF, PMMCOREV = 3	2.4 V		16	
		3 V		15	
t _{HD,MO} SIMO output data hold time ⁽³⁾	C _L = 20 pF, PMMCOREV = 0	1.8 V	- 10		ns
		3 V	- 8		
	C _L = 20 pF, PMMCOREV = 3	2.4 V	- 10		
		3 V	- 8		

- (1) f_{UCXCLK} = 1/2t_{LO/HI} with t_{LO/HI} ≥ max(t_{VALID,MO}(USCI) + t_{SU,SI}(Slave), t_{SU,MI}(USCI) + t_{VALID,SO}(Slave))
For the slave parameters t_{SU,SI}(Slave) and t_{VALID,SO}(Slave), see the SPI parameters of the attached slave.
- (2) Specifies the time to drive the next valid data to the SIMO output after the output changing UCLK clock edge. See the timing diagrams in [图 8-11](#) and [图 8-12](#).
- (3) Specifies how long data on the SIMO output is valid after the output changing UCLK clock edge. Negative values indicate that the data on the SIMO output can become invalid before the output changing clock edge observed on UCLK. See the timing diagrams in [图 8-11](#) and [图 8-12](#).

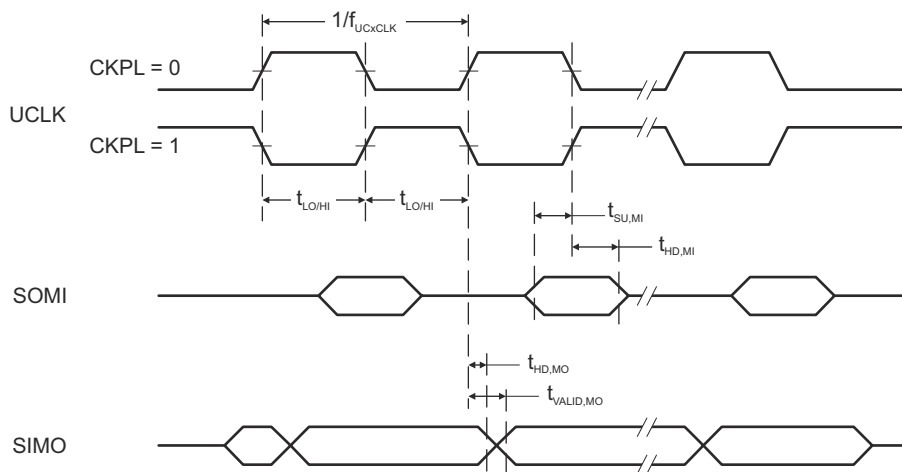


图 8-11. SPI Master Mode, CKPH = 0

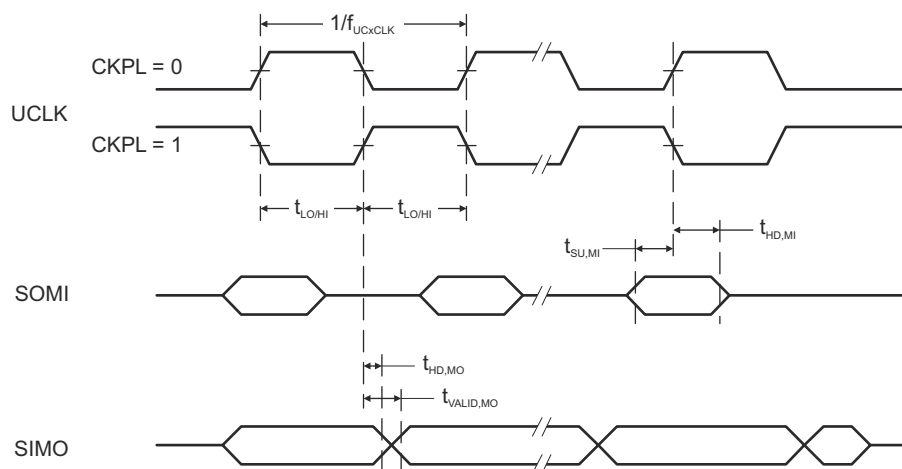


图 8-12. SPI Master Mode, CKPH = 1

8.33 USCI (SPI Slave Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾
(see [图 8-13](#) and [图 8-14](#))

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
t _{STE,LEAD} STE lead time, STE low to clock	PMMCOREV = 0	1.8 V	11		ns
		3 V	8		
	PMMCOREV = 3	2.4 V	7		
		3 V	6		
t _{STE,LAG} STE lag time, Last clock to STE high	PMMCOREV = 0	1.8 V	3		ns
		3 V	3		
	PMMCOREV = 3	2.4 V	3		
		3 V	3		
t _{STE,ACC} STE access time, STE low to SOMI data out	PMMCOREV = 0	1.8 V		66	ns
		3 V		50	
	PMMCOREV = 3	2.4 V		36	
		3 V		30	
t _{STE,DIS} STE disable time, STE high to SOMI high impedance	PMMCOREV = 0	1.8 V		30	ns
		3 V		23	
	PMMCOREV = 3	2.4 V		16	
		3 V		13	
t _{SU,SI} SIMO input data setup time	PMMCOREV = 0	1.8 V	5		ns
		3 V	5		
	PMMCOREV = 3	2.4 V	2		
		3 V	2		
t _{HD,SI} SIMO input data hold time	PMMCOREV = 0	1.8 V	5		ns
		3 V	5		
	PMMCOREV = 3	2.4 V	5		
		3 V	5		
t _{VALID,SO} SOMI output data valid time ⁽²⁾	UCLK edge to SOMI valid, C _L = 20 pF, PMMCOREV = 0	1.8 V		76	ns
		3 V		60	
	UCLK edge to SOMI valid, C _L = 20 pF, PMMCOREV = 3	2.4 V		44	
		3 V		40	
t _{HD,SO} SOMI output data hold time ⁽³⁾	C _L = 20 pF, PMMCOREV = 0	1.8 V	18		ns
		3 V	12		
	C _L = 20 pF, PMMCOREV = 3	2.4 V	10		
		3 V	8		

(1) $f_{UCLK} = 1/2t_{LO/HI}$ with $t_{LO/HI} \geq \max(t_{VALID,MO(Master)} + t_{SU,SI(USCI)}, t_{SU,MI(Master)} + t_{VALID,SO(USCI)})$

For the master parameters $t_{SU,MI(Master)}$ and $t_{VALID,MO(Master)}$, see the SPI parameters of the attached master.

- (2) Specifies the time to drive the next valid data to the SOMI output after the output changing UCLK clock edge. See the timing diagrams in [图 8-13](#) and [图 8-14](#).
- (3) Specifies how long data on the SOMI output is valid after the output changing UCLK clock edge. See the timing diagrams in [图 8-13](#) and [图 8-14](#).

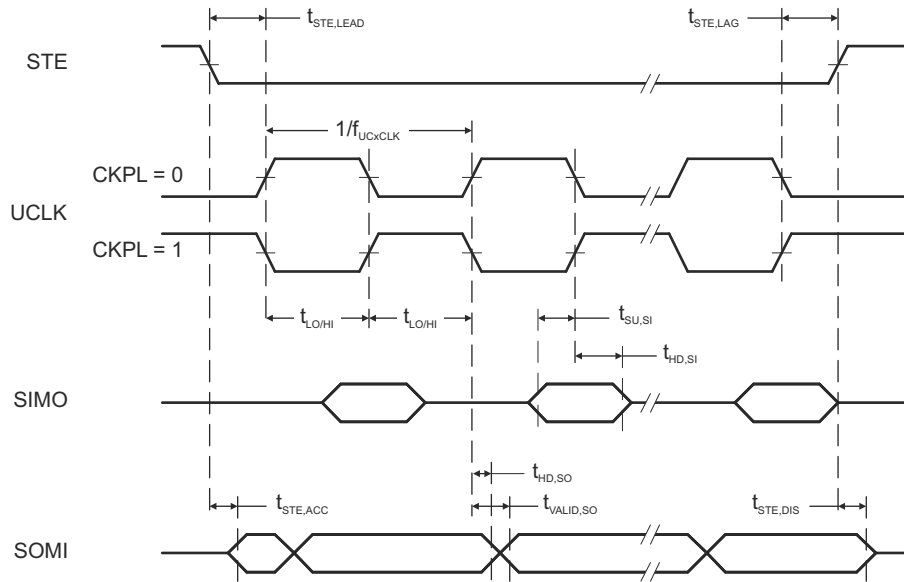


图 8-13. SPI Slave Mode, CKPH = 0

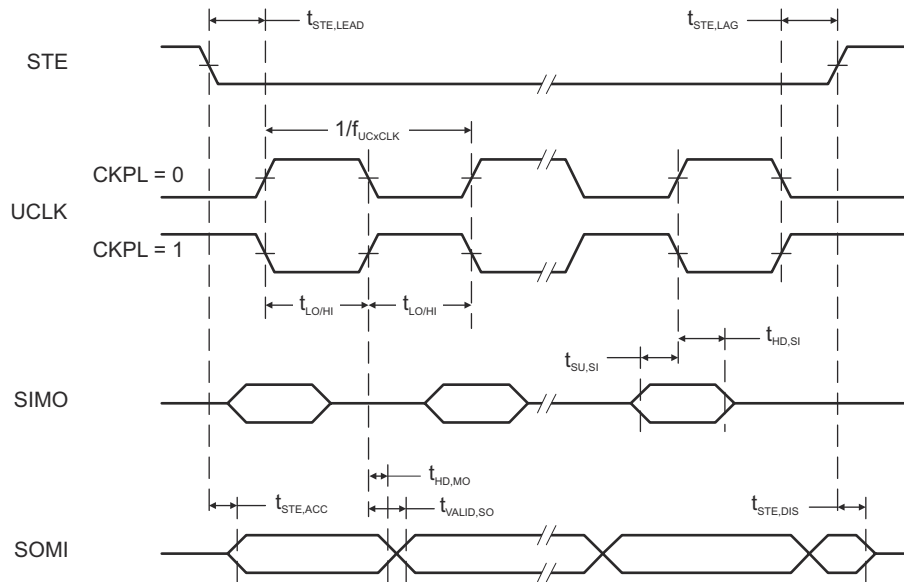


图 8-14. SPI Slave Mode, CKPH = 1

8.34 USCI (I²C Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see 图 8-15)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
f _{USCI}	USCI input clock frequency	Internal: SMCLK or ACLK, External: UCLK Duty cycle = 50% ±10%		f _{SYSTEM}	MHz
f _{SCL}	SCL clock frequency		2.2 V, 3 V	0 400	kHz
t _{HD,STA}	Hold time (repeated) START	f _{SCL} ≤ 100 kHz f _{SCL} > 100 kHz	2.2 V, 3 V	4.0 0.6	μs
t _{SU,STA}	Setup time for a repeated START	f _{SCL} ≤ 100 kHz f _{SCL} > 100 kHz	2.2 V, 3 V	4.7 0.6	μs
t _{HD,DAT}	Data hold time		2.2 V, 3 V	0	ns
t _{SU,DAT}	Data setup time		2.2 V, 3 V	250	ns
t _{SU,STO}	Setup time for STOP	f _{SCL} ≤ 100 kHz f _{SCL} > 100 kHz	2.2 V, 3 V	4.0 0.6	μs
t _{SP}	Pulse duration of spikes suppressed by input filter		2.2 V 3 V	50 600 50 600	ns

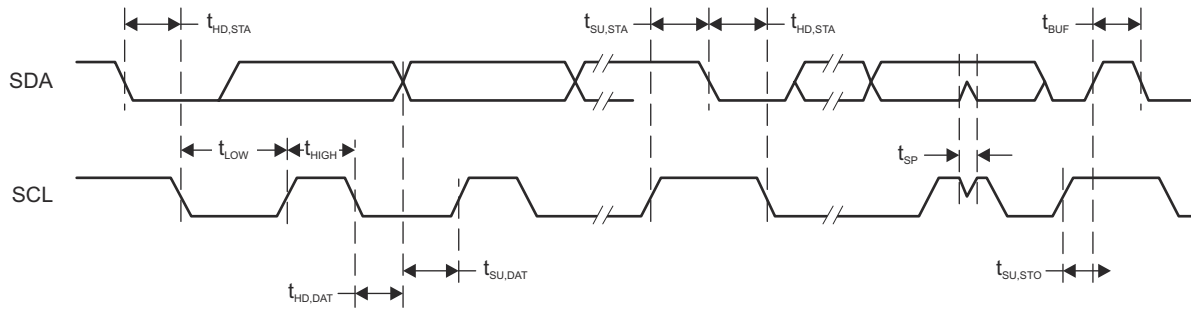


图 8-15. I²C Mode Timing

8.35 LCD_B, Recommended Operating Conditions

PARAMETER		CONDITIONS	MIN	NOM	MAX	UNIT
V _{CC,LCD_B, CP en,3.6}	Supply voltage range, charge pump enabled, V _{LCD} ≤ 3.6 V	LCDCPEN = 1, 0000 < VLCDx ≤ 1111 (charge pump enabled, V _{LCD} ≤ 3.6 V)	2.2		3.6	V
V _{CC,LCD_B, CP en,3.3}	Supply voltage range, charge pump enabled, V _{LCD} ≤ 3.3 V	LCDCPEN = 1, 0000 < VLCDx ≤ 1100 (charge pump enabled, V _{LCD} ≤ 3.3 V)	2.0		3.6	V
V _{CC,LCD_B, int. bias}	Supply voltage range, internal biasing, charge pump disabled	LCDCPEN = 0, VLCDEXT = 0	2.4		3.6	V
V _{CC,LCD_B, ext. bias}	Supply voltage range, external biasing, charge pump disabled	LCDCPEN = 0, VLCDEXT = 0	2.4		3.6	V
V _{CC,LCD_B, VLCDEXT}	Supply voltage range, external LCD voltage, internal or external biasing, charge pump disabled	LCDCPEN = 0, VLCDEXT = 1	2.0		3.6	V
V _{LDCAP/R33}	External LCD voltage at LDCAP/R33, internal or external biasing, charge pump disabled	LCDCPEN = 0, VLCDEXT = 1	2.4		3.6	V
C _{LDCAP}	Capacitor on LDCAP when charge pump enabled	LCDCPEN = 1, VLCDx > 0000 (charge pump enabled)	4.7	4.7	10	μF
f _{Frame}	LCD frame frequency range	f _{LCD} = 2 × mux × f _{FRAME} (mux = 1 (static), 2, 3, 4)	0		100	Hz
f _{ACLK,in}	ACLK input frequency range		30	32	40	kHz
C _{Panel}	Panel capacitance	100-Hz frame frequency			10000	pF
V _{R33}	Analog input voltage at R33	LCDCPEN = 0, VLCDEXT = 1	2.4		V _{CC} + 0.2	V
V _{R23,1/3bias}	Analog input voltage at R23	LCDREXT = 1, LCDEXTBIAS = 1, LCD2B = 0	V _{R13}	$V_{R03} + \frac{2}{3} \times (V_{R33} - V_{R03})$	V _{R33}	V
V _{R13,1/3bias}	Analog input voltage at R13 with 1/3 biasing	LCDREXT = 1, LCDEXTBIAS = 1, LCD2B = 0	V _{R03}	$V_{R03} + \frac{1}{3} \times (V_{R33} - V_{R03})$	V _{R23}	V
V _{R13,1/2bias}	Analog input voltage at R13 with 1/2 biasing	LCDREXT = 1, LCDEXTBIAS = 1, LCD2B = 1	V _{R03}	$V_{R03} + \frac{1}{2} \times (V_{R33} - V_{R03})$	V _{R33}	V
V _{R03}	Analog input voltage at R03	R0EXT = 1	V _{SS}			V
V _{LCD} -V _{R03}	Voltage difference between V _{LCD} and R03	LCDCPEN = 0, R0EXT = 1	2.4		V _{CC} +0.2	V
V _{LCDREF/R13}	External LCD reference voltage applied at LCDREF/R13	VLCDREFx = 01	0.8	1.2	1.5	V

8.36 LCD_B, Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
V _{LCD}	LCD voltage	VLCDx = 0000, VLCDEXT = 0	2.4 V to 3.6 V	V _{CC}		V
		LCDCPEN = 1, VLCDx = 0001	2 V to 3.6 V	2.60		
		LCDCPEN = 1, VLCDx = 0010	2 V to 3.6 V	2.66		
		LCDCPEN = 1, VLCDx = 0011	2 V to 3.6 V	2.72		
		LCDCPEN = 1, VLCDx = 0100	2 V to 3.6 V	2.79		
		LCDCPEN = 1, VLCDx = 0101	2 V to 3.6 V	2.85		
		LCDCPEN = 1, VLCDx = 0110	2 V to 3.6 V	2.92		
		LCDCPEN = 1, VLCDx = 0111	2 V to 3.6 V	2.98		
		LCDCPEN = 1, VLCDx = 1000	2 V to 3.6 V	3.05		
		LCDCPEN = 1, VLCDx = 1001	2 V to 3.6 V	3.10		
		LCDCPEN = 1, VLCDx = 1010	2 V to 3.6 V	3.17		
		LCDCPEN = 1, VLCDx = 1011	2 V to 3.6 V	3.24		
		LCDCPEN = 1, VLCDx = 1100	2 V to 3.6 V	3.30		
		LCDCPEN = 1, VLCDx = 1101	2.2 V to 3.6 V	3.36		
		LCDCPEN = 1, VLCDx = 1110	2.2 V to 3.6 V	3.42		
		LCDCPEN = 1, VLCDx = 1111	2.2 V to 3.6 V	3.48	3.6	
I _{CC,Peak,CP}	Peak supply currents due to charge pump activities	LCDCPEN = 1, VLCDx = 1111	2.2 V	400		μA
t _{LCD,CP,on}	Time to charge C _{LCD} when discharged	C _{LCD} = 4.7 μF, LCDCPEN = 0→1, VLCDx = 1111	2.2 V	100	500	ms
I _{CP,Load}	Maximum charge pump load current	LCDCPEN = 1, VLCDx = 1111	2.2 V	50		μA
R _{LCD,Seg}	LCD driver output impedance, segment lines	LCDCPEN = 1, VLCDx = 1000, I _{LOAD} = ±10 μA	2.2 V		10	kΩ
R _{LCD,COM}	LCD driver output impedance, common lines	LCDCPEN = 1, VLCDx = 1000, I _{LOAD} = ±10 μA	2.2 V		10	kΩ

8.37 12-Bit ADC, Power Supply and Input Range Conditions

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽²⁾

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
AV _{CC} Analog supply voltage	AV _{CC} and DV _{CC} are connected together, AV _{SS} and DV _{SS} are connected together, V _(AVSS) = V _(DVSS) = 0 V		2.2		3.6	V
V _(Ax) Analog input voltage range ⁽³⁾	All ADC12 analog input pins Ax		0		AV _{CC}	V
I _{ADC12_A} Operating supply current into AV _{CC} terminal ⁽⁴⁾	f _{ADC12CLK} = 5 MHz ⁽¹⁾	2.2 V		150	200	μA
		3 V		150	250	
C _I Input capacitance	Only one terminal Ax can be selected at one time	2.2 V		20	25	pF
R _I Input MUX ON resistance	0 V ≤ V _{IN} ≤ V _(AVCC)		10	200	1900	Ω

(1) ADC12ON = 1, REFON = 0, SHT0 = 0, SHT1 = 0, ADC12DIV = 0

(2) The leakage current is specified by the digital I/O input leakage.

(3) The analog input voltage range must be within the selected reference voltage range V_{R+} to V_{R-} for valid conversion results. If the reference voltage is supplied by an external source or if the internal voltage is used and REFOUT = 1, then decoupling capacitors are required. See [§ 8.43](#) and [§ 8.44](#).

(4) The internal reference supply current is not included in current consumption parameter I_{ADC12}.

8.38 12-Bit ADC, Timing Parameters

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
f _{ADC12CLK}	ADC conversion clock	For specified performance of ADC12 linearity parameters using an external reference voltage or AVCC as reference ⁽¹⁾	2.2 V, 3 V	0.45	4.8	5.0	MHz
		For specified performance of ADC12 linearity parameters using the internal reference ⁽²⁾		0.45	2.4	4.0	
		For specified performance of ADC12 linearity parameters using the internal reference ⁽³⁾		0.45	2.4	2.7	
f _{ADC12OSC}	Internal ADC12 oscillator ⁽⁵⁾	ADC12DIV = 0, f _{ADC12CLK} = f _{ADC12OSC}	2.2 V, 3 V	4.2	4.8	5.4	MHz
t _{CONVERT}	Conversion time	REFON = 0, Internal oscillator, ADC12OSC used for ADC conversion clock	2.2 V, 3 V	2.4		3.1	μs
		External f _{ADC12CLK} from ACLK, MCLK or SMCLK, ADC12SSEL ≠ 0		13 × 1 / f _{ADC12CLK}			
t _{Sample}	Sampling time	R _S = 400 Ω, R _I = 200 Ω, C _I = 20 pF, τ = (R _S + R _I) × C _I ⁽⁴⁾	2.2 V, 3 V	1000			ns

(1) REFOUT = 0, external reference voltage: SREF2 = 0, SREF1 = 1, SREF0 = 0. AV_{CC} as reference voltage: SREF2 = 0, SREF1 = 0, SREF0 = 0. The specified performance of the ADC12 linearity is ensured when using the ADC12OSC. For other clock sources, the specified performance of the ADC12 linearity is ensured with f_{ADC12CLK} maximum of 5 MHz.

(2) SREF2 = 0, SREF1 = 1, SREF0 = 0, ADC12SR = 0, REFOUT = 1

(3) SREF2 = 0, SREF1 = 1, SREF0 = 0, ADC12SR = 0, REFOUT = 0. The specified performance of the ADC12 linearity is ensured when using the ADC12OSC divided by 2.

(4) Approximately 10 Tau (τ) are needed to get an error of less than ±0.5 LSB:

t_{sample} = ln(2ⁿ⁺¹) × (R_S + R_I) × C_I + 800 ns, where n = ADC resolution = 12, R_S = external source resistance

(5) The ADC12OSC is sourced directly from MODOSC inside the UCS.

8.39 12-Bit ADC, Linearity Parameters Using an External Reference Voltage

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
E _I Integral linearity error ⁽²⁾	1.4 V ≤ dVREF ≤ 1.6 V ⁽¹⁾	2.2 V, 3 V			±2	LSB
	1.6 V < dVREF ⁽¹⁾				±1.7	
E _D Differential linearity error ⁽²⁾	See ⁽¹⁾	2.2 V, 3 V			±1	LSB
E _O Offset error ⁽³⁾	dVREF ≤ 2.2 V ⁽¹⁾	2.2 V, 3 V		±3	±5.6	LSB
	dVREF > 2.2 V ⁽¹⁾	2.2 V, 3 V		±1.5	±3.5	
E _G Gain error ⁽³⁾	See ⁽¹⁾	2.2 V, 3 V		±1	±2.5	LSB
E _T Total unadjusted error	dVREF ≤ 2.2 V ⁽¹⁾	2.2 V, 3 V		±3.5	±7.1	LSB
	dVREF > 2.2 V ⁽¹⁾	2.2 V, 3 V		±2	±5	

(1) The external reference voltage is selected by: SREF2 = 0 or 1, SREF1 = 1, SREF0 = 0. dVREF = V_{R+} - V_{R-}. V_{R+} < AVCC. V_{R-} > AVSS. Unless otherwise mentioned, dVREF > 1.5 V. Impedance of the external reference voltage R < 100 Ω, and two decoupling capacitors, 10 μF and 100 nF, should be connected to VREF+/VREF- to decouple the dynamic current. See also the [MSP430F5xx and MSP430F6xx Family User's Guide](#).

(2) Parameters are derived using the histogram method.

(3) Parameters are derived using a best fit curve.

8.40 12-Bit ADC, Linearity Parameters Using AVCC as Reference Voltage

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
E _I Integral linearity error ⁽²⁾	See ⁽¹⁾	2.2 V, 3 V			±1.7	LSB
E _D Differential linearity error ⁽²⁾	See ⁽¹⁾	2.2 V, 3 V			±1	LSB
E _O Offset error ⁽³⁾	See ⁽¹⁾	2.2 V, 3 V		±1	±2	LSB
E _G Gain error ⁽³⁾	See ⁽¹⁾	2.2 V, 3 V		±2	±4	LSB
E _T Total unadjusted error	See ⁽¹⁾	2.2 V, 3 V		±2	±5	LSB

(1) AVCC as reference voltage is selected by: SREF2 = 0, SREF1 = 0, SREF0 = 0.

(2) Parameters are derived using the histogram method.

(3) Parameters are derived using a best fit curve.

8.41 12-Bit ADC, Linearity Parameters Using the Internal Reference Voltage

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS ⁽¹⁾		V _{CC}	MIN	TYP	MAX	UNIT
E _I Integral linearity error ⁽²⁾	ADC12SR = 0, REFOUT = 1	f _{ADC12CLK} ≤ 4.0 MHz	2.2 V, 3 V			±1.7	LSB
	ADC12SR = 0, REFOUT = 0	f _{ADC12CLK} ≤ 2.7 MHz				±2.5	
E _D Differential linearity error ⁽²⁾	ADC12SR = 0, REFOUT = 1	f _{ADC12CLK} ≤ 4.0 MHz	2.2 V, 3 V	- 1		+1.5	LSB
	ADC12SR = 0, REFOUT = 1	f _{ADC12CLK} ≤ 2.7 MHz				±1	
	ADC12SR = 0, REFOUT = 0	f _{ADC12CLK} ≤ 2.7 MHz		- 1		+2.5	
E _O Offset error ⁽³⁾	ADC12SR = 0, REFOUT = 1	f _{ADC12CLK} ≤ 4.0 MHz	2.2 V, 3 V		±2	±4	LSB
	ADC12SR = 0, REFOUT = 0	f _{ADC12CLK} ≤ 2.7 MHz			±2	±4	
E _G Gain error ⁽³⁾	ADC12SR = 0, REFOUT = 1	f _{ADC12CLK} ≤ 4.0 MHz	2.2 V, 3 V		±1	±2.5	LSB
	ADC12SR = 0, REFOUT = 0	f _{ADC12CLK} ≤ 2.7 MHz				±1% ⁽⁴⁾	VREF
E _T Total unadjusted error	ADC12SR = 0, REFOUT = 1	f _{ADC12CLK} ≤ 4.0 MHz	2.2 V, 3 V		±2	±5	LSB
	ADC12SR = 0, REFOUT = 0	f _{ADC12CLK} ≤ 2.7 MHz				±1% ⁽⁴⁾	VREF

(1) The external reference voltage is selected by: SREF2 = 0, SREF1 = 0, SREF0 = 1. dVREF = V_{R+} - V_{R-}.

(2) Parameters are derived using the histogram method.

(3) Parameters are derived using a best fit curve.

(4) The gain error and the total unadjusted error are dominated by the accuracy of the integrated reference module absolute accuracy. In this mode the reference voltage used by the ADC12_A is not available on a pin.

8.42 12-Bit ADC, Temperature Sensor and Built-In V_{MID}

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

PARAMETER	TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
V_{SENSOR} Temperature sensor voltage ⁽²⁾ (see)图 8-16	ADC12ON = 1, INCH = 0Ah, $T_A = 0^\circ\text{C}$	2.2 V		680		mV
		3 V		680		
TC_{SENSOR} Temperature coefficient of sensor ⁽²⁾	ADC12ON = 1, INCH = 0Ah	2.2 V		2.25		mV/ $^\circ\text{C}$
		3 V		2.25		
$t_{SENSOR(sample)}$ Sample time required if channel 10 is selected ⁽³⁾	ADC12ON = 1, INCH = 0Ah, Error of conversion result ≤ 1 LSB	2.2 V	100			μs
		3 V	100			
V_{MID} AV_{CC} divider at channel 11	ADC12ON = 1, INCH = 0Bh, $V_{MID} \approx 0.5 \times V_{AVCC}$	2.2 V	1.06	1.1	1.14	V
		3 V	1.46	1.5	1.54	
$t_{VMID(sample)}$ Sample time required if channel 11 is selected ⁽⁴⁾	ADC12ON = 1, INCH = 0Bh, Error of conversion result ≤ 1 LSB	2.2 V, 3 V	1000			ns

- (1) The temperature sensor is provided by the REF module. See the REF module parametric, I_{REF+} , regarding the current consumption of the temperature sensor.
- (2) The temperature sensor offset can be significant. TI recommends a single-point calibration to minimize the offset error of the built-in temperature sensor. The TLV structure contains calibration values for $30^\circ\text{C} \pm 3^\circ\text{C}$ and $85^\circ\text{C} \pm 3^\circ\text{C}$ for each of the available reference voltage levels. The sensor voltage can be computed as $V_{SENSE} = TC_{SENSOR} \times (\text{Temperature}, ^\circ\text{C}) + V_{SENSOR}$, where TC_{SENSOR} and V_{SENSOR} can be computed from the calibration values for higher accuracy. See also the [MSP430F5xx and MSP430F6xx Family User's Guide](#).
- (3) The typical equivalent impedance of the sensor is 51 k Ω . The sample time required includes the sensor-on time $t_{SENSOR(on)}$.
- (4) The on-time $t_{VMID(on)}$ is included in the sampling time $t_{VMID(sample)}$; no additional on time is needed.

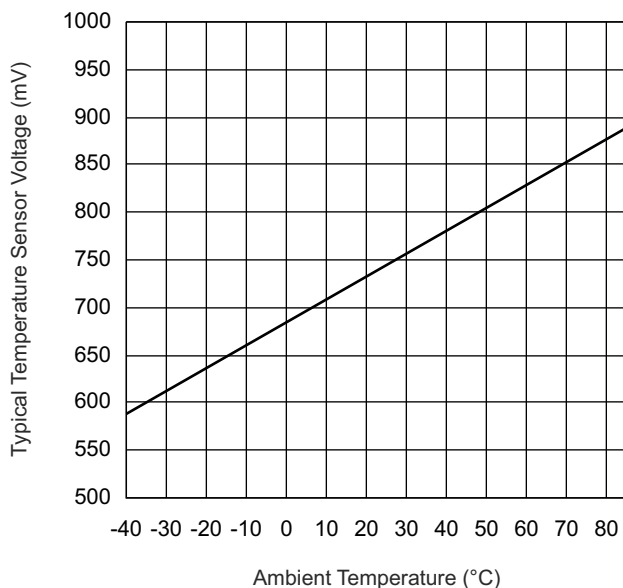


图 8-16. Typical Temperature Sensor Voltage

8.43 REF, External Reference

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	MAX	UNIT
V _{eREF+}	Positive external reference voltage input	V _{eREF+} > V _{REF-/V_{eREF-}} ⁽²⁾		1.4	AV _{CC}	V
V _{REF-/V_{eREF-}}	Negative external reference voltage input	V _{eREF+} > V _{REF-/V_{eREF-}} ⁽³⁾		0	1.2	V
V _{eREF+} - V _{REF-/V_{eREF-}}	Differential external reference voltage input	V _{eREF+} > V _{REF-/V_{eREF-}} ⁽⁴⁾		1.4	AV _{CC}	V
I _{VeREF+} , I _{VeREF-/V_{eREF-}}	Static input current	1.4 V ≤ V _{eREF+} ≤ V _{AVCC} , V _{eREF-} = 0 V, f _{ADC12CLK} = 5 MHz, ADC12SHTx = 1h, Conversion rate 200 ksps	2.2 V, 3 V	- 26	26	μA
		1.4 V ≤ V _{eREF+} ≤ V _{AVCC} , V _{eREF-} = 0 V, f _{ADC12CLK} = 5 MHz, ADC12SHTx = 8h, Conversion rate 20 ksps	2.2 V, 3 V	- 1.2	+1.2	
C _{VREF+/-}	Capacitance at VREF+ or VREF- terminal ⁽⁵⁾			10		μF

- (1) The external reference is used during ADC conversion to charge and discharge the capacitance array. The input capacitance, C_i, is also the dynamic load for an external reference during conversion. The dynamic impedance of the reference supply should follow the recommendations on analog-source impedance to let the charge settle for 12-bit accuracy.
- (2) The accuracy limits the minimum positive external reference voltage. Lower reference voltage levels may be applied with reduced accuracy requirements.
- (3) The accuracy limits the maximum negative external reference voltage. Higher reference voltage levels may be applied with reduced accuracy requirements.
- (4) The accuracy limits minimum external differential reference voltage. Lower differential reference voltage levels may be applied with reduced accuracy requirements.
- (5) Connect two decoupling capacitors, 10 μF and 100 nF, to VREF to decouple the dynamic current required for an external reference source if it is used for the ADC12_A. Also see the [MSP430F5xx and MSP430F6xx Family User's Guide](#).

8.44 REF, Built-In Reference

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
V _{REF+}	REFVSEL = {2} for 2.5 V, REFON = REFOUT = 1, I _{VREF+} = 0 A	3 V		2.5	±1%	V
	REFVSEL = {1} for 2 V, REFON = REFOUT = 1, I _{VREF+} = 0 A	3 V		2.0	±1%	
	REFVSEL = {0} for 1.5 V, REFON = REFOUT = 1, I _{VREF+} = 0 A	2.2 V, 3 V		1.5	±1%	
AV _{CC(min)}	REFVSEL = {0} for 1.5 V			2.2		V
	REFVSEL = {1} for 2 V			2.3		
	REFVSEL = {2} for 2.5 V			2.8		
I _{REF+}	ADC12SR = 1 ⁽⁸⁾ , REFON = 1, REFOUT = 0, REFBURST = 0	3 V		70	100	μA
	ADC12SR = 1 ⁽⁸⁾ , REFON = 1, REFOUT = 1, REFBURST = 0			0.45	0.75	mA
	ADC12SR = 0 ⁽⁸⁾ , REFON = 1, REFOUT = 0, REFBURST = 0			210	310	μA
	ADC12SR = 0 ⁽⁸⁾ , REFON = 1, REFOUT = 1, REFBURST = 0			0.95	1.7	mA
I _{L(VREF+)}	REFVSEL = {0, 1, 2}, I _{VREF+} = +10 μA, - 1000 μA, AV _{CC} = AV _{CC(min)} for each reference level, REFVSEL = {0, 1, 2}, REFON = REFOUT = 1			1500	2500	μV/mA
C _{VREF+}	REFON = REFOUT = 1 ⁽⁶⁾ , 0 mA ≤ I _{VREF+} ≤ I _{VREF+(max)}	2.2 V, 3 V	20		100	pF
TC _{REF+}	I _{VREF+} is a constant in the range of 0 mA ≤ I _{VREF+} ≤ - 1 mA	REFOUT = 0	2.2 V, 3 V	20		ppm/ °C
TC _{REF+}	I _{VREF+} is a constant in the range of 0 mA ≤ I _{VREF+} ≤ - 1 mA	REFOUT = 1	2.2 V, 3 V	20	50	ppm/ °C
PSRR _{DC}	Power supply rejection ratio (DC)	AV _{CC} = AV _{CC(min)} to AV _{CC(max)} , T _A = 25°C, REFVSEL = {0, 1, 2}, REFON = 1, REFOUT = 0 or 1		120	300	μV/V
PSRR _{AC}	Power supply rejection ratio (AC)	AV _{CC} = AV _{CC(min)} to AV _{CC(max)} , T _A = 25°C, REFVSEL = {0, 1, 2}, REFON = 1, REFOUT = 0 or 1		1		mV/V
t _{SETTLE}	AV _{CC} = AV _{CC(min)} to AV _{CC(max)} , REFVSEL = {0, 1, 2}, REFOUT = 0, REFON = 0 → 1			75		μs
	AV _{CC} = AV _{CC(min)} to AV _{CC(max)} , C _{VREF} = C _{VREF(max)} , REFVSEL = {0, 1, 2}, REFOUT = 1, REFON = 0 → 1			75		

- (1) The reference is supplied to the ADC by the REF module and is buffered locally inside the ADC. The ADC uses two internal buffers, one smaller and one larger for driving the V_{REF+} terminal. When REFOUT = 1, the reference is available at the V_{REF+} terminal, as well as, used as the reference for the conversion and uses the larger buffer. When REFOUT = 0, the reference is only used as the reference for the conversion and uses the smaller buffer.
- (2) The internal reference current is supplied by the AV_{CC} terminal. Consumption is independent of the ADC12ON control bit, unless a conversion is active. REFOUT = 0 represents the current contribution of the smaller buffer. REFOUT = 1 represents the current contribution of the larger buffer without external load.
- (3) Contribution only due to the reference and buffer including package. This does not include resistance due to PCB traces or other external factors.
- (4) Calculated using the box method: (MAX(- 40°C to +85°C) - MIN(- 40°C to +85°C)) / MIN(- 40°C to +85°C)/(85°C - (- 40°C)).
- (5) The condition is that the error in a conversion started after t_{REFON} is less than ±0.5 LSB. The settling time depends on the external capacitive load when REFOUT = 1.
- (6) Connect two decoupling capacitors, 10 μF and 100 nF, to VREF to decouple the dynamic current required for an external reference source if it is used for the ADC12_A. Also see the [MSP430F5xx and MSP430F6xx Family User's Guide](#).

- (7) The temperature sensor is provided by the REF module. Its current is supplied by terminal AVCC and is equivalent to I_{REF+} with $REFON = 1$ and $REFOUT = 0$.
- (8) For devices without the ADC12, the parametric with $ADC12SR = 0$ are applicable.

8.45 12-Bit DAC, Supply Specifications

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
AV _{CC}	Analog supply voltage	AV _{CC} = DV _{CC} , AV _{SS} = DV _{SS} = 0 V		2.20		3.60	V
I _{DD}	Supply current, single DAC channel ^{(1) (2)}	DAC12AMPx = 2, DAC12IR = 0, DAC12OG = 1, DAC12_xDAT = 0800h, VeREF+ = VREF+ = 1.5 V	3 V		65	110	μA
		DAC12AMPx = 2, DAC12IR = 1, DAC12_xDAT = 0800h, VeREF+ = VREF+ = AV _{CC}	2.2 V, 3 V		125	165	
		DAC12AMPx = 5, DAC12IR = 1, DAC12_xDAT = 0800h, VeREF+ = VREF+ = AV _{CC}			250	350	
		DAC12AMPx = 7, DAC12IR = 1, DAC12_xDAT = 0800h, VeREF+ = VREF+ = AV _{CC}			750	1100	
PSRR	Power supply rejection ratio ^{(3) (4)}	DAC12_xDAT = 800h, VeREF+ = 1.5 V, ΔAV _{CC} = 100 mV	2.2 V		70		dB
		DAC12_xDAT = 800h, VeREF+ = 1.5 V or 2.5 V, ΔAV _{CC} = 100 mV	3 V		70		

- (1) No load at the output pin, DAC12_0 or DAC12_1, assuming that the control bits for the shared pins are set properly.
- (2) Current into reference terminals not included. If DAC12IR = 1 current flows through the input divider; see Reference Input specifications.
- (3) $PSRR = 20 \log (\Delta AV_{CC} / \Delta V_{DAC12_xOUT})$
- (4) The internal reference is not used.

8.46 12-Bit DAC, Linearity Specifications

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see 图 8-17)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
Resolution	12-bit monotonic		12			bits
INL	Integral nonlinearity ⁽²⁾	VeREF+ = 1.5 V, DAC12AMPx = 7, DAC12IR = 1	2.2 V	±2	±4 ⁽¹⁾	LSB
		VeREF+ = 2.5 V, DAC12AMPx = 7, DAC12IR = 1	3 V	±2	±4	
DNL	Differential nonlinearity ⁽²⁾	VeREF+ = 1.5 V, DAC12AMPx = 7, DAC12IR = 1	2.2 V	±0.4	±1 ⁽¹⁾	LSB
		VeREF+ = 2.5 V, DAC12AMPx = 7, DAC12IR = 1	3 V	±0.4	±1	
E _O	Offset voltage	Without calibration ^{(2) (3)}	VeREF+ = 1.5 V, DAC12AMPx = 7, DAC12IR = 1	2.2 V	±21 ⁽¹⁾	mV
			VeREF+ = 2.5 V, DAC12AMPx = 7, DAC12IR = 1	3 V	±21	
	With calibration ^{(2) (3)}	VeREF+ = 1.5 V, DAC12AMPx = 7, DAC12IR = 1	2.2 V	±1.5 ⁽¹⁾		
		VeREF+ = 2.5 V, DAC12AMPx = 7, DAC12IR = 1	3 V	±1.5		
d _{E(O)} /d _T	Offset error temperature coefficient ⁽²⁾	With calibration	2.2 V, 3 V	±10		µV/°C
E _G	Gain error	VeREF+ = 1.5 V	2.2 V		±2.5	%FSR
		VeREF+ = 2.5 V	3 V		±2.5	
d _{E(G)} /d _T	Gain temperature coefficient ⁽²⁾		2.2 V, 3 V	10		ppm of FSR/°C
t _{Offset_Cal}	Time for offset calibration ⁽⁴⁾	DAC12AMPx = 2	2.2 V, 3 V		165	ms
		DAC12AMPx = 3, 5			66	
		DAC12AMPx = 4, 6, 7			16.5	

- (1) This parameter is not production tested.
 (2) Parameters calculated from the best-fit curve from 0x0F to 0xFFF. The best-fit curve method is used to deliver coefficients "a" and "b" of the first-order equation: $y = a + bx$. $V_{DAC12_xOUT} = E_O + (1 + E_G) \times (V_{eREF+} / 4095) \times DAC12_xDAT$, DAC12IR = 1.
 (3) The offset calibration works on the output operational amplifier. Offset calibration is triggered by setting the DAC12CALON bit.
 (4) The offset calibration can be done if DAC12AMPx = {2, 3, 4, 5, 6, 7}. The output operational amplifier is switched off with DAC12AMPx = {0, 1}. TI recommends configuring the DAC12 module before initiating calibration. Port activity during calibration may effect accuracy and is not recommended.

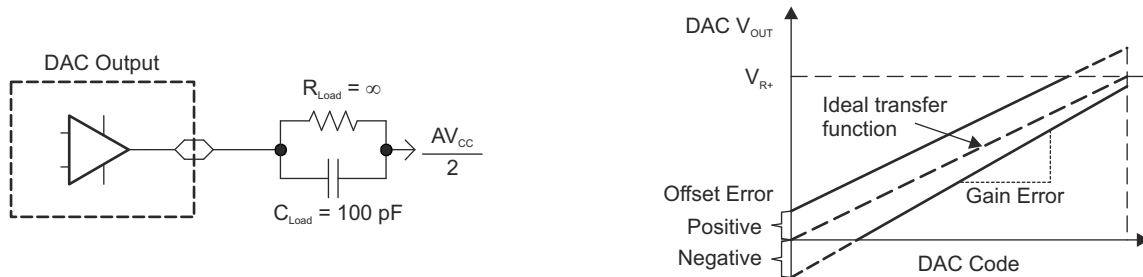


图 8-17. Linearity Test Load Conditions and Gain and Offset Definitions

8.47 12-Bit DAC, Output Specifications

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
V _O	No load, V _{REF+} = AV _{CC} , DAC12_xDAT = 0h, DAC12IR = 1, DAC12AMPx = 7	2.2 V, 3 V	0		0.005	V
	No load, V _{REF+} = AV _{CC} , DAC12_xDAT = 0FFFh, DAC12IR = 1, DAC12AMPx = 7		AV _{CC} - 0.05		AV _{CC}	
	R _{Load} = 3 kΩ, V _{REF+} = AV _{CC} , DAC12_xDAT = 0h, DAC12IR = 1, DAC12AMPx = 7		0		0.1	
	R _{Load} = 3 kΩ, V _{REF+} = AV _{CC} , DAC12_xDAT = 0FFFh, DAC12IR = 1, DAC12AMPx = 7		AV _{CC} - 0.13		AV _{CC}	
C _{L(DAC12)}	Maximum DAC12 load capacitance	2.2 V, 3 V			100	pF
I _{L(DAC12)}	DAC12AMPx = 2, DAC12_xDAT = 0FFFh, V _{O/P(DAC12)} > AV _{CC} - 0.3	2.2 V, 3 V	-1			mA
	DAC12AMPx = 2, DAC12_xDAT = 0h, V _{O/P(DAC12)} < 0.3 V				1	
R _{O/P(DAC12)}	R _{Load} = 3 kΩ, V _{O/P(DAC12)} < 0.3 V, DAC12AMPx = 2, DAC12_xDAT = 0h	2.2 V, 3 V		150	250	Ω
	R _{Load} = 3 kΩ, V _{O/P(DAC12)} > AV _{CC} - 0.3 V, DAC12_xDAT = 0FFFh			150	250	
	R _{Load} = 3 kΩ, 0.3 V ≤ V _{O/P(DAC12)} ≤ AV _{CC} - 0.3 V				6	

(1) Data is valid after the offset calibration of the output amplifier.

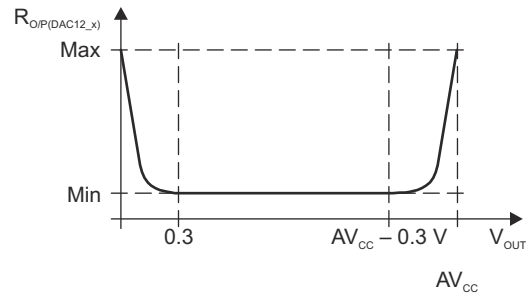
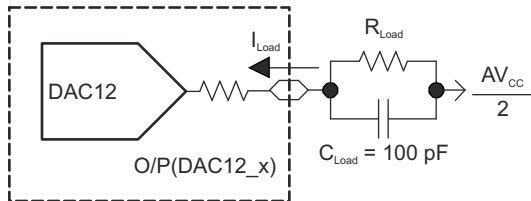


图 8-18. DAC12_x Output Resistance Tests

8.48 12-Bit DAC, Reference Input Specifications

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
V _{REF+} Reference input voltage range	DAC12IR = 0 ^{(1) (2)}	2.2 V, 3 V	$\frac{AV_{CC}}{3}$		$AV_{CC} + 0.2$	V
	DAC12IR = 1 ^{(3) (4)}		AV_{CC}		$AV_{CC} + 0.2$	
R _{i(VREF+)} , R _{i(VREF-)} Reference input resistance	DAC12_0 IR = DAC12_1 IR = 0	2.2 V, 3 V	20			MΩ
	DAC12_0 IR = 1, DAC12_1 IR = 0		48			kΩ
	DAC12_0 IR = 0, DAC12_1 IR = 1		48			
	DAC12_0 IR = DAC12_1 IR = 1, DAC12_0 SREFx = DAC12_1 SREFx ⁽⁵⁾		24			

(1) For a full-scale output, the reference input voltage can be as high as 1/3 of the maximum output voltage swing (AV_{CC}).

(2) The maximum voltage applied at reference input voltage terminal V_{REF+} = $(AV_{CC} - V_{E(O)}) / (3 \times (1 + E_G))$.

(3) For a full-scale output, the reference input voltage can be as high as the maximum output voltage swing (AV_{CC}).

(4) The maximum voltage applied at reference input voltage terminal V_{REF+} = $(AV_{CC} - V_{E(O)}) / (1 + E_G)$.

(5) When DAC12IR = 1 and DAC12SREFx = 0 or 1 for both channels, the reference input resistive dividers for each DAC are in parallel reducing the reference input resistance.

8.49 12-Bit DAC, Dynamic Specifications

V_{REF} = V_{CC}, DAC12IR = 1 (see 图 8-19 and 图 8-20), over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
t _{ON} DAC12 on time	DAC12_xDAT = 800h, Error _{V(O)} < ±0.5 LSB ⁽¹⁾ (see 图 8-19)	2.2 V, 3 V	60		120	μs
			15		30	
			6		12	
t _{S(FS)} Settling time, full scale	DAC12_xDAT = 80h → F7Fh → 80h	2.2 V, 3 V	100		200	μs
			40		80	
			15		30	
t _{S(C-C)} Settling time, code to code	DAC12_xDAT = 3F8h → 408h → 3F8h, BF8h → C08h → BF8h	2.2 V, 3 V	5			μs
			2			
			1			
SR Slew rate	DAC12_xDAT = 80h → F7Fh → 80h ⁽²⁾	2.2 V, 3 V	0.05	0.35		V/μs
			0.35	1.10		
			1.50	5.20		
Glitch energy	DAC12_xDAT = 800h → 7FFh → 800h	2.2 V, 3 V	35			nV-s

(1) R_{Load} and C_{Load} connected to AV_{SS} (not AV_{CC}/2) in 图 8-19.

(2) Slew rate applies to output voltage steps ≥ 200 mV.

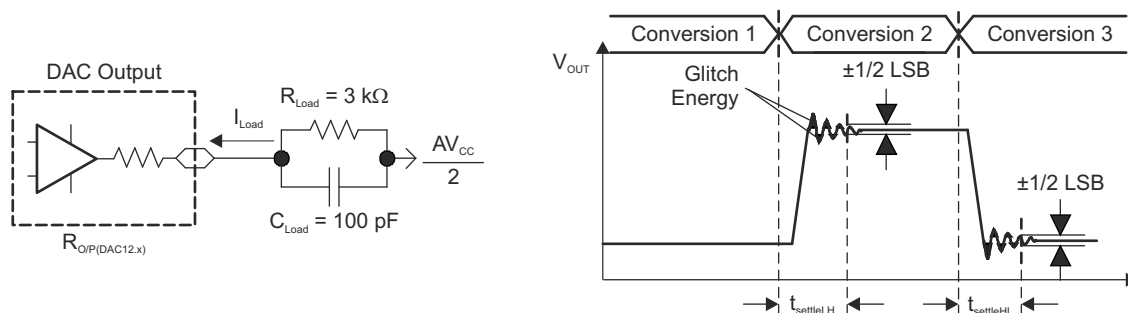


图 8-19. Settling Time and Glitch Energy Testing

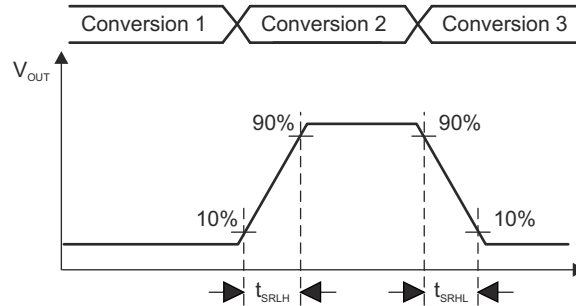


图 8-20. Slew Rate Testing

8.50 12-Bit DAC, Dynamic Specifications (Continued)

over recommended ranges of supply voltage and $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V_{CC}	MIN	TYP	MAX	UNIT
BW - 3dB 3-dB bandwidth, $V_{DC} = 1.5\text{ V}$, $V_{AC} = 0.1\text{ V}_{PP}$ (see 图 8-21)	DAC12AMPx = {2, 3, 4}, DAC12SREFx = 2, DAC12IR = 1, DAC12_xDAT = 800h	2.2 V, 3 V	40			kHz
	DAC12AMPx = {5, 6}, DAC12SREFx = 2, DAC12IR = 1, DAC12_xDAT = 800h		180			
	DAC12AMPx = 7, DAC12SREFx = 2, DAC12IR = 1, DAC12_xDAT = 800h		550			
Channel-to-channel crosstalk ⁽¹⁾ (see 图 8-22)	DAC12_0DAT = 800h, No load, DAC12_1DAT = 80h $\leftrightarrow$ F7Fh, $R_{Load} = 3\text{ k}\Omega$, $f_{DAC12_1OUT} = 10\text{ kHz}$ at 50/50 duty cycle	2.2 V, 3 V		- 80		dB
	DAC12_0DAT = 80h $\leftrightarrow$ F7Fh, $R_{Load} = 3\text{ k}\Omega$, DAC12_1DAT = 800h, No load, $f_{DAC12_0OUT} = 10\text{ kHz}$ at 50/50 duty cycle			- 80		

(1) $R_{Load} = 3\text{ k}\Omega$, $C_{Load} = 100\text{ pF}$

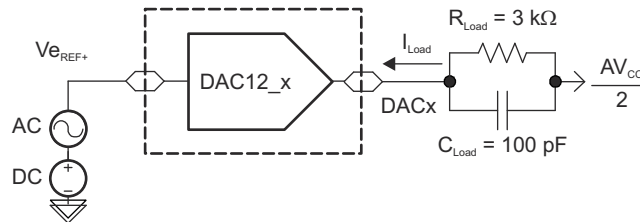


图 8-21. Test Conditions for 3-dB Bandwidth Specification

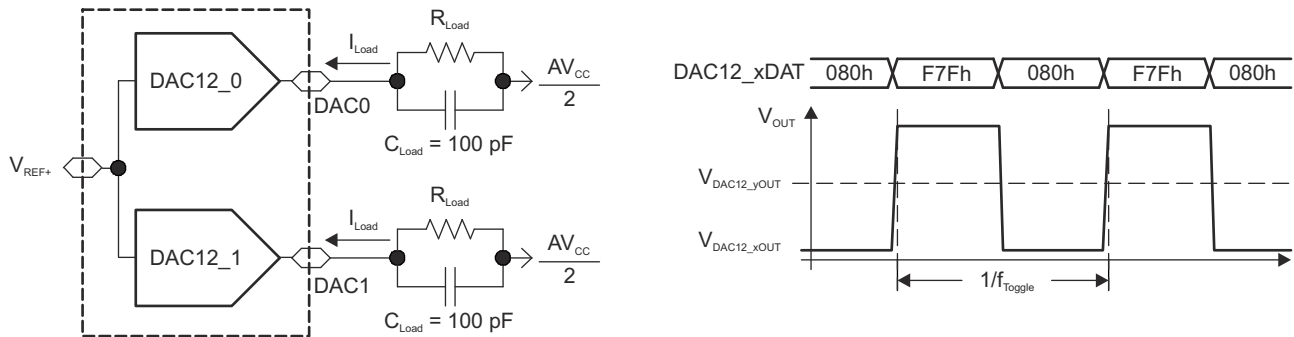


图 8-22. Crosstalk Test Conditions

8.51 Comparator_B

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	V _{CC}	MIN	TYP	MAX	UNIT
V _{CC}	Supply voltage			1.8		3.6	V
I _{AVCC_COMP}	Comparator operating supply current into AVCC terminal, excludes reference resistor ladder	CBPWRMD = 00	1.8 V			40	μA
			2.2 V		30	50	
			3 V		40	65	
		CBPWRMD = 01	2.2 V, 3 V		10	30	
		CBPWRMD = 10	2.2 V, 3 V		0.1	0.5	
I _{AVCC_REF}	Quiescent current of local reference voltage amplifier into AVCC terminal	CBREFACC = 1, CBREFLx = 01				22	μA
V _{IC}	Common-mode input range			0	V _{CC} – 1		V
V _{OFFSET}	Input offset voltage	CBPWRMD = 00				±20	mV
		CBPWRMD = 01, 10				±10	
C _{IN}	Input capacitance				5		pF
R _{SIN}	Series input resistance	On (switch closed)			3	4	kΩ
		Off (switch open)		50			MΩ
t _{PD}	Propagation delay, response time	CBPWRMD = 00, CBF = 0				450	ns
		CBPWRMD = 01, CBF = 0				600	
		CBPWRMD = 10, CBF = 0				50	μs
t _{PD,filter}	Propagation delay with filter active	CBPWRMD = 00, CBON = 1, CBF = 1, CBF _{DLY} = 00		0.35	0.6	1.0	μs
		CBPWRMD = 00, CBON = 1, CBF = 1, CBF _{DLY} = 01		0.6	1.0	1.8	
		CBPWRMD = 00, CBON = 1, CBF = 1, CBF _{DLY} = 10		1.0	1.8	3.4	
		CBPWRMD = 00, CBON = 1, CBF = 1, CBF _{DLY} = 11		1.8	3.4	6.5	
t _{EN_CMP}	Comparator enable time, settling time	CBON = 0 to CBON = 1, CBPWRMD = 00, 01			1	2	μs
		CBON = 0 to CBON = 1, CBPWRMD = 10				100	
t _{EN_REF}	Resistor reference enable time	CBON = 0 to CBON = 1			0.3	1.5	μs
V _{CB_REF}	Reference voltage for a given tap	V _{IN} = reference into resistor ladder, n = 0 to 31		$\frac{V_{IN} \times (n + 0.5)}{32}$	$\frac{V_{IN} \times (n + 1)}{32}$	$\frac{V_{IN} \times (n + 1.5)}{32}$	V

8.52 Ports PU.0 and PU.1

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	MAX	UNIT
V _{OH}	High-level output voltage	V _{USB} = 3.3 V ±10%, I _{OH} = - 25 mA	2.4		V
V _{OL}	Low-level output voltage	V _{USB} = 3.3 V ±10%, I _{OL} = 25 mA		0.4	V
V _{IH}	High-level input voltage	V _{USB} = 3.3 V ±10%	2.0		V
V _{IL}	Low-level input voltage	V _{USB} = 3.3 V ±10%		0.8	V

8.53 USB Output Ports DP and DM

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	MAX	UNIT
V _{OH}	D+, D - single ended	USB 2.0 load conditions	2.8	3.6	V
V _{OL}	D+, D - single ended	USB 2.0 load conditions	0	0.3	V
Z _(DRV)	D+, D - impedance	Including external series resistor of 27 Ω	28	44	Ω
t _{RISE}	Rise time	Full speed, differential, C _L = 50 pF, 10%/90%, Rpu on D+	4	20	ns
t _{FALL}	Fall time	Full speed, differential, C _L = 50 pF, 10%/90%, Rpu on D+	4	20	ns

8.54 USB Input Ports DP and DM

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		MIN	MAX	UNIT
V _(CM)	Differential input common-mode range	0.8	2.5	V
Z _(IN)	Input impedance	300		kΩ
V _{CRS}	Crossover voltage	1.3	2.0	V
V _{IL}	Static SE input logic low level		0.8	V
V _{IH}	Static SE input logic high level	2.0		V
VDI	Differential input voltage		0.2	V

8.55 USB-PWR (USB Power System)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{LAUNCH}	V _{BUS} detection threshold				3.75	V
V _{BUS}	USB bus voltage	Normal operation	3.76		5.5	V
V _{USB}	USB LDO output voltage			3.3	±9%	V
V ₁₈	Internal USB voltage ⁽¹⁾			1.8		V
I _{USB_EXT}	Maximum external current from VUSB terminal ⁽²⁾	USB LDO is on			12	mA
I _{DET}	USB LDO current overload detection ⁽³⁾		60		100	mA
I _{SUSPEND}	Operating supply current into VBUS terminal. ⁽⁴⁾	USB LDO is on, USB PLL disabled			250	µA
C _{BUS}	VBUS terminal recommended capacitance			4.7		µF
C _{USB}	VUSB terminal recommended capacitance			220		nF
C ₁₈	V18 terminal recommended capacitance			220		nF
t _{ENABLE}	Settling time V _{USB} and V ₁₈	Within 2%, recommended capacitances			2	ms
R _{PUR}	Pullup resistance of PUR terminal ⁽⁵⁾		70	110	150	Ω

(1) This voltage is for internal use only. No external DC loading should be applied.

(2) This represents additional current that can be supplied to the application from the VUSB terminal beyond the needs of the USB operation.

(3) A current overload is detected when the total current supplied from the USB LDO, including I_{USB_EXT}, exceeds this value.

(4) Does not include current contribution of R_{pu} and R_{pd} as outlined in the USB specification.

(5) This value, in series with an external resistor between PUR and D+, produces the R_{pu} as outlined in the USB specification.

8.56 USB-PLL (USB Phase-Locked Loop)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		MIN	TYP	MAX	UNIT
I _{PLL}	Operating supply current			7	mA
f _{PLL}	PLL frequency		48		MHz
f _{UPD}	PLL reference frequency	1.5		3	MHz
t _{LOCK}	PLL lock time			2	ms
t _{Jitter}	PLL jitter		1000		ps

8.57 Flash Memory

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		T _J	MIN	TYP	MAX	UNIT
DV _{CC(PGM/ERASE)}	Program and erase supply voltage		1.8		3.6	V
I _{PGM}	Average supply current from DVCC during program			3	5	mA
I _{ERASE}	Average supply current from DVCC during erase			6	15	mA
I _{MERASE} , I _{BANK}	Average supply current from DVCC during mass erase or bank erase			6	15	mA
t _{CPT}	Cumulative program time ⁽¹⁾				16	ms
	Program and erase endurance		10 ⁴	10 ⁵		cycles
t _{Retention}	Data retention duration	25°C	100			years
t _{Word}	Word or byte program time ⁽²⁾		64		85	μs
t _{Block, 0}	Block program time for first byte or word ⁽²⁾		49		65	μs
t _{Block, 1 - (N - 1)}	Block program time for each additional byte or word, except for last byte or word ⁽²⁾		37		49	μs
t _{Block, N}	Block program time for last byte or word ⁽²⁾		55		73	μs
t _{Seg Erase}	Erase time for segment, mass erase, and bank erase when available ⁽²⁾		23		32	ms
f _{MCLK,MGR}	MCLK frequency in marginal read mode (FCTL4.MGR0 = 1 or FCTL4.MGR1 = 1)		0		1	MHz

- (1) The cumulative program time must not be exceeded when writing to a 128-byte flash block. This parameter applies to all programming methods: individual word or byte write and block write modes.
- (2) These values are hardwired into the state machine of the flash controller.

8.58 JTAG and Spy-Bi-Wire Interface

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{SBW}	Spy-Bi-Wire input frequency	2.2 V, 3 V	0		20	MHz
t _{SBW,Low}	Spy-Bi-Wire low clock pulse duration	2.2 V, 3 V	0.025		15	μs
t _{SBW,En}	Spy-Bi-Wire enable time (TEST high to acceptance of first clock edge) ⁽¹⁾	2.2 V, 3 V			1	μs
t _{SBW,Rst}	Spy-Bi-Wire return to normal operation time		15		100	μs
f _{TCK}	TCK input frequency (4-wire JTAG) ⁽²⁾	2.2 V	0		5	MHz
		3 V	0		10	MHz
R _{internal}	Internal pulldown resistance on TEST	2.2 V, 3 V	45	60	80	kΩ

- (1) Tools that access the Spy-Bi-Wire interface must wait for the t_{SBW,En} time after pulling the TEST/SBWTCK pin high before applying the first SBWTCK clock edge.
- (2) f_{TCK} may be restricted to meet the timing requirements of the module selected.

9 Detailed Description

9.1 Overview

The MSP430F663x devices include a high-performance 12-bit ADC, comparator, two USCIs, USB 2.0, a hardware multiplier, DMA, four 16-bit timers, an RTC module with alarm capabilities, an LCD driver, and up to 74 I/O pins.

9.2 CPU

The MSP430 CPU has a 16-bit RISC architecture that is highly transparent to the application. All operations, other than program-flow instructions, are performed as register operations in conjunction with seven addressing modes for source operand and four addressing modes for destination operand.

The CPU is integrated with 16 registers that provide reduced instruction execution time. The register-to-register operation execution time is one cycle of the CPU clock.

Four of the registers, R0 to R3, are dedicated as program counter, stack pointer, status register, and constant generator, respectively. The remaining registers are general-purpose registers (see [Figure 9-1](#)).

Peripherals are connected to the CPU using data, address, and control buses. Peripherals can be managed with all instructions.

Program Counter	PC/R0
Stack Pointer	SP/R1
Status Register	SR/CG1/R2
Constant Generator	CG2/R3
General-Purpose Register	R4
General-Purpose Register	R5
General-Purpose Register	R6
General-Purpose Register	R7
General-Purpose Register	R8
General-Purpose Register	R9
General-Purpose Register	R10
General-Purpose Register	R11
General-Purpose Register	R12
General-Purpose Register	R13
General-Purpose Register	R14
General-Purpose Register	R15

图 9-1. Integrated CPU Registers

9.3 Instruction Set

The instruction set consists of the original 51 instructions with three formats and seven address modes and additional instructions for the expanded address range. Each instruction can operate on word and byte data. 表 9-1 lists examples of the three types of instruction formats; 表 9-2 lists the address modes.

表 9-1. Instruction Word Formats

INSTRUCTION WORD FORMAT	EXAMPLE	OPERATION
Dual operands, source-destination	ADD R4,R5	$R4 + R5 \rightarrow R5$
Single operands, destination only	CALL R8	$PC \rightarrow (TOS), R8 \rightarrow PC$
Relative jump, un/conditional	JNE	Jump-on-equal bit = 0

表 9-2. Address Mode Descriptions

ADDRESS MODE	S ⁽¹⁾	D ⁽¹⁾	SYNTAX	EXAMPLE	OPERATION
Register	+	+	MOV Rs,Rd	MOV R10,R11	$R10 \rightarrow R11$
Indexed	+	+	MOV X(Rn),Y(Rm)	MOV 2(R5),6(R6)	$M(2+R5) \rightarrow M(6+R6)$
Symbolic (PC relative)	+	+	MOV EDE,TONI		$M(EDE) \rightarrow M(TONI)$
Absolute	+	+	MOV &MEM, &TCDAT		$M(MEM) \rightarrow M(TCDAT)$
Indirect	+		MOV @Rn,Y(Rm)	MOV @R10,Tab(R6)	$M(R10) \rightarrow M(Tab+R6)$
Indirect auto-increment	+		MOV @Rn+,Rm	MOV @R10+,R11	$M(R10) \rightarrow R11$ $R10 + 2 \rightarrow R10$
Immediate	+		MOV #X,TONI	MOV #45,TONI	$\#45 \rightarrow M(TONI)$

(1) S = source, D = destination

9.4 Operating Modes

These devices have one active mode and seven software-selectable low-power modes of operation. An interrupt event can wake up the device from any of the low-power modes, service the request, and restore back to the low-power mode on return from the interrupt program.

Software can configure the following operating modes:

- Active mode (AM)
 - All clocks are active
- Low-power mode 0 (LPM0)
 - CPU is disabled
 - ACLK and SMCLK remain active, MCLK is disabled
 - FLL loop control remains active
- Low-power mode 1 (LPM1)
 - CPU is disabled
 - FLL loop control is disabled
 - ACLK and SMCLK remain active, MCLK is disabled
- Low-power mode 2 (LPM2)
 - CPU is disabled
 - MCLK, FLL loop control, and DCOCLK are disabled
 - DC generator of the DCO remains enabled
 - ACLK remains active
- Low-power mode 3 (LPM3)
 - CPU is disabled
 - MCLK, FLL loop control, and DCOCLK are disabled
 - DC generator of the DCO is disabled
 - ACLK remains active
- Low-power mode 4 (LPM4)
 - CPU is disabled
 - ACLK is disabled
 - MCLK, FLL loop control, and DCOCLK are disabled
 - DC generator of the DCO is disabled
 - Crystal oscillator is stopped
 - Complete data retention
- Low-power mode 3.5 (LPM3.5)
 - Internal regulator disabled
 - No data retention
 - RTC enabled and clocked by low-frequency oscillator
 - Wake-up signal from $\overline{\text{RST}}/\text{NMI}$, RTC_B, P1, P2, P3, and P4
- Low-power mode 4.5 (LPM4.5)
 - Internal regulator disabled
 - No data retention
 - Wake-up signal from $\overline{\text{RST}}/\text{NMI}$, P1, P2, P3, and P4

9.5 Interrupt Vector Addresses

The interrupt vectors and the power-up start address are in the address range 0FFFFh to 0FF80h (see 表 9-3). The vector contains the 16-bit address of the appropriate interrupt-handler instruction sequence.

表 9-3. Interrupt Sources, Flags, and Vectors of MSP430F663x Configurations

INTERRUPT SOURCE	INTERRUPT FLAG	SYSTEM INTERRUPT	WORD ADDRESS	PRIORITY
System Reset Power-Up, External Reset Watchdog Time-out, Key Violation Flash Memory Key Violation	WDTIFG, KEYV (SYSRSTIV) ^{(1) (3)}	Reset	0FFFEh	63, highest
System NMI PMM Vacant Memory Access JTAG Mailbox	SVMLIFG, SVMHIFG, DLYLIFG, DLYHIFG, VLRLIFG, VLRHIFG, VMAIFG, JMBNIFG, JMBOUTIFG (SYSSNIV) ⁽¹⁾	(Non)maskable	0FFFCCh	62
User NMI NMI Oscillator Fault Flash Memory Access Violation	NMIIFG, OFIFG, ACCVIFG, BUSIFG (SYSUNIV) ^{(1) (3)}	(Non)maskable	0FFFAh	61
Comp_B	Comparator B interrupt flags (CBIV) ^{(1) (2)}	Maskable	0FFF8h	60
Timer TB0	TB0CCR0 CCIFG0 ⁽²⁾	Maskable	0FFF6h	59
Timer TB0	TB0CCR1 CCIFG1 to TB0CCR6 CCIFG6, TB0IFG (TBIV) ^{(1) (2)}	Maskable	0FFF4h	58
Watchdog Interval Timer Mode	WDTIFG	Maskable	0FFF2h	57
USCI_A0 Receive or Transmit	UCA0RXIFG, UCA0TXIFG (UCA0IV) ^{(1) (2)}	Maskable	0FFF0h	56
USCI_B0 Receive or Transmit	UCB0RXIFG, UCB0TXIFG (UCB0IV) ^{(1) (2)}	Maskable	0FFEEh	55
ADC12_A ⁽⁵⁾	ADC12IFG0 to ADC12IFG15 (ADC12IV) ^{(1) (2)}	Maskable	0FFECCh	54
Timer TA0	TA0CCR0 CCIFG0 ⁽²⁾	Maskable	0FFEAh	53
Timer TA0	TA0CCR1 CCIFG1 to TA0CCR4 CCIFG4, TA0IFG (TA0IV) ^{(1) (2)}	Maskable	0FFE8h	52
USB_UBM	USB interrupts (USBIV) ^{(1) (2)}	Maskable	0FFE6h	51
DMA	DMA0IFG, DMA1IFG, DMA2IFG, DMA3IFG, DMA4IFG, DMA5IFG (DMAIV) ^{(1) (2)}	Maskable	0FFE4h	50
Timer TA1	TA1CCR0 CCIFG0 ⁽²⁾	Maskable	0FFE2h	49
Timer TA1	TA1CCR1 CCIFG1 to TA1CCR2 CCIFG2, TA1IFG (TA1IV) ^{(1) (2)}	Maskable	0FFE0h	48
I/O Port P1	P1IFG.0 to P1IFG.7 (P1IV) ^{(1) (2)}	Maskable	0FFDEh	47
USCI_A1 Receive or Transmit	UCA1RXIFG, UCA1TXIFG (UCA1IV) ^{(1) (2)}	Maskable	0FFDCh	46
USCI_B1 Receive or Transmit	UCB1RXIFG, UCB1TXIFG (UCB1IV) ^{(1) (2)}	Maskable	0FFDAh	45
I/O Port P2	P2IFG.0 to P2IFG.7 (P2IV) ^{(1) (2)}	Maskable	0FFD8h	44
LCD_B	LCD_B Interrupt Flags (LCDBIV) ⁽¹⁾	Maskable	0FFD6h	43
RTC_B	RTCRDYIFG, RTCTEVIFG, RTCAIFG, RT0PSIFG, RT1PSIFG, RTCOFIFG (RTCIV) ^{(1) (2)}	Maskable	0FFD4h	42
DAC12_A ⁽⁶⁾	DAC12_0IFG, DAC12_1IFG ^{(1) (2)}	Maskable	0FFD2h	41
Timer TA2	TA2CCR0 CCIFG0 ⁽²⁾	Maskable	0FFD0h	40
Timer TA2	TA2CCR1 CCIFG1 to TA2CCR2 CCIFG2, TA2IFG (TA2IV) ^{(1) (2)}	Maskable	0FFCEh	39
I/O Port P3	P3IFG.0 to P3IFG.7 (P3IV) ^{(1) (2)}	Maskable	0FFCCh	38
I/O Port P4	P4IFG.0 to P4IFG.7 (P4IV) ^{(1) (2)}	Maskable	0FFCAh	37
Reserved	Reserved ⁽⁴⁾		0FFC8h	36
			⋮	⋮
			0FF80h	0, lowest

- (1) Multiple source flags
- (2) Interrupt flags are in the module.
- (3) A reset is generated if the CPU tries to fetch instructions from within peripheral space or vacant memory space.
(Non)maskable: the individual interrupt-enable bit can disable an interrupt event, but the general-interrupt enable cannot disable it.
- (4) Reserved interrupt vectors at addresses are not used in this device and can be used for regular program code if necessary. To maintain compatibility with other devices, TI recommends reserving these locations.

- (5) Only on devices with peripheral module ADC12_A, otherwise reserved.
(6) Only on devices with peripheral module DAC12_A, otherwise reserved.

9.6 Memory

表 9-4 summarizes the memory map for all device variants.

表 9-4. Memory Organization

(1) (3)		MSP430F6636 MSP430F6633 MSP430F6630	MSP430F6637 MSP430F6634 MSP430F6631	MSP430F6638 MSP430F6635 MSP430F6632
Memory (flash) Main: interrupt vector	Total Size	128KB 00FFFFh to 00FF80h	192KB 00FFFFh to 00FF80h	256KB 00FFFFh to 00FF80h
Main: code memory	Bank 3	N/A	N/A	64KB 047FFFh to 038000h
	Bank 2	N/A	64KB 037FFFh to 028000h	64KB 037FFFh to 028000h
	Bank 1	64KB 027FFFh to 018000h	64KB 027FFFh to 018000h	64KB 027FFFh to 018000h
	Bank 0	64KB 017FFFh to 008000h	64KB 017FFFh to 008000h	64KB 017FFFh to 008000h
RAM	Sector 3	4KB 0063FFh to 005400h	4KB 0063FFh to 005400h	4KB 0063FFh to 005400h
	Sector 2	4KB 0053FFh to 004400h	4KB 0053FFh to 004400h	4KB 0053FFh to 004400h
	Sector 1	4KB 0043FFh to 003400h	4KB 0043FFh to 003400h	4KB 0043FFh to 003400h
	Sector 0	4KB 0033FFh to 002400h	4KB 0033FFh to 002400h	4KB 0033FFh to 002400h
USB RAM ⁽²⁾	Size RAM	2KB 0023FFh to 001C00h	2KB 0023FFh to 001C00h	2KB 0023FFh to 001C00h
Information memory (flash)	Info A	128 bytes 0019FFh to 001980h	128 bytes 0019FFh to 001980h	128 bytes 0019FFh to 001980h
	Info B	128 bytes 00197Fh to 001900h	128 bytes 00197Fh to 001900h	128 bytes 00197Fh to 001900h
	Info C	128 bytes 0018FFh to 001880h	128 bytes 0018FFh to 001880h	128 bytes 0018FFh to 001880h
	Info D	128 bytes 00187Fh to 001800h	128 bytes 00187Fh to 001800h	128 bytes 00187Fh to 001800h
Bootloader (BSL) memory (flash)	BSL 3	512 bytes 0017FFh to 001600h	512 bytes 0017FFh to 001600h	512 bytes 0017FFh to 001600h
	BSL 2	512 bytes 0015FFh to 001400h	512 bytes 0015FFh to 001400h	512 bytes 0015FFh to 001400h
	BSL 1	512 bytes 0013FFh to 001200h	512 bytes 0013FFh to 001200h	512 bytes 0013FFh to 001200h
	BSL 0	512 bytes 0011FFh to 001000h	512 bytes 0011FFh to 001000h	512 bytes 0011FFh to 001000h
Peripherals	Size	4KB 000FFFFh to 000000h	4KB 000FFFFh to 000000h	4KB 000FFFFh to 000000h

- (1) N/A = Not available.
(2) USB RAM can be used as general-purpose RAM when not used for USB operation.
(3) Backup RAM is accessed through the control registers BAKMEM0, BAKMEM1, BAKMEM2, and BAKMEM3.

9.7 Bootloader (BSL)

The BSL lets users program the flash memory or RAM using various serial interfaces. Access to the device memory by the BSL is protected by an user-defined password. For complete description of the features of the BSL and its implementation, see [MSP430™ Flash Devices Bootloader \(BSL\) User's Guide](#).

9.7.1 USB BSL

All devices come preprogrammed with the USB BSL. Use of the USB BSL requires external access to six pins (see [表 9-5](#)). In addition to these pins, the application must support external components necessary for normal USB operation; for example, the proper crystal on XT2IN and XT2OUT or proper decoupling.

表 9-5. USB BSL Pin Requirements and Functions

DEVICE SIGNAL	BSL FUNCTION
RST/NMI/SBWDIO	Entry sequence signal
PU.0/DP	USB data terminal DP
PU.1/DM	USB data terminal DM
PUR	USB pullup resistor terminal
VBUS	USB bus power supply
VSSU	USB ground supply

Note

The default USB BSL evaluates the logic level of the PUR pin after a BOR reset. If the PUR pin is pulled high externally, the BSL is invoked. Therefore, unless the application is invoking the BSL, it is important to keep PUR pulled low after a BOR reset, even if BSL or USB is never used. TI recommends applying a 1-M Ω resistor to ground.

9.7.2 UART BSL

A UART BSL is also available that can be programmed by the user into the BSL memory by replacing the preprogrammed, factory supplied, USB BSL. Use of the UART BSL requires external access to six pins (see [表 9-6](#)).

表 9-6. UART BSL Pin Requirements and Functions

DEVICE SIGNAL	BSL FUNCTION
RST/NMI/SBWDIO	Entry sequence signal
TEST/SBWTCK	Entry sequence signal
P1.1	Data transmit
P1.2	Data receive
VCC	Power supply
VSS	Ground supply

9.8 JTAG Operation

9.8.1 JTAG Standard Interface

The MSP430 family supports the standard JTAG interface which requires four signals for sending and receiving data. The JTAG signals are shared with general-purpose I/O. The TEST/SBWTCK pin is used to enable the JTAG signals. In addition to these signals, the $\overline{\text{RST}}$ /NMI/SBWDIO is required to interface with MSP430 development tools and device programmers. [表 9-7](#) lists the JTAG pin requirements. For further details on interfacing to development tools and device programmers, see the [MSP430 Hardware Tools User's Guide](#). For a complete description of the features of the JTAG interface and its implementation, see [MSP430 Programming With the JTAG Interface](#).

表 9-7. JTAG Pin Requirements and Functions

DEVICE SIGNAL	DIRECTION	FUNCTION
PJ.3/TCK	IN	JTAG clock input
PJ.2/TMS	IN	JTAG state control
PJ.1/TDI/TCLK	IN	JTAG data input, TCLK input
PJ.0/TDO	OUT	JTAG data output
TEST/SBWTCK	IN	Enable JTAG pins
RST/NMI/SBWDIO	IN	External reset
VCC		Power supply
VSS		Ground supply

9.8.2 Spy-Bi-Wire Interface

In addition to the standard JTAG interface, the MSP430 family supports the two wire Spy-Bi-Wire interface. Spy-Bi-Wire can be used to interface with MSP430 development tools and device programmers. 表 9-8 lists the Spy-Bi-Wire interface pin requirements. For further details on interfacing to development tools and device programmers, see the [MSP430 Hardware Tools User's Guide](#). For a complete description of the features of the JTAG interface and its implementation, see [MSP430 Programming With the JTAG Interface](#).

表 9-8. Spy-Bi-Wire Pin Requirements and Functions

DEVICE SIGNAL	DIRECTION	FUNCTION
TEST/SBWTCK	IN	Spy-Bi-Wire clock input
RST/NMI/SBWDIO	IN, OUT	Spy-Bi-Wire data input/output
VCC		Power supply
VSS		Ground supply

9.9 Flash Memory

The flash memory can be programmed by the JTAG port, Spy-Bi-Wire (SBW), the BSL, or in-system by the CPU. The CPU can perform single-byte, single-word, and long-word writes to the flash memory. Features of the flash memory include:

- Flash memory has n segments of main memory and four segments of information memory (A to D) of 128 bytes each. Each segment in main memory is 512 bytes in size.
- Segments 0 to n may be erased in one step, or each segment may be individually erased.
- Segments A to D can be erased individually, or as a group with segments 0 to n. Segments A to D are also called *information memory*.
- Segment A can be locked separately.

9.10 RAM

The RAM is made up of n sectors. Each sector can be completely powered down to save leakage; however, all data is lost. Features of the RAM include:

- RAM has n sectors. The size of a sector can be found in [节 9.6](#).
- Each sector 0 to n can be complete disabled; however, data retention is lost.
- Each sector 0 to n automatically enters low power retention mode when possible.
- For devices that contain USB memory, the USB memory can be used as normal RAM if USB is not required.

9.11 Backup RAM

The backup RAM provides a limited number of bytes of RAM that are retained during LPMx.5 and during operation from a backup supply if the Battery Backup System module is implemented.

Eight bytes of backup RAM are available. The backup RAM can be wordwise accessed by the control registers BAKMEM0, BAKMEM1, BAKMEM2, and BAKMEM3.

9.12 Peripherals

Peripherals are connected to the CPU through data, address, and control buses. Peripherals can be managed using all instructions. For complete module descriptions, see the [MSP430F5xx and MSP430F6xx Family User's Guide](#).

9.12.1 Digital I/O

Up to nine 8-bit I/O ports are implemented: P1 through P6, P8, and P9 are complete, P7 contains six individual I/O ports, and PJ contains four individual I/O ports.

- All individual I/O bits are independently programmable.
- Any combination of input, output, and interrupt conditions is possible.
- Programmable pullup or pulldown on all ports.
- Programmable drive strength on all ports.
- All eight bits of ports P1, P2, P3, and P4 support edge-selectable interrupt input.
- All instructions support read and write access to port-control registers.
- Ports can be accessed byte-wise (P1 through P9) or word-wise in pairs (PA through PD).

9.12.2 Port Mapping Controller

The port mapping controller allows the flexible and reconfigurable mapping of digital functions to port P2. 表 9-9 lists the mnemonic for each function that can be assigned.

表 9-9. Port Mapping Mnemonics and Functions

VALUE	PxMAPy MNEMONIC	INPUT PIN FUNCTION	OUTPUT PIN FUNCTION
0	PM_NONE	None	DV _{SS}
1	PM_CBOUT	-	Comparator_B output
	PM_TB0CLK	Timer TB0 clock input	-
2	PM_ADC12CLK	-	ADC12CLK
	PM_DMAE0	DMAE0 Input	-
3	PM_SVMOUT	-	SVM output
	PM_TB0OUTH	Timer TB0 high-impedance input TB0OUTH	-
4	PM_TB0CCR0B	Timer TB0 CCR0 capture input CCI0B	Timer TB0: TB0.0 compare output Out0
5	PM_TB0CCR1B	Timer TB0 CCR1 capture input CCI1B	Timer TB0: TB0.1 compare output Out1
6	PM_TB0CCR2B	Timer TB0 CCR2 capture input CCI2B	Timer TB0: TB0.2 compare output Out2
7	PM_TB0CCR3B	Timer TB0 CCR3 capture input CCI3B	Timer TB0: TB0.3 compare output Out3
8	PM_TB0CCR4B	Timer TB0 CCR4 capture input CCI4B	Timer TB0: TB0.4 compare output Out4
9	PM_TB0CCR5B	Timer TB0 CCR5 capture input CCI5B	Timer TB0: TB0.5 compare output Out5
10	PM_TB0CCR6B	Timer TB0 CCR6 capture input CCI6B	Timer TB0: TB0.6 compare output Out6
11	PM_UCA0RXD	USCI_A0 UART RXD (Direction controlled by USCI - input)	
	PM_UCA0SOMI	USCI_A0 SPI slave out master in (direction controlled by USCI)	
12	PM_UCA0TXD	USCI_A0 UART TXD (Direction controlled by USCI - output)	
	PM_UCA0SIMO	USCI_A0 SPI slave in master out (direction controlled by USCI)	
13	PM_UCA0CLK	USCI_A0 clock input/output (direction controlled by USCI)	
	PM_UCB0STE	USCI_B0 SPI slave transmit enable (direction controlled by USCI - input)	
14	PM_UCB0SOMI	USCI_B0 SPI slave out master in (direction controlled by USCI)	
	PM_UCB0SCL	USCI_B0 I ² C clock (open drain and direction controlled by USCI)	
15	PM_UCB0SIMO	USCI_B0 SPI slave in master out (direction controlled by USCI)	
	PM_UCB0SDA	USCI_B0 I ² C data (open drain and direction controlled by USCI)	
16	PM_UCB0CLK	USCI_B0 clock input/output (direction controlled by USCI)	
	PM_UCA0STE	USCI_A0 SPI slave transmit enable (direction controlled by USCI - input)	

表 9-9. Port Mapping Mnemonics and Functions (continued)

VALUE	PxMAPy MNEMONIC	INPUT PIN FUNCTION	OUTPUT PIN FUNCTION
17	PM_MCLK	-	MCLK
18	Reserved	Reserved for test purposes. Do not use this setting.	
19	Reserved	Reserved for test purposes. Do not use this setting.	
20 – 30	Reserved	None	DVSS
31 (0FFh) ⁽¹⁾	PM_ANALOG	Disables the output driver and the input Schmitt-trigger to prevent parasitic cross currents when applying analog signals.	

(1) The value of the PM_ANALOG mnemonic is set to 0FFh. The port mapping registers are 5 bits wide, and the upper bits are ignored, which results in a maximum value of 31.

表 9-10 lists the default values for all pins that support port mapping.

表 9-10. Default Mapping

PIN	PxMAPy MNEMONIC	INPUT PIN FUNCTION	OUTPUT PIN FUNCTION
P2.0/P2MAP0	PM_UCB0STE, PM_UCA0CLK	USCI_B0 SPI slave transmit enable (direction controlled by USCI – input), USCI_A0 clock input/output (direction controlled by USCI)	
P2.1/P2MAP1	PM_UCB0SIMO, PM_UCB0SDA	USCI_B0 SPI slave in master out (direction controlled by USCI), USCI_B0 I ² C data (open drain and direction controlled by USCI)	
P2.2/P2MAP2	PM_UCB0SOMI, PM_UCB0SCL	USCI_B0 SPI slave out master in (direction controlled by USCI), USCI_B0 I ² C clock (open drain and direction controlled by USCI)	
P2.3/P2MAP3	PM_UCB0CLK, PM_UCA0STE	USCI_B0 clock input/output (direction controlled by USCI), USCI_A0 SPI slave transmit enable (direction controlled by USCI – input)	
P2.4/P2MAP4	PM_UCA0TXD, PM_UCA0SIMO	USCI_A0 UART TXD (direction controlled by USCI – output), USCI_A0 SPI slave in master out (direction controlled by USCI)	
P2.5/P2MAP5	PM_UCA0RXD, PM_UCA0SOMI	USCI_A0 UART RXD (direction controlled by USCI – input), USCI_A0 SPI slave out master in (direction controlled by USCI)	
P2.6/P2MAP6/R03	PM_NONE	-	DVSS
P2.7/P2MAP7/LCDREF/R13	PM_NONE	-	DVSS

9.12.3 Oscillator and System Clock

The clock system is supported by the Unified Clock System (UCS) module that includes support for a 32-kHz watch crystal oscillator (in XT1 LF mode; XT1 HF mode is not supported), an internal very-low-power low-frequency oscillator (VLO), an internal trimmed low-frequency oscillator (REFO), an integrated internal digitally controlled oscillator (DCO), and a high-frequency crystal oscillator XT2. The UCS module is designed to meet the requirements of both low system cost and low power consumption. The UCS module features digital frequency-locked loop (FLL) hardware that, in conjunction with a digital modulator, stabilizes the DCO frequency to a programmable multiple of the watch-crystal frequency. The internal DCO provides a fast turnon clock source and stabilizes in 3 μ s (typical). The UCS module provides the following clock signals:

- Auxiliary clock (ACLK), sourced from a 32-kHz watch crystal (XT1), a high-frequency crystal (XT2), the internal low-frequency oscillator (VLO), the trimmed low-frequency oscillator (REFO), or the internal digitally-controlled oscillator DCO.
- Main clock (MCLK), the system clock used by the CPU. MCLK can be sourced by same sources available to ACLK.
- Sub-Main clock (SMCLK), the subsystem clock used by the peripheral modules. SMCLK can be sourced by same sources available to ACLK.
- ACLK/n, the buffered output of ACLK, ACLK/2, ACLK/4, ACLK/8, ACLK/16, ACLK/32.

9.12.4 Power-Management Module (PMM)

The PMM includes an integrated voltage regulator that supplies the core voltage to the device and contains programmable output levels to provide for power optimization. The PMM also includes supply voltage supervisor (SVS) and supply voltage monitoring (SVM) circuitry, as well as brownout protection. The brownout circuit is

implemented to provide the proper internal reset signal to the device during power-on and power-off. The SVS and SVM circuitry detects if the supply voltage drops below a user-selectable level and supports both supply voltage supervision (the device is automatically reset) and supply voltage monitoring (the device is not automatically reset). SVS and SVM circuitry is available on the primary supply and core supply.

9.12.5 Hardware Multiplier (MPY) (Link to User's Guide)

The multiplication operation is supported by a dedicated peripheral module. The module performs operations with 32-, 24-, 16-, and 8-bit operands. The module supports signed and unsigned multiplication as well as signed and unsigned multiply-and-accumulate operations.

9.12.6 Real-Time Clock (RTC_B)

The RTC_B module can be configured for real-time clock (RTC) or calendar mode providing seconds, minutes, hours, day of week, day of month, month, and year. Calendar mode integrates an internal calendar which compensates for months with less than 31 days and includes leap year correction. The RTC_B also supports flexible alarm functions and offset-calibration hardware. The implementation on this device supports operation in LPM3.5 mode and operation from a backup supply.

[Using the MSP430 RTC_B Module With Battery Backup Supply](#) describes how to use the RTC_B with battery backup supply functionality to retain the time and keep the RTC counting through loss of main power supply, and how to perform correct reinitialization when the main power supply is restored.

9.12.7 Watchdog Timer (WDT_A)

The primary function of the WDT_A module is to perform a controlled system restart after a software problem occurs. If the selected time interval expires, a system reset is generated. If the watchdog function is not needed in an application, the module can be configured as an interval timer and can generate interrupts at selected time intervals.

9.12.8 System Module (SYS)

The SYS module handles many of the system functions within the device. These include power-on reset and power-up clear handling, NMI source selection and management, reset interrupt vector generators, bootloader entry mechanisms, and configuration management (device descriptors). SYS also includes a data exchange mechanism through JTAG called a JTAG mailbox that can be used in the application.

表 9-11 lists the SYS interrupt vector registers.

表 9-11. System Module Interrupt Vector Registers

INTERRUPT VECTOR REGISTER	INTERRUPT EVENT	WORD ADDRESS	OFFSET	PRIORITY
SYSRSTIV, System Reset	No interrupt pending	019Eh	00h	Highest
	Brownout (BOR)		02h	
	RST/NMI (BOR)		04h	
	PMMSWBOR (BOR)		06h	
	LPM3.5 or LPM4.5 wakeup (BOR)		08h	
	Security violation (BOR)		0Ah	
	SVSL (POR)		0Ch	
	SVSH (POR)		0Eh	
	SVML_OVP (POR)		10h	
	SVMH_OVP (POR)		12h	
	PMMSWPOR (POR)		14h	
	WDT time-out (PUC)		16h	
	WDT key violation (PUC)		18h	
	KEYV flash key violation (PUC)		1Ah	
	Reserved		1Ch	
	Peripheral area fetch (PUC)		1Eh	
	PMM key violation (PUC)		20h	
	Reserved		22h to 3Eh	Lowest
SYSSNIV, System NMI	No interrupt pending	019Ch	00h	Highest
	SVMLIFG		02h	
	SVMHIFG		04h	
	DLYLIFG		06h	
	DLYHIFG		08h	
	VMAIFG		0Ah	
	JMBINIFG		0Ch	
	JMBOUTIFG		0Eh	
	SVMLVLRIFG		10h	
	SVMHVLRIFG		12h	
	Reserved		14h to 1Eh	Lowest
SYSUNIV, User NMI	No interrupt pending	019Ah	00h	Highest
	NMIIFG		02h	
	OFIFG		04h	
	ACCVIFG		06h	
	BUSIFG		08h	
	Reserved		0Ah to 1Eh	Lowest
SYSBERRIV, Bus Error	No interrupt pending	0198h	00h	Highest
	USB wait state time-out		02h	
	Reserved		04h to 1Eh	Lowest

9.12.9 DMA Controller

The DMA controller allows movement of data from one memory address to another without CPU intervention. For example, the DMA controller can be used to move data from the ADC12_A conversion memory to RAM. Using the DMA controller can increase the throughput of peripheral modules. The DMA controller reduces system power consumption by allowing the CPU to remain in sleep mode, without having to awaken to move data to or from a peripheral. 表 9-12 lists the trigger assignments for each DMA channel.

The USB timestamp generator also uses the channel 0, 1, and 2 DMA trigger assignments.

表 9-12. DMA Trigger Assignments

TRIGGER ⁽¹⁾	CHANNEL					
	0	1	2	3	4	5
0	DMAREQ					
1	TA0CCR0 CCIFG					
2	TA0CCR2 CCIFG					
3	TA1CCR0 CCIFG					
4	TA1CCR2 CCIFG					
5	TA2CCR0 CCIFG					
6	TA2CCR2 CCIFG					
7	TBCCR0 CCIFG					
8	TBCCR2 CCIFG					
9	Reserved					
10	Reserved					
11	Reserved					
12	Reserved					
13	Reserved					
14	Reserved					
15	Reserved					
16	UCA0RXIFG					
17	UCA0TXIFG					
18	UCB0RXIFG					
19	UCB0TXIFG					
20	UCA1RXIFG					
21	UCA1TXIFG					
22	UCB1RXIFG					
23	UCB1TXIFG					
24	ADC12IFG ⁽²⁾					
25	DAC12_0IFG ⁽³⁾					
26	DAC12_1IFG ⁽³⁾					
27	USB FNRXD					
28	USB ready					
29	MPY ready					
30	DMA5IFG	DMA0IFG	DMA1IFG	DMA2IFG	DMA3IFG	DMA4IFG
31	DMAE0					

- (1) Reserved DMA triggers may be used by other devices in the family. Reserved DMA triggers will not cause any DMA trigger event when selected.
- (2) Only on devices with peripheral module ADC12_A. Reserved on devices without ADC.
- (3) Only on devices with peripheral module DAC12_A. Reserved on devices without DAC.

9.12.10 Universal Serial Communication Interface (USCI)

The USCI modules are used for serial data communication. The USCI module supports synchronous communication protocols such as SPI (3 or 4 pin) and I²C, and asynchronous communication protocols such as UART, enhanced UART with automatic baudrate detection, and IrDA. Each USCI module contains two portions, A and B.

The USCI_An module provides support for SPI (3 or 4 pin), UART, enhanced UART, or IrDA.

The USCI_Bn module provides support for SPI (3 or 4 pin) or I²C.

The MSP430F663x series includes two complete USCI modules (n = 0 or 1).

9.12.11 Timer TA0

Timer TA0 is a 16-bit timer/counter (Timer_A type) with five capture/compare registers. TA0 can support multiple capture/compares, PWM outputs, and interval timing (see 表 9-13). TA0 also has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each capture/compare register.

表 9-13. Timer TA0 Signal Connections

INPUT PIN NUMBER		DEVICE INPUT SIGNAL	MODULE INPUT SIGNAL	MODULE BLOCK	MODULE OUTPUT SIGNAL	DEVICE OUTPUT SIGNAL	OUTPUT PIN NUMBER	
PZ	ZCA, ZQW						PZ	ZCA, ZQW
34-P1.0	L5-P1.0	TA0CLK	TACLK	Timer	NA	NA		
		ACLK	ACLK					
		SMCLK	SMCLK					
34-P1.0	L5-P1.0	TA0CLK	TACLK					
35-P1.1	M5-P1.1	TA0.0	CCI0A	CCR0	TA0	TA0.0	35-P1.1	M5-P1.1
		DV _{SS}	CCI0B					
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					
36-P1.2	J6-P1.2	TA0.1	CCI1A	CCR1	TA1	TA0.1	36-P1.2	J6-P1.2
40-P1.6	J7-P1.6	TA0.1	CCI1B				40-P1.6	J7-P1.6
		DV _{SS}	GND				ADC12_A (internal) ⁽¹⁾ ADC12SHSx = {1}	
		DV _{CC}	V _{CC}					
37-P1.3	H6-P1.3	TA0.2	CCI2A	CCR2	TA2	TA0.2	37-P1.3	H6-P1.3
41-P1.7	M7-P1.7	TA0.2	CCI2B				41-P1.7	M7-P1.7
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					
38-P1.4	M6-P1.4	TA0.3	CCI3A	CCR3	TA3	TA0.3	38-P1.4	M6-P1.4
		DV _{SS}	CCI3B					
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					
39-P1.5	L6-P1.5	TA0.4	CCI4A	CCR4	TA4	TA0.4	39-P1.5	L6-P1.5
		DV _{SS}	CCI4B					
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					

(1) Only on devices with peripheral module ADC12_A.

9.12.12 Timer TA1

Timer TA1 is a 16-bit timer/counter (Timer_A type) with three capture/compare registers. TA1 supports multiple capture/compares, PWM outputs, and interval timing (see 表 9-14). TA1 also has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each capture/compare register.

表 9-14. Timer TA1 Signal Connections

INPUT PIN NUMBER		DEVICE INPUT SIGNAL	MODULE INPUT SIGNAL	MODULE BLOCK	MODULE OUTPUT SIGNAL	DEVICE OUTPUT SIGNAL	OUTPUT PIN NUMBER	
PZ	ZCA, ZQW						PZ	ZCA, ZQW
42-P3.0	L7-P3.0	TA1CLK	TACLK	Timer	NA	NA		
		ACLK	ACLK					
		SMCLK	SMCLK					
42-P3.0	L7-P3.0	TA1CLK	TACLK	CCR0	TA0	TA1.0		
43-P3.1	H7-P3.1	TA1.0	CCI0A				43-P3.1	H7-P3.1
		DV _{SS}	CCI0B					
		DV _{SS}	GND					
		DV _{CC}	V _{CC}	CCR1	TA1	TA1.1		
44-P3.2	M8-P3.2	TA1.1	CCI1A				44-P3.2	M8-P3.2
		CBOUT (internal)	CCI1B				DAC12_A ⁽¹⁾ DAC12_0, DAC12_1 (internal)	
		DV _{SS}	GND					
		DV _{CC}	V _{CC}	CCR2	TA2	TA1.2		
45-P3.3	L8-P3.3	TA1.2	CCI2A				45-P3.3	L8-P3.3
		ACLK (internal)	CCI2B					
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					

(1) Only on devices with peripheral module DAC12_A.

9.12.13 Timer TA2

Timer TA2 is a 16-bit timer/counter (Timer_A type) with three capture/compare registers. TA2 supports multiple capture/compares, PWM outputs, and interval timing (see 表 9-15). TA2 also has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each capture/compare register.

表 9-15. Timer TA2 Signal Connections

INPUT PIN NUMBER		DEVICE INPUT SIGNAL	MODULE INPUT SIGNAL	MODULE BLOCK	MODULE OUTPUT SIGNAL	DEVICE OUTPUT SIGNAL	OUTPUT PIN NUMBER	
PZ	ZCA, ZQW						PZ	ZCA, ZQW
46-P3.4	J8-P3.4	TA2CLK	TACLK	Timer	NA	NA		
		ACLK	ACLK					
		SMCLK	SMCLK					
46-P3.4	J8-P3.4	TA2CLK	TACLK	CCR0	TA0	TA2.0		
47-P3.5	M9-P3.5	TA2.0	CCI0A				47-P3.5	M9-P3.5
		DV _{SS}	CCI0B					
		DV _{SS}	GND					
		DV _{CC}	V _{CC}	CCR1	TA1	TA2.1		
48-P3.6	L9-P3.6	TA2.1	CCI1A				48-P3.6	L9-P3.6
		CBOUT (internal)	CCI1B					
		DV _{SS}	GND					
		DV _{CC}	V _{CC}	CCR2	TA2	TA2.2		
49-P3.7	M10-P3.7	TA2.2	CCI2A				49-P3.7	M10-P3.7
		ACLK (internal)	CCI2B					
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					

9.12.14 Timer TB0

Timer TB0 is a 16-bit timer/counter (Timer_B type) with seven capture/compare registers. TB0 supports multiple capture/compares, PWM outputs, and interval timing (see 表 9-16). TB0 also has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each capture/compare register.

表 9-16. Timer TB0 Signal Connections

INPUT PIN NUMBER		DEVICE INPUT SIGNAL	MODULE INPUT SIGNAL	MODULE BLOCK	MODULE OUTPUT SIGNAL	DEVICE OUTPUT SIGNAL	OUTPUT PIN NUMBER	
PZ	ZCA, ZQW						PZ	ZCA, ZQW
58-P8.0 P2MAPx ⁽³⁾	J11-P8.0 P2MAPx ⁽³⁾	TB0CLK	TB0CLK	Timer	NA	NA		
		ACLK	ACLK					
		SMCLK	SMCLK					
58-P8.0 P2MAPx ⁽³⁾	J11-P8.0 P2MAPx ⁽³⁾	TB0CLK	TB0CLK	CCR0	TB0	TB0.0	50-P4.0	J9-P4.0
50-P4.0	J9-P4.0	TB0.0	CCI0A				P2MAPx ⁽³⁾	P2MAPx ⁽³⁾
P2MAPx ⁽³⁾	P2MAPx ⁽³⁾	TB0.0	CCI0B				ADC12 (internal) ⁽¹⁾ ADC12SHSx = {2}	
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					
51-P4.1	M11-P4.1	TB0.1	CCI1A	CCR1	TB1	TB0.1	51-P4.1	M11-P4.1
P2MAPx ⁽³⁾	P2MAPx ⁽³⁾	TB0.1	CCI1B				P2MAPx ⁽³⁾	P2MAPx ⁽³⁾
		DV _{SS}	GND				ADC12 (internal) ⁽¹⁾ ADC12SHSx = {3}	
		DV _{CC}	V _{CC}					
52-P4.2	L10-P4.2	TB0.2	CCI2A	CCR2	TB2	TB0.2	52-P4.2	L10-P4.2
P2MAPx ⁽³⁾	P2MAPx ⁽³⁾	TB0.2	CCI2B				P2MAPx ⁽³⁾	P2MAPx ⁽³⁾
		DV _{SS}	GND				DAC12_A ⁽²⁾ (internal) DAC12_0, DAC12_1	
		DV _{CC}	V _{CC}					
53-P4.3	M12-P4.3	TB0.3	CCI3A	CCR3	TB3	TB0.3	53-P4.3	M12-P4.3
P2MAPx ⁽³⁾	P2MAPx ⁽³⁾	TB0.3	CCI3B				P2MAPx ⁽³⁾	P2MAPx ⁽³⁾
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					
54-P4.4	L12-P4.4	TB0.4	CCI4A	CCR4	TB4	TB0.4	54-P4.4	L12-P4.4
P2MAPx ⁽³⁾	P2MAPx ⁽³⁾	TB0.4	CCI4B				P2MAPx ⁽³⁾	P2MAPx ⁽³⁾
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					
55-P4.5	L11-P4.5	TB0.5	CCI5A	CCR5	TB5	TB0.5	55-P4.5	L11-P4.5
P2MAPx ⁽³⁾	P2MAPx ⁽³⁾	TB0.5	CCI5B				P2MAPx ⁽³⁾	P2MAPx ⁽³⁾
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					
56-P4.6	K11-P4.6	TB0.6	CCI6A	CCR6	TB6	TB0.6	56-P4.6	K11-P4.6
P2MAPx ⁽³⁾	P2MAPx ⁽³⁾	TB0.6	CCI6B				P2MAPx ⁽³⁾	P2MAPx ⁽³⁾
		DV _{SS}	GND					
		DV _{CC}	V _{CC}					

(1) Only on devices with peripheral module ADC12_A.

(2) Only on devices with peripheral module DAC12_A.

(3) Timer functions selectable by the port mapping controller.

9.12.15 Comparator_B

The primary function of the Comparator_B module is to support precision slope analog-to-digital conversions, battery voltage supervision, and monitoring of external analog signals.

9.12.16 ADC12_A

The ADC12_A module supports fast 12-bit analog-to-digital conversions. The module implements a 12-bit SAR core, sample select control, reference generator, and a 16-word conversion-and-control buffer. The conversion-and-control buffer allows up to 16 independent ADC samples to be converted and stored without any CPU intervention.

The DAC12_A module is a 12-bit R-ladder voltage-output DAC. The DAC12_A may be used in 8-bit or 12-bit mode, and may be used with the DMA controller. When multiple DAC12_A modules are present, they may be grouped together for synchronous operation.

9.12.18 CRC16

The CRC16 module produces a signature based on a sequence of entered data values and can be used for data checking purposes. The CRC16 module signature is based on the CRC-CCITT standard.

9.12.19 Voltage Reference (REF) Module

The REF module generates all of the critical reference voltages that can be used by the various analog peripherals in the device.

9.12.20 LCD_B

The LCD_B driver generates the segment and common signals that are required to drive a liquid crystal display (LCD). The LCD_B controller has dedicated data memories to hold segment drive information. Common and segment signals are generated as defined by the mode. Static, 2-mux, 3-mux, and 4-mux LCDs are supported. The module can provide a LCD voltage independent of the supply voltage with its integrated charge pump. It is possible to control the level of the LCD voltage, and thus the contrast, by software. The module also provides an automatic blinking capability for individual segments.

9.12.21 USB Universal Serial Bus

The USB module is a fully integrated USB interface that is compliant with the USB 2.0 specification. The module supports full-speed operation of control, interrupt, and bulk transfers. The module includes an integrated LDO, PHY, and PLL. The PLL is highly flexible and can support a wide range of input clock frequencies. USB RAM, when not used for USB communication, can be used by the system.

9.12.22 Embedded Emulation Module (EEM)

The EEM supports real-time in-system debugging. The L version of the EEM has the following features:

- Eight hardware triggers or breakpoints on memory access
- Two hardware triggers or breakpoints on CPU register write access
- Up to 10 hardware triggers can be combined to form complex triggers or breakpoints
- Two cycle counters
- Sequencer
- State storage
- Clock control on module level

9.12.23 Peripheral File Map

表 9-17 lists the register base address for all of the available peripheral modules.

表 9-17. Peripherals

MODULE NAME	BASE ADDRESS	OFFSET ADDRESS RANGE ⁽¹⁾
Special Functions (see 表 9-18)	0100h	000h to 01Fh
PMM (see 表 9-19)	0120h	000h to 010h
Flash Control (see 表 9-20)	0140h	000h to 00Fh
CRC16 (see 表 9-21)	0150h	000h to 007h
RAM Control (see 表 9-22)	0158h	000h to 001h
Watchdog (see 表 9-23)	015Ch	000h to 001h
UCS (see 表 9-24)	0160h	000h to 01Fh
SYS (see 表 9-25)	0180h	000h to 01Fh
Shared Reference (see 表 9-26)	01B0h	000h to 001h
Port Mapping Control (see 表 9-27)	01C0h	000h to 003h
Port Mapping Port P2 (see 表 9-27)	01D0h	000h to 007h
Port P1, P2 (see 表 9-28)	0200h	000h to 01Fh
Port P3, P4 (see 表 9-29)	0220h	000h to 01Fh
Port P5, P6 (see 表 9-30)	0240h	000h to 00Bh
Port P7, P8 (see 表 9-31)	0260h	000h to 00Bh
Port P9 (see 表 9-32)	0280h	000h to 00Bh
Port PJ (see 表 9-33)	0320h	000h to 01Fh
Timer TA0 (see 表 9-34)	0340h	000h to 02Eh
Timer TA1 (see 表 9-35)	0380h	000h to 02Eh
Timer TB0 (see 表 9-36)	03C0h	000h to 02Eh
Timer TA2 (see 表 9-37)	0400h	000h to 02Eh
Battery Backup (see 表 9-38)	0480h	000h to 01Fh
RTC_B (see 表 9-39)	04A0h	000h to 01Fh
32-bit Hardware Multiplier (see 表 9-40)	04C0h	000h to 02Fh
DMA General Control (see 表 9-41)	0500h	000h to 00Fh
DMA Channel 0 (see 表 9-41)	0510h	000h to 00Ah
DMA Channel 1 (see 表 9-41)	0520h	000h to 00Ah
DMA Channel 2 (see 表 9-41)	0530h	000h to 00Ah
DMA Channel 3 (see 表 9-41)	0540h	000h to 00Ah
DMA Channel 4 (see 表 9-41)	0550h	000h to 00Ah
DMA Channel 5 (see 表 9-41)	0560h	000h to 00Ah
USCI_A0 (see 表 9-42)	05C0h	000h to 01Fh
USCI_B0 (see 表 9-43)	05E0h	000h to 01Fh
USCI_A1 (see 表 9-44)	0600h	000h to 01Fh
USCI_B1 (see 表 9-45)	0620h	000h to 01Fh
ADC12_A (see 表 9-46)	0700h	000h to 03Fh
DAC12_A (see 表 9-47)	0780h	000h to 01Fh
Comparator_B (see 表 9-48)	08C0h	000h to 00Fh
USB configuration (see 表 9-49)	0900h	000h to 014h
USB control (see 表 9-50)	0920h	000h to 01Fh
LCD_B control (see 表 9-51)	0A00h	000h to 05Fh

(1) For a detailed description of the individual control register offset addresses, see the [MSP430F5xx and MSP430F6xx Family User's Guide](#).

表 9-18. Special Function Registers (Base Address: 0100h)

REGISTER DESCRIPTION	REGISTER	OFFSET
SFR interrupt enable	SFRIE1	00h
SFR interrupt flag	SFRIFG1	02h
SFR reset pin control	SFRRPCR	04h

表 9-19. PMM Registers (Base Address: 0120h)

REGISTER DESCRIPTION	REGISTER	OFFSET
PMM control 0	PMMCTL0	00h
PMM control 1	PMMCTL1	02h
SVS high-side control	SVSMHCTL	04h
SVS low-side control	SVSMLCTL	06h
PMM interrupt flags	PMMIFG	0Ch
PMM interrupt enable	PMMIE	0Eh
PMM power mode 5 control	PM5CTL0	10h

表 9-20. Flash Control Registers (Base Address: 0140h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Flash control 1	FCTL1	00h
Flash control 3	FCTL3	04h
Flash control 4	FCTL4	06h

表 9-21. CRC16 Registers (Base Address: 0150h)

REGISTER DESCRIPTION	REGISTER	OFFSET
CRC data input	CRC16DI	00h
CRC result	CRC16INRES	04h

表 9-22. RAM Control Registers (Base Address: 0158h)

REGISTER DESCRIPTION	REGISTER	OFFSET
RAM control 0	RCCTL0	00h

表 9-23. Watchdog Registers (Base Address: 015Ch)

REGISTER DESCRIPTION	REGISTER	OFFSET
Watchdog timer control	WDTCTL	00h

表 9-24. UCS Registers (Base Address: 0160h)

REGISTER DESCRIPTION	REGISTER	OFFSET
UCS control 0	UCSCTL0	00h
UCS control 1	UCSCTL1	02h
UCS control 2	UCSCTL2	04h
UCS control 3	UCSCTL3	06h
UCS control 4	UCSCTL4	08h
UCS control 5	UCSCTL5	0Ah
UCS control 6	UCSCTL6	0Ch
UCS control 7	UCSCTL7	0Eh
UCS control 8	UCSCTL8	10h

表 9-25. SYS Registers (Base Address: 0180h)

REGISTER DESCRIPTION	REGISTER	OFFSET
System control	SYSCCTL	00h

表 9-25. SYS Registers (Base Address: 0180h) (continued)

REGISTER DESCRIPTION	REGISTER	OFFSET
Bootloader configuration area	SYSBSLC	02h
JTAG mailbox control	SYSJMBC	06h
JTAG mailbox input 0	SYSJMBI0	08h
JTAG mailbox input 1	SYSJMBI1	0Ah
JTAG mailbox output 0	SYSJMBO0	0Ch
JTAG mailbox output 1	SYSJMBO1	0Eh
Bus error vector generator	SYSBERRIV	18h
User NMI vector generator	SYSUNIV	1Ah
System NMI vector generator	SYSSNIV	1Ch
Reset vector generator	SYSRSTIV	1Eh

表 9-26. Shared Reference Registers (Base Address: 01B0h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Shared reference control	REFCTL	00h

**表 9-27. Port Mapping Registers
(Base Address of Port Mapping Control: 01C0h, Port P2: 01D0h)**

REGISTER DESCRIPTION	REGISTER	OFFSET
Port mapping password	PMAPPWD	00h
Port mapping control	PMAPCTL	02h
Port P2.0 mapping	P2MAP0	00h
Port P2.1 mapping	P2MAP1	01h
Port P2.2 mapping	P2MAP2	02h
Port P2.3 mapping	P2MAP3	03h
Port P2.4 mapping	P2MAP4	04h
Port P2.5 mapping	P2MAP5	05h
Port P2.6 mapping	P2MAP6	06h
Port P2.7 mapping	P2MAP7	07h

表 9-28. Port P1, P2 Registers (Base Address: 0200h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Port P1 input	P1IN	00h
Port P1 output	P1OUT	02h
Port P1 direction	P1DIR	04h
Port P1 pullup/pulldown enable	P1REN	06h
Port P1 drive strength	P1DS	08h
Port P1 selection	P1SEL	0Ah
Port P1 interrupt vector word	P1IV	0Eh
Port P1 interrupt edge select	P1IES	18h
Port P1 interrupt enable	P1IE	1Ah
Port P1 interrupt flag	P1IFG	1Ch
Port P2 input	P2IN	01h
Port P2 output	P2OUT	03h
Port P2 direction	P2DIR	05h
Port P2 pullup/pulldown enable	P2REN	07h
Port P2 drive strength	P2DS	09h
Port P2 selection	P2SEL	0Bh

表 9-28. Port P1, P2 Registers (Base Address: 0200h) (continued)

REGISTER DESCRIPTION	REGISTER	OFFSET
Port P2 interrupt vector word	P2IV	1Eh
Port P2 interrupt edge select	P2IES	19h
Port P2 interrupt enable	P2IE	1Bh
Port P2 interrupt flag	P2IFG	1Dh

表 9-29. Port P3, P4 Registers (Base Address: 0220h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Port P3 input	P3IN	00h
Port P3 output	P3OUT	02h
Port P3 direction	P3DIR	04h
Port P3 pullup/pulldown enable	P3REN	06h
Port P3 drive strength	P3DS	08h
Port P3 selection	P3SEL	0Ah
Port P3 interrupt vector word	P3IV	0Eh
Port P3 interrupt edge select	P3IES	18h
Port P3 interrupt enable	P3IE	1Ah
Port P3 interrupt flag	P3IFG	1Ch
Port P4 input	P4IN	01h
Port P4 output	P4OUT	03h
Port P4 direction	P4DIR	05h
Port P4 pullup/pulldown enable	P4REN	07h
Port P4 drive strength	P4DS	09h
Port P4 selection	P4SEL	0Bh
Port P4 interrupt vector word	P4IV	1Eh
Port P4 interrupt edge select	P4IES	19h
Port P4 interrupt enable	P4IE	1Bh
Port P4 interrupt flag	P4IFG	1Dh

表 9-30. Port P5, P6 Registers (Base Address: 0240h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Port P5 input	P5IN	00h
Port P5 output	P5OUT	02h
Port P5 direction	P5DIR	04h
Port P5 pullup/pulldown enable	P5REN	06h
Port P5 drive strength	P5DS	08h
Port P5 selection	P5SEL	0Ah
Port P6 input	P6IN	01h
Port P6 output	P6OUT	03h
Port P6 direction	P6DIR	05h
Port P6 pullup/pulldown enable	P6REN	07h
Port P6 drive strength	P6DS	09h
Port P6 selection	P6SEL	0Bh

表 9-31. Port P7, P8 Registers (Base Address: 0260h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Port P7 input	P7IN	00h
Port P7 output	P7OUT	02h

表 9-31. Port P7, P8 Registers (Base Address: 0260h) (continued)

REGISTER DESCRIPTION	REGISTER	OFFSET
Port P7 direction	P7DIR	04h
Port P7 pullup/pulldown enable	P7REN	06h
Port P7 drive strength	P7DS	08h
Port P7 selection	P7SEL	0Ah
Port P8 input	P8IN	01h
Port P8 output	P8OUT	03h
Port P8 direction	P8DIR	05h
Port P8 pullup/pulldown enable	P8REN	07h
Port P8 drive strength	P8DS	09h
Port P8 selection	P8SEL	0Bh

表 9-32. Port P9 Register (Base Address: 0280h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Port P9 input	P9IN	00h
Port P9 output	P9OUT	02h
Port P9 direction	P9DIR	04h
Port P9 pullup/pulldown enable	P9REN	06h
Port P9 drive strength	P9DS	08h
Port P9 selection	P9SEL	0Ah

表 9-33. Port J Registers (Base Address: 0320h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Port PJ input	PJIN	00h
Port PJ output	PJOUT	02h
Port PJ direction	PJDIR	04h
Port PJ pullup/pulldown enable	PJREN	06h
Port PJ drive strength	PJDS	08h

表 9-34. TA0 Registers (Base Address: 0340h)

REGISTER DESCRIPTION	REGISTER	OFFSET
TA0 control	TA0CTL	00h
Capture/compare control 0	TA0CCTL0	02h
Capture/compare control 1	TA0CCTL1	04h
Capture/compare control 2	TA0CCTL2	06h
Capture/compare control 3	TA0CCTL3	08h
Capture/compare control 4	TA0CCTL4	0Ah
TA0 counter	TA0R	10h
Capture/compare 0	TA0CCR0	12h
Capture/compare 1	TA0CCR1	14h
Capture/compare 2	TA0CCR2	16h
Capture/compare 3	TA0CCR3	18h
Capture/compare 4	TA0CCR4	1Ah
TA0 expansion 0	TA0EX0	20h
TA0 interrupt vector	TA0IV	2Eh

表 9-35. TA1 Registers (Base Address: 0380h)

REGISTER DESCRIPTION	REGISTER	OFFSET
TA1 control	TA1CTL	00h
Capture/compare control 0	TA1CCTL0	02h
Capture/compare control 1	TA1CCTL1	04h
Capture/compare control 2	TA1CCTL2	06h
TA1 counter	TA1R	10h
Capture/compare 0	TA1CCR0	12h
Capture/compare 1	TA1CCR1	14h
Capture/compare 2	TA1CCR2	16h
TA1 expansion 0	TA1EX0	20h
TA1 interrupt vector	TA1IV	2Eh

表 9-36. TB0 Registers (Base Address: 03C0h)

REGISTER DESCRIPTION	REGISTER	OFFSET
TB0 control	TB0CTL	00h
Capture/compare control 0	TB0CCTL0	02h
Capture/compare control 1	TB0CCTL1	04h
Capture/compare control 2	TB0CCTL2	06h
Capture/compare control 3	TB0CCTL3	08h
Capture/compare control 4	TB0CCTL4	0Ah
Capture/compare control 5	TB0CCTL5	0Ch
Capture/compare control 6	TB0CCTL6	0Eh
TB0 counter	TB0R	10h
Capture/compare 0	TB0CCR0	12h
Capture/compare 1	TB0CCR1	14h
Capture/compare 2	TB0CCR2	16h
Capture/compare 3	TB0CCR3	18h
Capture/compare 4	TB0CCR4	1Ah
Capture/compare 5	TB0CCR5	1Ch
Capture/compare 6	TB0CCR6	1Eh
TB0 expansion 0	TB0EX0	20h
TB0 interrupt vector	TB0IV	2Eh

表 9-37. TA2 Registers (Base Address: 0400h)

REGISTER DESCRIPTION	REGISTER	OFFSET
TA2 control	TA2CTL	00h
Capture/compare control 0	TA2CCTL0	02h
Capture/compare control 1	TA2CCTL1	04h
Capture/compare control 2	TA2CCTL2	06h
TA2 counter	TA2R	10h
Capture/compare 0	TA2CCR0	12h
Capture/compare 1	TA2CCR1	14h
Capture/compare 2	TA2CCR2	16h
TA2 expansion 0	TA2EX0	20h
TA2 interrupt vector	TA2IV	2Eh

表 9-38. Battery Backup Registers (Base Address: 0480h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Battery backup memory 0	BAKMEM0	00h
Battery backup memory 1	BAKMEM1	02h
Battery backup memory 2	BAKMEM2	04h
Battery backup memory 3	BAKMEM3	06h
Battery backup control	BAKCTL	1Ch
Battery charger control	BAKCHCTL	1Eh

表 9-39. Real-Time Clock Registers (Base Address: 04A0h)

REGISTER DESCRIPTION	REGISTER	OFFSET
RTC control 0	RTCCTL0	00h
RTC control 1	RTCCTL1	01h
RTC control 2	RTCCTL2	02h
RTC control 3	RTCCTL3	03h
RTC prescaler 0 control	RTCPS0CTL	08h
RTC prescaler 1 control	RTCPS1CTL	0Ah
RTC prescaler 0	RTCPS0	0Ch
RTC prescaler 1	RTCPS1	0Dh
RTC interrupt vector word	RTCIV	0Eh
RTC seconds	RTCSEC	10h
RTC minutes	RTCMIN	11h
RTC hours	RTCHOUR	12h
RTC day of week	RTCDOW	13h
RTC days	RTCDAY	14h
RTC month	RTCMON	15h
RTC year low	RTCYEARL	16h
RTC year high	RTCYEARH	17h
RTC alarm minutes	RTCAMIN	18h
RTC alarm hours	RTCAHOUR	19h
RTC alarm day of week	RTCADOW	1Ah
RTC alarm days	RTCADAY	1Bh
Binary-to-BCD conversion	BIN2BCD	1Ch
BCD-to-binary conversion	BCD2BIN	1Eh

表 9-40. 32-Bit Hardware Multiplier Registers (Base Address: 04C0h)

REGISTER DESCRIPTION	REGISTER	OFFSET
16-bit operand 1 - multiply	MPY	00h
16-bit operand 1 - signed multiply	MPYS	02h
16-bit operand 1 - multiply accumulate	MAC	04h
16-bit operand 1 - signed multiply accumulate	MACS	06h
16-bit operand 2	OP2	08h
16 × 16 result low word	RESLO	0Ah
16 × 16 result high word	RESHI	0Ch
16 × 16 sum extension	SUMEXT	0Eh
32-bit operand 1 - multiply low word	MPY32L	10h
32-bit operand 1 - multiply high word	MPY32H	12h
32-bit operand 1 - signed multiply low word	MPYS32L	14h

表 9-40. 32-Bit Hardware Multiplier Registers (Base Address: 04C0h) (continued)

REGISTER DESCRIPTION	REGISTER	OFFSET
32-bit operand 1 – signed multiply high word	MPYS32H	16h
32-bit operand 1 – multiply accumulate low word	MAC32L	18h
32-bit operand 1 – multiply accumulate high word	MAC32H	1Ah
32-bit operand 1 – signed multiply accumulate low word	MACS32L	1Ch
32-bit operand 1 – signed multiply accumulate high word	MACS32H	1Eh
32-bit operand 2 – low word	OP2L	20h
32-bit operand 2 – high word	OP2H	22h
32 × 32 result 0 – least significant word	RES0	24h
32 × 32 result 1	RES1	26h
32 × 32 result 2	RES2	28h
32 × 32 result 3 – most significant word	RES3	2Ah
MPY32 control 0	MPY32CTL0	2Ch

**表 9-41. DMA Registers (Base Address DMA General Control: 0500h,
DMA Channel 0: 0510h, DMA Channel 1: 0520h, DMA Channel 2: 0530h, DMA Channel 3: 0540h, DMA
Channel 4: 0550h, DMA Channel 5: 0560h)**

REGISTER DESCRIPTION	REGISTER	OFFSET
DMA general control: DMA module control 0	DMACTL0	00h
DMA general control: DMA module control 1	DMACTL1	02h
DMA general control: DMA module control 2	DMACTL2	04h
DMA general control: DMA module control 3	DMACTL3	06h
DMA general control: DMA module control 4	DMACTL4	08h
DMA general control: DMA interrupt vector	DMAIV	0Ah
DMA channel 0 control	DMA0CTL	00h
DMA channel 0 source address low	DMA0SAL	02h
DMA channel 0 source address high	DMA0SAH	04h
DMA channel 0 destination address low	DMA0DAL	06h
DMA channel 0 destination address high	DMA0DAH	08h
DMA channel 0 transfer size	DMA0SZ	0Ah
DMA channel 1 control	DMA1CTL	00h
DMA channel 1 source address low	DMA1SAL	02h
DMA channel 1 source address high	DMA1SAH	04h
DMA channel 1 destination address low	DMA1DAL	06h
DMA channel 1 destination address high	DMA1DAH	08h
DMA channel 1 transfer size	DMA1SZ	0Ah
DMA channel 2 control	DMA2CTL	00h
DMA channel 2 source address low	DMA2SAL	02h
DMA channel 2 source address high	DMA2SAH	04h
DMA channel 2 destination address low	DMA2DAL	06h
DMA channel 2 destination address high	DMA2DAH	08h
DMA channel 2 transfer size	DMA2SZ	0Ah
DMA channel 3 control	DMA3CTL	00h
DMA channel 3 source address low	DMA3SAL	02h
DMA channel 3 source address high	DMA3SAH	04h
DMA channel 3 destination address low	DMA3DAL	06h

**表 9-41. DMA Registers (Base Address DMA General Control: 0500h,
DMA Channel 0: 0510h, DMA Channel 1: 0520h, DMA Channel 2: 0530h, DMA Channel 3: 0540h, DMA
Channel 4: 0550h, DMA Channel 5: 0560h) (continued)**

REGISTER DESCRIPTION	REGISTER	OFFSET
DMA channel 3 destination address high	DMA3DAH	08h
DMA channel 3 transfer size	DMA3SZ	0Ah
DMA channel 4 control	DMA4CTL	00h
DMA channel 4 source address low	DMA4SAL	02h
DMA channel 4 source address high	DMA4SAH	04h
DMA channel 4 destination address low	DMA4DAL	06h
DMA channel 4 destination address high	DMA4DAH	08h
DMA channel 4 transfer size	DMA4SZ	0Ah
DMA channel 5 control	DMA5CTL	00h
DMA channel 5 source address low	DMA5SAL	02h
DMA channel 5 source address high	DMA5SAH	04h
DMA channel 5 destination address low	DMA5DAL	06h
DMA channel 5 destination address high	DMA5DAH	08h
DMA channel 5 transfer size	DMA5SZ	0Ah

表 9-42. USCI_A0 Registers (Base Address: 05C0h)

REGISTER DESCRIPTION	REGISTER	OFFSET
USCI control 0	UCA0CTL0	00h
USCI control 1	UCA0CTL1	01h
USCI baud rate 0	UCA0BR0	06h
USCI baud rate 1	UCA0BR1	07h
USCI modulation control	UCA0MCTL	08h
USCI status	UCA0STAT	0Ah
USCI receive buffer	UCA0RXBUF	0Ch
USCI transmit buffer	UCA0TXBUF	0Eh
USCI LIN control	UCA0ABCTL	10h
USCI IrDA transmit control	UCA0IRTCTL	12h
USCI IrDA receive control	UCA0IRRCTL	13h
USCI interrupt enable	UCA0IE	1Ch
USCI interrupt flags	UCA0IFG	1Dh
USCI interrupt vector word	UCA0IV	1Eh

表 9-43. USCI_B0 Registers (Base Address: 05E0h)

REGISTER DESCRIPTION	REGISTER	OFFSET
USCI synchronous control 0	UCB0CTL0	00h
USCI synchronous control 1	UCB0CTL1	01h
USCI synchronous bit rate 0	UCB0BR0	06h
USCI synchronous bit rate 1	UCB0BR1	07h
USCI synchronous status	UCB0STAT	0Ah
USCI synchronous receive buffer	UCB0RXBUF	0Ch
USCI synchronous transmit buffer	UCB0TXBUF	0Eh
USCI I2C own address	UCB0I2COA	10h
USCI I2C slave address	UCB0I2CSA	12h
USCI interrupt enable	UCB0IE	1Ch

表 9-43. USCI_B0 Registers (Base Address: 05E0h) (continued)

REGISTER DESCRIPTION	REGISTER	OFFSET
USCI interrupt flags	UCB0IFG	1Dh
USCI interrupt vector word	UCB0IV	1Eh

表 9-44. USCI_A1 Registers (Base Address: 0600h)

REGISTER DESCRIPTION	REGISTER	OFFSET
USCI control 0	UCA1CTL0	00h
USCI control 1	UCA1CTL1	01h
USCI baud rate 0	UCA1BR0	06h
USCI baud rate 1	UCA1BR1	07h
USCI modulation control	UCA1MCTL	08h
USCI status	UCA1STAT	0Ah
USCI receive buffer	UCA1RXBUF	0Ch
USCI transmit buffer	UCA1TXBUF	0Eh
USCI LIN control	UCA1ABCTL	10h
USCI IrDA transmit control	UCA1IRTCTL	12h
USCI IrDA receive control	UCA1IRRCTL	13h
USCI interrupt enable	UCA1IE	1Ch
USCI interrupt flags	UCA1IFG	1Dh
USCI interrupt vector word	UCA1IV	1Eh

表 9-45. USCI_B1 Registers (Base Address: 0620h)

REGISTER DESCRIPTION	REGISTER	OFFSET
USCI synchronous control 0	UCB1CTL0	00h
USCI synchronous control 1	UCB1CTL1	01h
USCI synchronous bit rate 0	UCB1BR0	06h
USCI synchronous bit rate 1	UCB1BR1	07h
USCI synchronous status	UCB1STAT	0Ah
USCI synchronous receive buffer	UCB1RXBUF	0Ch
USCI synchronous transmit buffer	UCB1TXBUF	0Eh
USCI I2C own address	UCB1I2COA	10h
USCI I2C slave address	UCB1I2CSA	12h
USCI interrupt enable	UCB1IE	1Ch
USCI interrupt flags	UCB1IFG	1Dh
USCI interrupt vector word	UCB1IV	1Eh

表 9-46. ADC12_A Registers (Base Address: 0700h)

REGISTER DESCRIPTION	REGISTER	OFFSET
ADC12 control 0	ADC12CTL0	00h
ADC12 control 1	ADC12CTL1	02h
ADC12 control 2	ADC12CTL2	04h
Interrupt flag	ADC12IFG	0Ah
Interrupt enable	ADC12IE	0Ch
Interrupt vector word	ADC12IV	0Eh
ADC memory control 0	ADC12MCTL0	10h
ADC memory control 1	ADC12MCTL1	11h
ADC memory control 2	ADC12MCTL2	12h
ADC memory control 3	ADC12MCTL3	13h

表 9-46. ADC12_A Registers (Base Address: 0700h) (continued)

REGISTER DESCRIPTION	REGISTER	OFFSET
ADC memory control 4	ADC12MCTL4	14h
ADC memory control 5	ADC12MCTL5	15h
ADC memory control 6	ADC12MCTL6	16h
ADC memory control 7	ADC12MCTL7	17h
ADC memory control 8	ADC12MCTL8	18h
ADC memory control 9	ADC12MCTL9	19h
ADC memory control 10	ADC12MCTL10	1Ah
ADC memory control 11	ADC12MCTL11	1Bh
ADC memory control 12	ADC12MCTL12	1Ch
ADC memory control 13	ADC12MCTL13	1Dh
ADC memory control 14	ADC12MCTL14	1Eh
ADC memory control 15	ADC12MCTL15	1Fh
Conversion memory 0	ADC12MEM0	20h
Conversion memory 1	ADC12MEM1	22h
Conversion memory 2	ADC12MEM2	24h
Conversion memory 3	ADC12MEM3	26h
Conversion memory 4	ADC12MEM4	28h
Conversion memory 5	ADC12MEM5	2Ah
Conversion memory 6	ADC12MEM6	2Ch
Conversion memory 7	ADC12MEM7	2Eh
Conversion memory 8	ADC12MEM8	30h
Conversion memory 9	ADC12MEM9	32h
Conversion memory 10	ADC12MEM10	34h
Conversion memory 11	ADC12MEM11	36h
Conversion memory 12	ADC12MEM12	38h
Conversion memory 13	ADC12MEM13	3Ah
Conversion memory 14	ADC12MEM14	3Ch
Conversion memory 15	ADC12MEM15	3Eh

表 9-47. DAC12_A Registers (Base Address: 0780h)

REGISTER DESCRIPTION	REGISTER	OFFSET
DAC12_A channel 0 control 0	DAC12_0CTL0	00h
DAC12_A channel 0 control 1	DAC12_0CTL1	02h
DAC12_A channel 0 data	DAC12_0DAT	04h
DAC12_A channel 0 calibration control	DAC12_0CALCTL	06h
DAC12_A channel 0 calibration data	DAC12_0CALDAT	08h
DAC12_A channel 1 control 0	DAC12_1CTL0	10h
DAC12_A channel 1 control 1	DAC12_1CTL1	12h
DAC12_A channel 1 data	DAC12_1DAT	14h
DAC12_A channel 1 calibration control	DAC12_1CALCTL	16h
DAC12_A channel 1 calibration data	DAC12_1CALDAT	18h
DAC12_A interrupt vector word	DAC12IV	1Eh

表 9-48. Comparator_B Registers (Base Address: 08C0h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Comp_B control 0	CBCTL0	00h

表 9-48. Comparator_B Registers (Base Address: 08C0h) (continued)

REGISTER DESCRIPTION	REGISTER	OFFSET
Comp_B control 1	CBCTL1	02h
Comp_B control 2	CBCTL2	04h
Comp_B control 3	CBCTL3	06h
Comp_B interrupt	CBINT	0Ch
Comp_B interrupt vector word	CBIV	0Eh

表 9-49. USB Configuration Registers (Base Address: 0900h)

REGISTER DESCRIPTION	REGISTER	OFFSET
USB key/ID	USBKEYID	00h
USB module configuration	USBCNF	02h
USB PHY control	USBPHYCTL	04h
USB power control	USBPWRCTL	08h
USB power voltage setting	USBPWRVSR	0Ah
USB PLL control	USBPLLCTL	10h
USB PLL divider	USBPLLDIV	12h
USB PLL interrupts	USBPLLIR	14h

表 9-50. USB Control Registers (Base Address: 0920h)

REGISTER DESCRIPTION	REGISTER	OFFSET
Input endpoint_0 configuration	USBIEPCNF_0	00h
Input endpoint_0 byte count	USBIEPCNT_0	01h
Output endpoint_0 configuration	USBOEPCNF_0	02h
Output endpoint_0 byte count	USBOEPCNT_0	03h
Input endpoint interrupt enables	USBIEPIE	0Eh
Output endpoint interrupt enables	USBOEPIE	0Fh
Input endpoint interrupt flags	USBIEPIFG	10h
Output endpoint interrupt flags	USBOEPIFG	11h
USB interrupt vector	USBIV	12h
USB maintenance	USBMAINT	16h
Timestamp	USBTSREG	18h
USB frame number	USBFN	1Ah
USB control	USBCTL	1Ch
USB interrupt enables	USBIE	1Dh
USB interrupt flags	USBIFG	1Eh
Function address	USBFUNADR	1Fh

表 9-51. LCD_B Registers (Base Address: 0A00h)

REGISTER DESCRIPTION	REGISTER	OFFSET
LCD_B control 0	LCDBCTL0	00h
LCD_B control 1	LCDBCTL1	002h
LCD_B blinking control	LCDBBLKCTL	004h
LCD_B memory control	LCDBMEMCTL	006h
LCD_B voltage control	LCDBVCTL	008h
LCD_B port control 0	LCDBPCTL0	00Ah
LCD_B port control 1	LCDBPCTL1	00Ch
LCD_B port control 2	LCDBPCTL2	00Eh
LCD_B charge pump control	LCDBCTL0	012h

表 9-51. LCD_B Registers (Base Address: 0A00h) (continued)

REGISTER DESCRIPTION	REGISTER	OFFSET
LCD_B interrupt vector word	LCDBIV	01Eh
LCD_B memory 1	LCDM1	020h
LCD_B memory 2	LCDM2	021h
⋮	⋮	⋮
LCD_B memory 22	LCDM22	035h
LCD_B blinking memory 1	LCDBM1	040h
LCD_B blinking memory 2	LCDBM2	041h
⋮	⋮	⋮
LCD_B blinking memory 22	LCDBM22	055h

9.13 Input/Output Diagrams

9.13.1 Port P1 (P1.0 to P1.7) Input/Output With Schmitt Trigger

图 9-2 shows the pin diagram. 表 9-52 summarizes how to select the pin function.

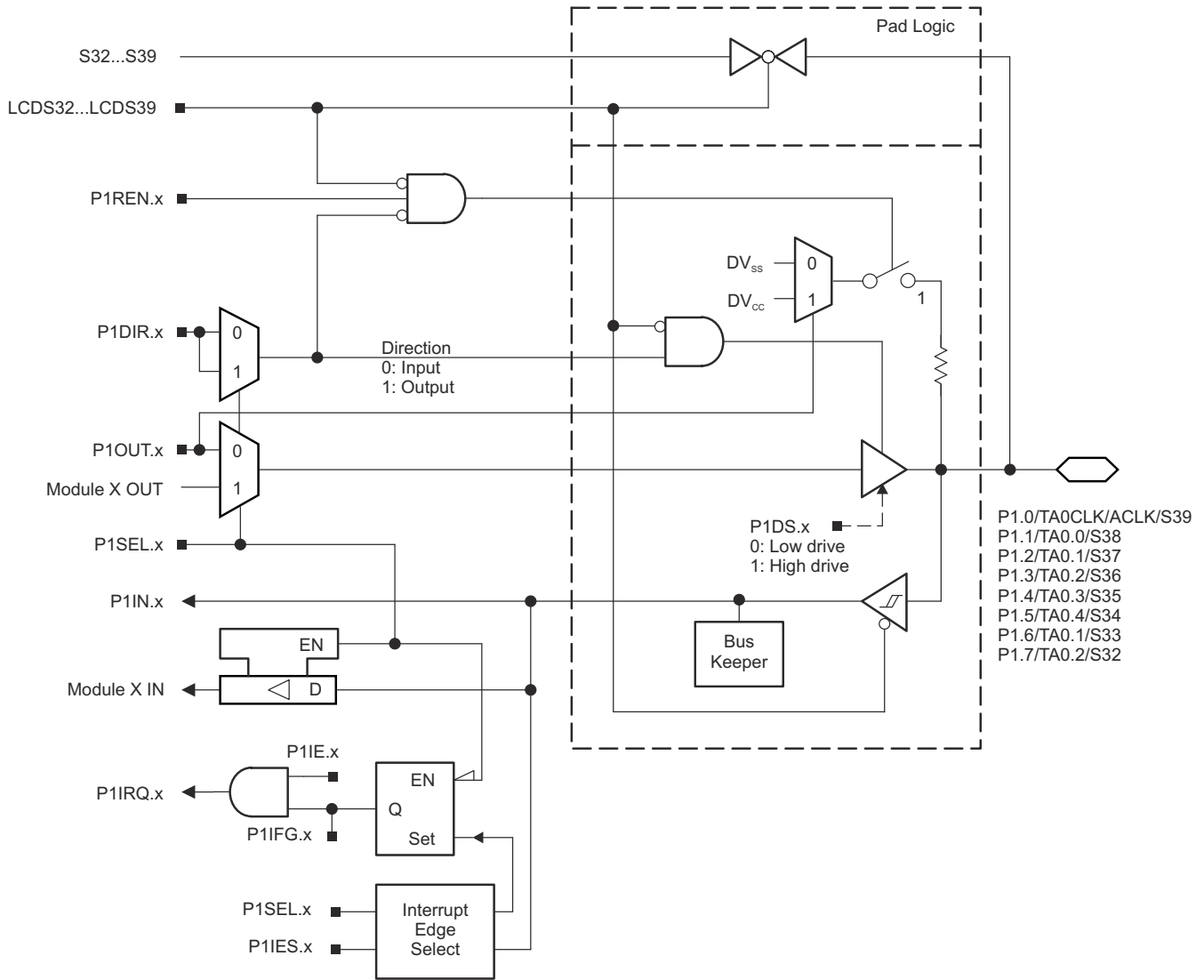


图 9-2. Port P1 (P1.0 to P1.7) Diagram

表 9-52. Port P1 (P1.0 to P1.7) Pin Functions

PIN NAME (P1.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾		
			P1DIR.x	P1SEL.x	LCDS32...39
P1.0/TA0CLK/ACLK/ S39	0	P1.0 (I/O)	I: 0; O: 1	0	0
		Timer TA0.TA0CLK	0	1	0
		ACLK	1	1	0
		S39	X	X	1
P1.1/TA0.0/S38	1	P1.1 (I/O)	I: 0; O: 1	0	0
		Timer TA0.CCI0A capture input	0	1	0
		Timer TA0.0 output	1	1	0
		S38	X	X	1
P1.2/TA0.1/S37	2	P1.2 (I/O)	I: 0; O: 1	0	0
		Timer TA0.CCI1A capture input	0	1	0
		Timer TA0.1 output	1	1	0
		S37	X	X	1
P1.3/TA0.2/S36	3	P1.3 (I/O)	I: 0; O: 1	0	0
		Timer TA0.CCI2A capture input	0	1	0
		Timer TA0.2 output	1	1	0
		S36	X	X	1
P1.4/TA0.3/S35	4	P1.4 (I/O)	I: 0; O: 1	0	0
		Timer TA0.CCI3A capture input	0	1	0
		Timer TA0.3 output	1	1	0
		S35	X	X	1
P1.5/TA0.4/S34	5	P1.5 (I/O)	I: 0; O: 1	0	0
		Timer TA0.CCI4A capture input	0	1	0
		Timer TA0.4 output	1	1	0
		S34	X	X	1
P1.6/TA0.1/S33	6	P1.6 (I/O)	I: 0; O: 1	0	0
		Timer TA0.CCI1B capture input	0	1	0
		Timer TA0.1 output	1	1	0
		S33	X	X	1
P1.7/TA0.2/S32	7	P1.7 (I/O)	I: 0; O: 1	0	0
		Timer TA0.CCI2B capture input	0	1	0
		Timer TA0.2 output	1	1	0
		S32	X	X	1

9.13.2 Port P2 (P2.0 to P2.7) Input/Output With Schmitt Trigger

图 9-3 shows the pin diagram. 表 9-53 summarizes how to select the pin function.

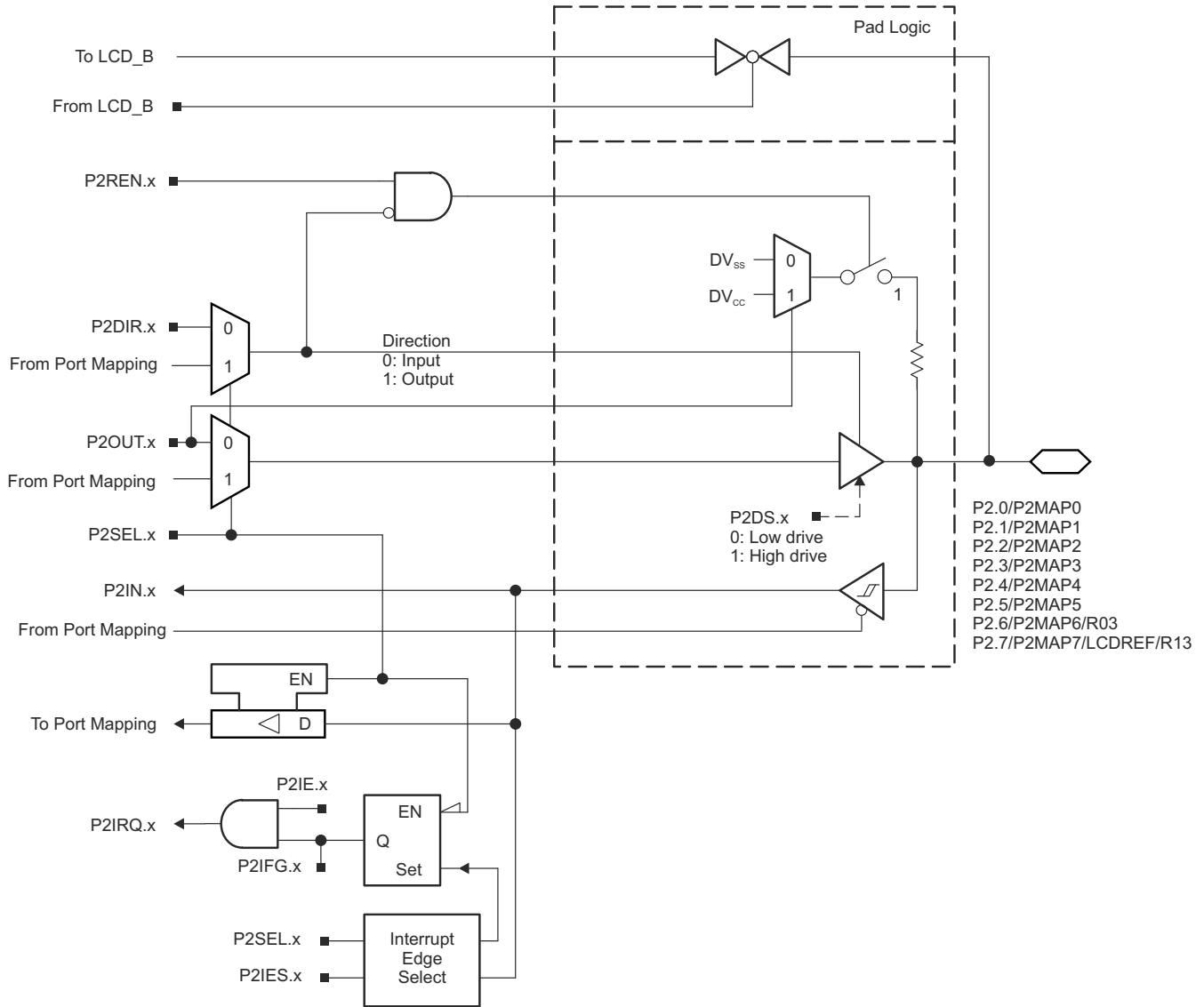


图 9-3. Port P2 (P2.0 to P2.7) Diagram

表 9-53. Port P2 (P2.0 to P2.7) Pin Functions

PIN NAME (P2.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾		
			P2DIR.x	P2SEL.x	P2MAPx
P2.0/P2MAP0	0	P2.0 (I/O)	I: 0; O: 1	0	
		Mapped secondary digital function	X	1	≤ 19
P2.1/P2MAP1	1	P2.1 (I/O)	I: 0; O: 1	0	
		Mapped secondary digital function	X	1	≤ 19
P2.2/P2MAP2	2	P2.2 (I/O)	I: 0; O: 1	0	
		Mapped secondary digital function	X	1	≤ 19
P2.3/P2MAP3	3	P2.3 (I/O)	I: 0; O: 1	0	
		Mapped secondary digital function	X	1	≤ 19
P2.4/P2MAP4	4	P2.4 (I/O)	I: 0; O: 1	0	
		Mapped secondary digital function	X	1	≤ 19
P2.5/P2MAP5	5	P2.5 (I/O)	I: 0; O: 1	0	
		Mapped secondary digital function	X	1	≤ 19
P2.6/P2MAP6/R03	6	P2.6 (I/O)	I: 0; O: 1	0	
		Mapped secondary digital function	X	1	≤ 19
		R03	X	1	= 31
P2.7/P2MAP7/ LCDREF/R13	7	P2.7 (I/O)	I: 0; O: 1	0	
		Mapped secondary digital function	X	1	≤ 19
		LCDREF/R13	X	1	= 31

9.13.3 Port P3 (P3.0 to P3.7) Input/Output With Schmitt Trigger

图 9-4 shows the pin diagram. 表 9-54 summarizes how to select the pin function.

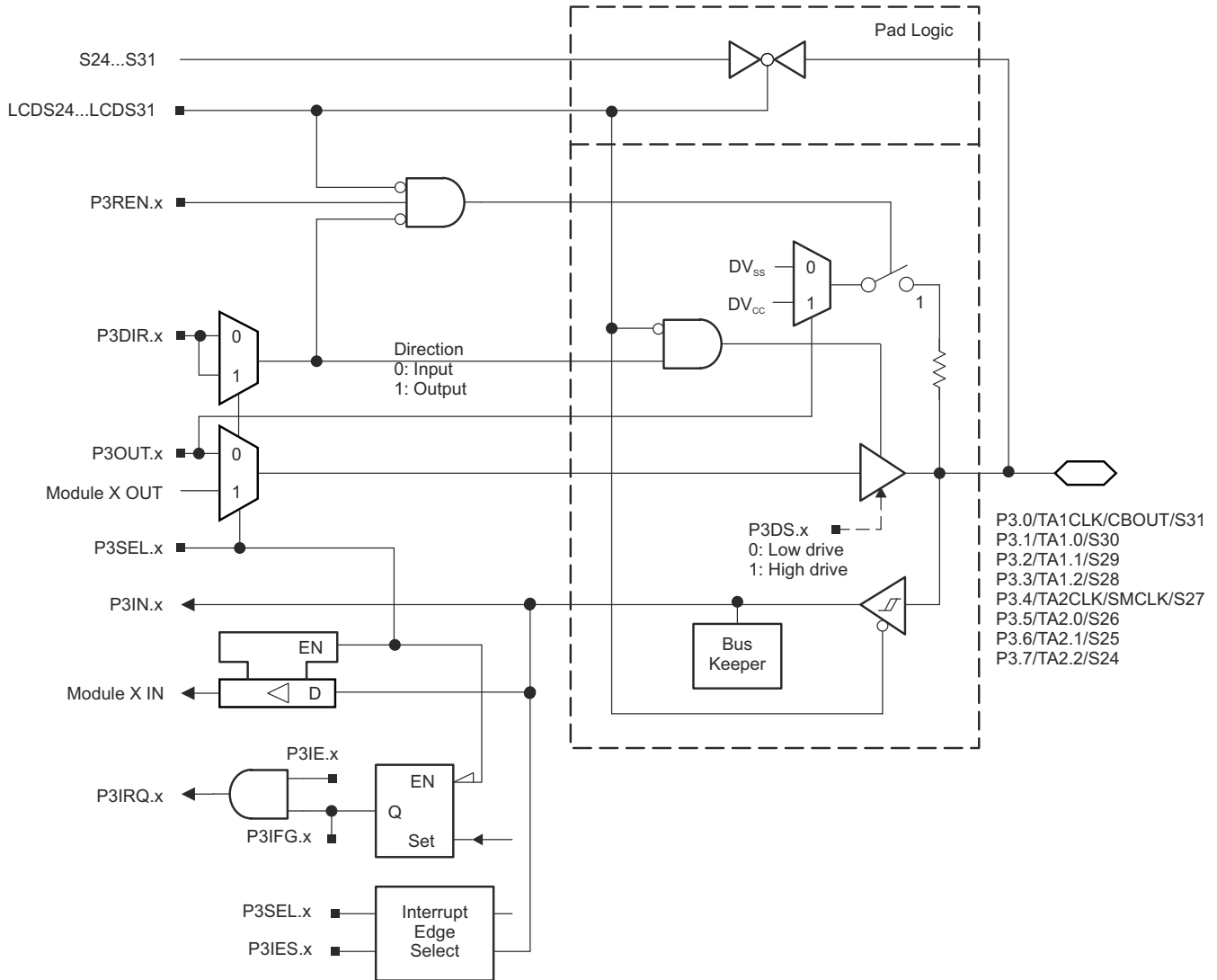


图 9-4. Port P3 (P3.0 to P3.7) Diagram

表 9-54. Port P3 (P3.0 to P3.7) Pin Functions

PIN NAME (P3.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾		
			P3DIR.x	P3SEL.x	LCDS24...31
P3.0/TA1CLK/ CBOUT/S31	0	P3.0 (I/O)	I: 0; O: 1	0	0
		Timer TA1.TA1CLK	0	1	0
		CBOUT	1	1	0
		S31	X	X	1
P3.1/TA1.0/S30	1	P3.1 (I/O)	I: 0; O: 1	0	0
		Timer TA1.CCI0A capture input	0	1	0
		Timer TA1.0 output	1	1	0
		S30	X	X	1
P3.2/TA1.1/S29	2	P3.2 (I/O)	I: 0; O: 1	0	0
		Timer TA1.CCI1A capture input	0	1	0
		Timer TA1.1 output	1	1	0
		S29	X	X	1
P3.3/TA1.2/S28	3	P3.3 (I/O)	I: 0; O: 1	0	0
		Timer TA1.CCI2A capture input	0	1	0
		Timer TA1.2 output	1	1	0
		S28	X	X	1
P3.4/TA2CLK/ SMCLK/S27	4	P3.4 (I/O)	I: 0; O: 1	0	0
		Timer TA2.TA2CLK	0	1	0
		SMCLK	1	1	0
		S27	X	X	1
P3.5/TA2.0/S26	5	P3.5 (I/O)	I: 0; O: 1	0	0
		Timer TA2.CCI0A capture input	0	1	0
		Timer TA2.0 output	1	1	0
		S26	X	X	1
P3.6/TA2.1/S25	6	P3.6 (I/O)	I: 0; O: 1	0	0
		Timer TA2.CCI1A capture input	0	1	0
		Timer TA2.1 output	1	1	1
		S25	X	X	1
P3.7/TA2.2/S24	7	P3.7 (I/O)	I: 0; O: 1	0	0
		Timer TA2.CCI2A capture input	0	1	0
		Timer TA2.2 output	1	1	0
		S24	X	X	1

9.13.4 Port P4 (P4.0 to P4.7) Input/Output With Schmitt Trigger

图 9-5 shows the pin diagram. 表 9-55 summarizes how to select the pin function.

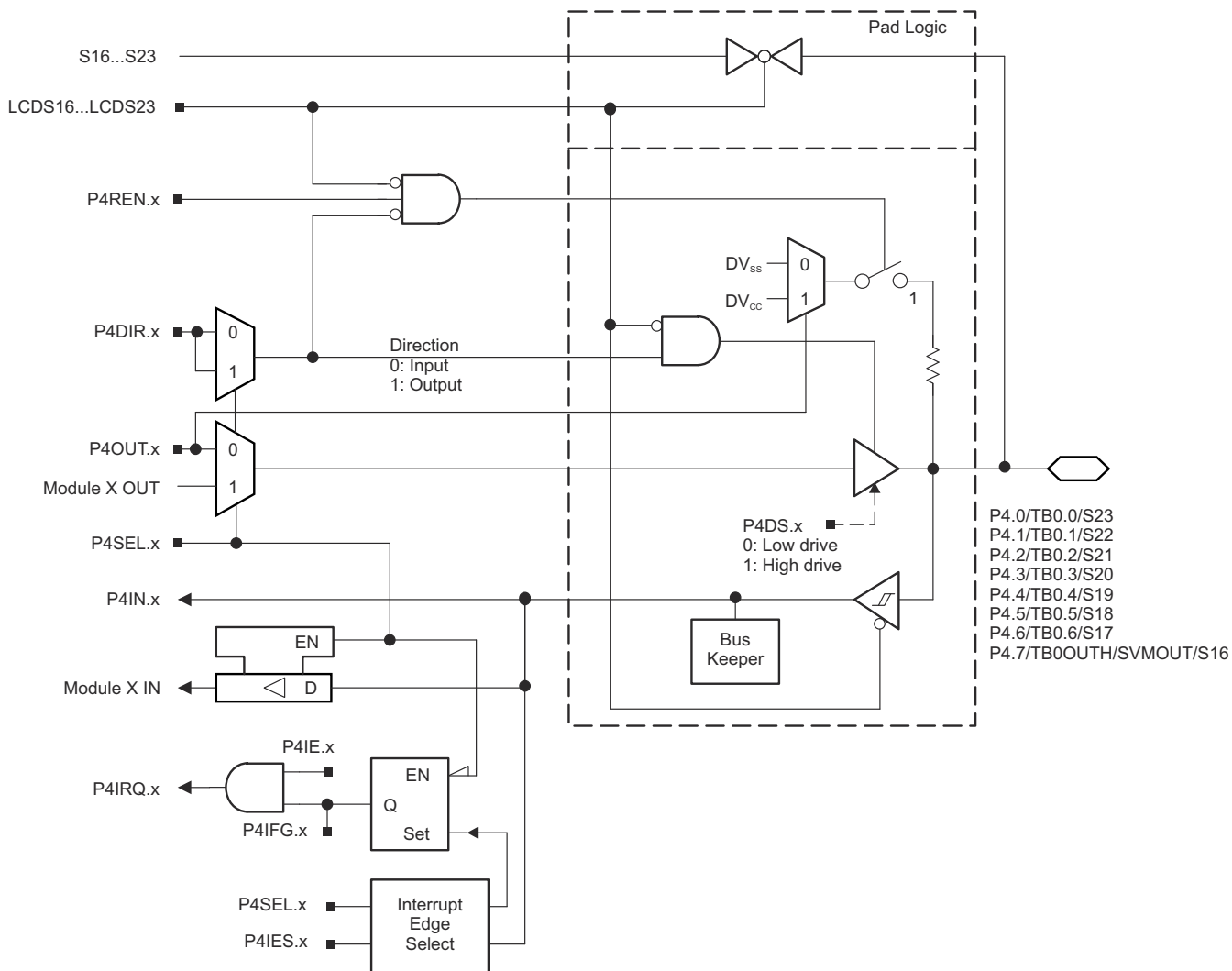


图 9-5. Port P4 (P4.0 to P4.7) Diagram

表 9-55. Port P4 (P4.0 to P4.7) Pin Functions

PIN NAME (P4.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾		
			P4DIR.x	P4SEL.x	LCDS16...23
P4.0/TB0.0/S23	0	P4.0 (I/O)	I: 0; O: 1	0	0
		Timer TB0.CCI0A capture input	0	1	0
		Timer TB0.0 output ⁽¹⁾	1	1	0
		S23	X	X	1
P4.1/TB0.1/S22	1	P4.1 (I/O)	I: 0; O: 1	0	0
		Timer TB0.CCI1A capture input	0	1	0
		Timer TB0.1 output ⁽¹⁾	1	1	0
		S22	X	X	1
P4.2/TB0.2/S21	2	P4.2 (I/O)	I: 0; O: 1	0	0
		Timer TB0.CCI2A capture input	0	1	0
		Timer TB0.2 output ⁽¹⁾	1	1	0
		S21	X	X	1
P4.3/TB0.3/S20	3	P4.3 (I/O)	I: 0; O: 1	0	0
		Timer TB0.CCI3A capture input	0	1	0
		Timer TB0.3 output ⁽¹⁾	1	1	0
		S20	X	X	1
P4.4/TB0.4/S19	4	P4.4 (I/O)	I: 0; O: 1	0	0
		Timer TB0.CCI4A capture input	0	1	0
		Timer TB0.4 output ⁽¹⁾	1	1	0
		S19	X	X	1
P4.5/TB0.5/S18	5	P4.5 (I/O)	I: 0; O: 1	0	0
		Timer TB0.CCI5A capture input	0	1	0
		Timer TB0.5 output ⁽¹⁾	1	1	0
		S18	X	X	1
P4.6/TB0.6/S17	6	P4.6 (I/O)	I: 0; O: 1	0	0
		Timer TB0.CCI6A capture input	0	1	0
		Timer TB0.6 output ⁽¹⁾	1	1	0
		S17	X	X	1
P4.7/TB0OUTH/ SVMOUT/S16	7	P4.7 (I/O)	I: 0; O: 1	0	0
		Timer TB0.TB0OUTH	0	1	0
		SVMOUT	1	1	0
		S16	X	X	1

(1) Setting TB0OUTH causes all Timer_B configured outputs to be set to high impedance.

9.13.5 Port P5 (P5.0 and P5.1) Input/Output With Schmitt Trigger

图 9-6 shows the pin diagram. 表 9-56 summarizes how to select the pin function.

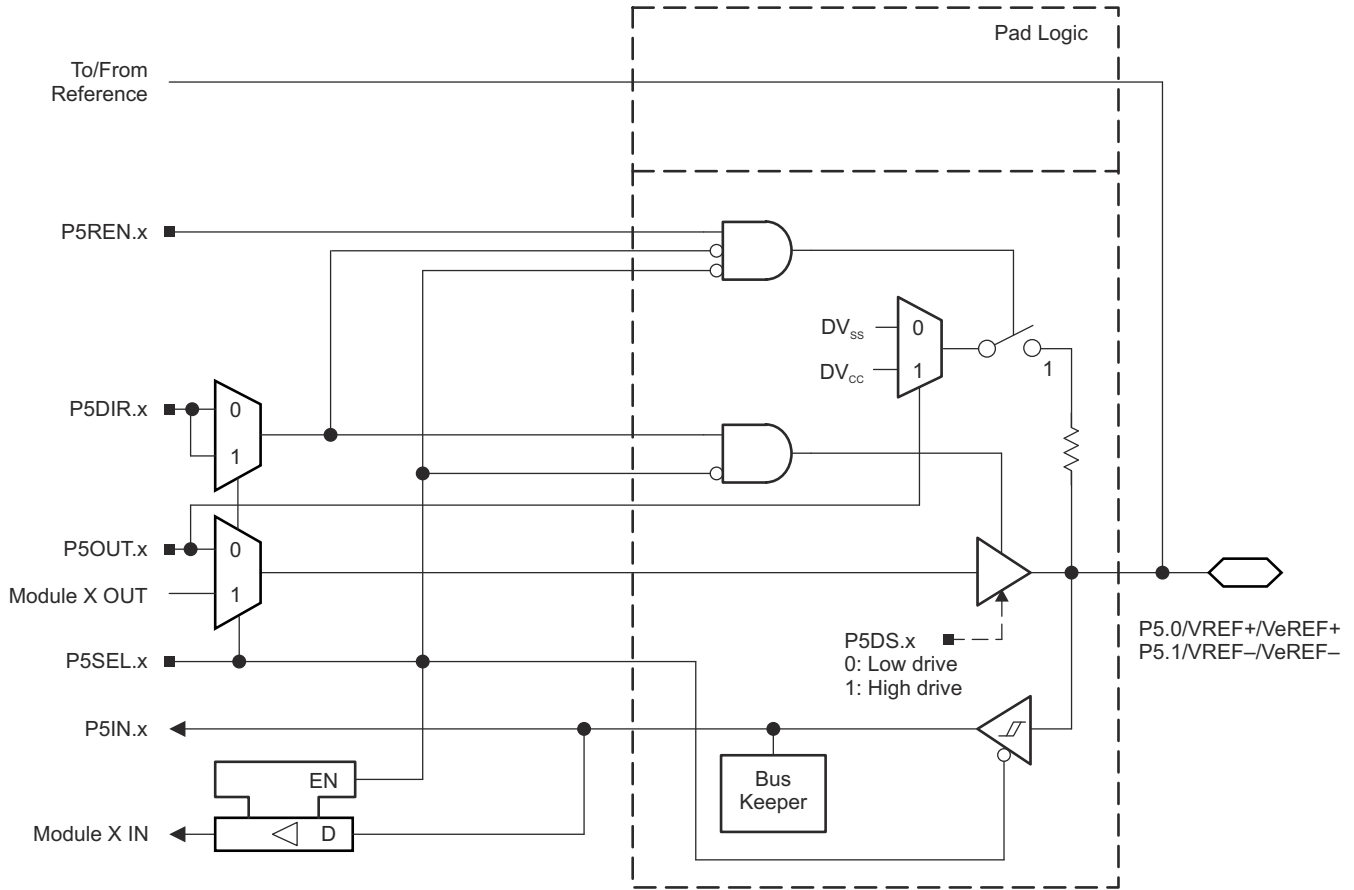


图 9-6. Port P5 (P5.0 and P5.1) Diagram

表 9-56. Port P5 (P5.0 and P5.1) Pin Functions

PIN NAME (P5.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾		
			P5DIR.x	P5SEL.x	REFOUT
P5.0/VREF+/VeREF+	0	P5.0 (I/O) ⁽²⁾	I: 0; O: 1	0	X
		VeREF+ ⁽³⁾	X	1	0
		VREF+ ⁽⁴⁾	X	1	1
P5.1/VREF-/VeREF-	1	P5.1 (I/O) ⁽²⁾	I: 0; O: 1	0	X
		VeREF- ⁽⁵⁾	X	1	0
		VREF- ⁽⁶⁾	X	1	1

(1) X = Don't care

(2) Default condition

(3) Setting the P5SEL.0 bit disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. An external voltage can be applied to VeREF+ and used as the reference for the ADC12_A, Comparator_B, or DAC12_A.

(4) Setting the P5SEL.0 bit disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. The ADC12_A VREF+ reference is available at the pin.

(5) Setting the P5SEL.1 bit disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. An external voltage can be applied to VeREF- and used as the reference for the ADC12_A, Comparator_B, or DAC12_A.

(6) Setting the P5SEL.1 bit disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. The ADC12_A VREF- reference is available at the pin.

图 9-8 shows the pin diagram. 表 9-58 summarizes how to select the pin function.

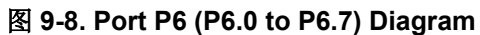


表 9-58. Port P6 (P6.0 to P6.7) Pin Functions

PIN NAME (P6.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾				
			P6DIR.x	P6SEL.x	CBPD.x	DAC12OPS	DAC12AMPx
P6.0/CB0/A0	0	P6.0 (I/O)	I: 0; O: 1	0	0	n/a	n/a
		CB0	X	X	1	n/a	n/a
		A0 ^{(1) (2)}	X	1	X	n/a	n/a
P6.1/CB1/A1	1	P6.1 (I/O)	I: 0; O: 1	0	0	n/a	n/a
		CB1	X	X	1	n/a	n/a
		A1 ^{(1) (2)}	X	1	X	n/a	n/a
P6.2/CB2/A2	2	P6.2 (I/O)	I: 0; O: 1	0	0	n/a	n/a
		CB2	X	X	1	n/a	n/a
		A2 ^{(1) (2)}	X	1	X	n/a	n/a
P6.3/CB3/A3	3	P6.3 (I/O)	I: 0; O: 1	0	0	n/a	n/a
		CB3	X	X	1	n/a	n/a
		A3 ^{(1) (2)}	X	1	X	n/a	n/a
P6.4/CB4/A4	4	P6.4 (I/O)	I: 0; O: 1	0	0	n/a	n/a
		CB4	X	X	1	n/a	n/a
		A4 ^{(1) (2)}	X	1	X	n/a	n/a
P6.5/CB5/A5	5	P6.5 (I/O)	I: 0; O: 1	0	0	n/a	n/a
		CB5	X	X	1	n/a	n/a
		A5 ^{(1) (2)}	X	1	X	n/a	n/a
P6.6/CB6/A6/DAC0	6	P6.6 (I/O)	I: 0; O: 1	0	0	X	0
		CB6	X	X	1	X	0
		A6 ^{(1) (2)}	X	1	X	X	0
		DAC0	X	X	X	0	>1
P6.7/CB7/A7/DAC1	7	P6.7 (I/O)	I: 0; O: 1	0	0	X	0
		CB7	X	X	1	X	0
		A7 ^{(1) (2)}	X	1	X	X	0
		DAC1	X	X	X	0	>1

- (1) Setting the P6SEL.x bit disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.
- (2) The ADC12_A channel Ax is connected internally to AV_{SS} if not selected by the respective INCHx bits.

9.13.8 Port P7 (P7.2) Input/Output With Schmitt Trigger

图 9-9 shows the pin diagram. 表 9-59 summarizes how to select the pin function.

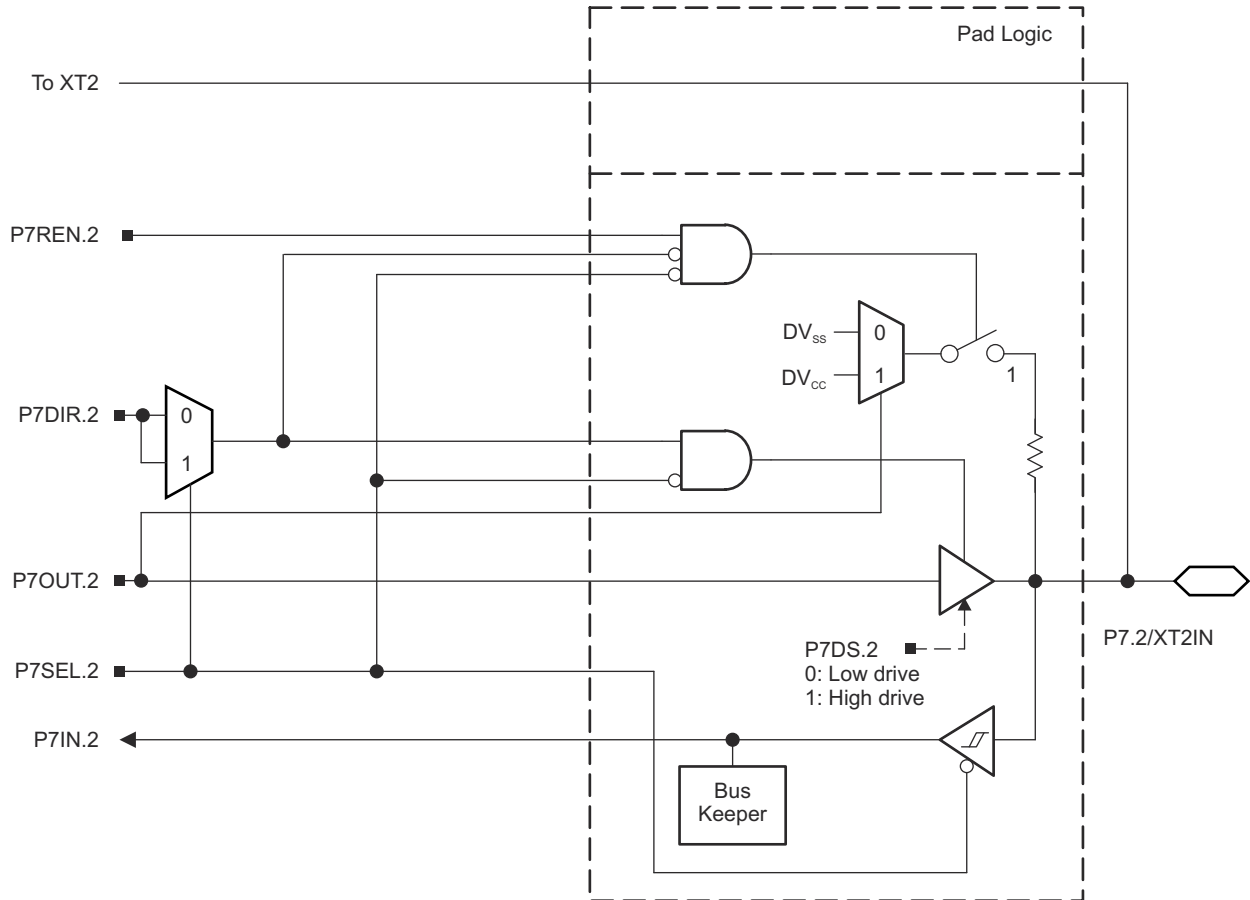


图 9-9. Port P7 (P7.2) Diagram

9.13.9 Port P7 (P7.3) Input/Output With Schmitt Trigger

图 9-10 shows the pin diagram. 表 9-59 summarizes how to select the pin function.

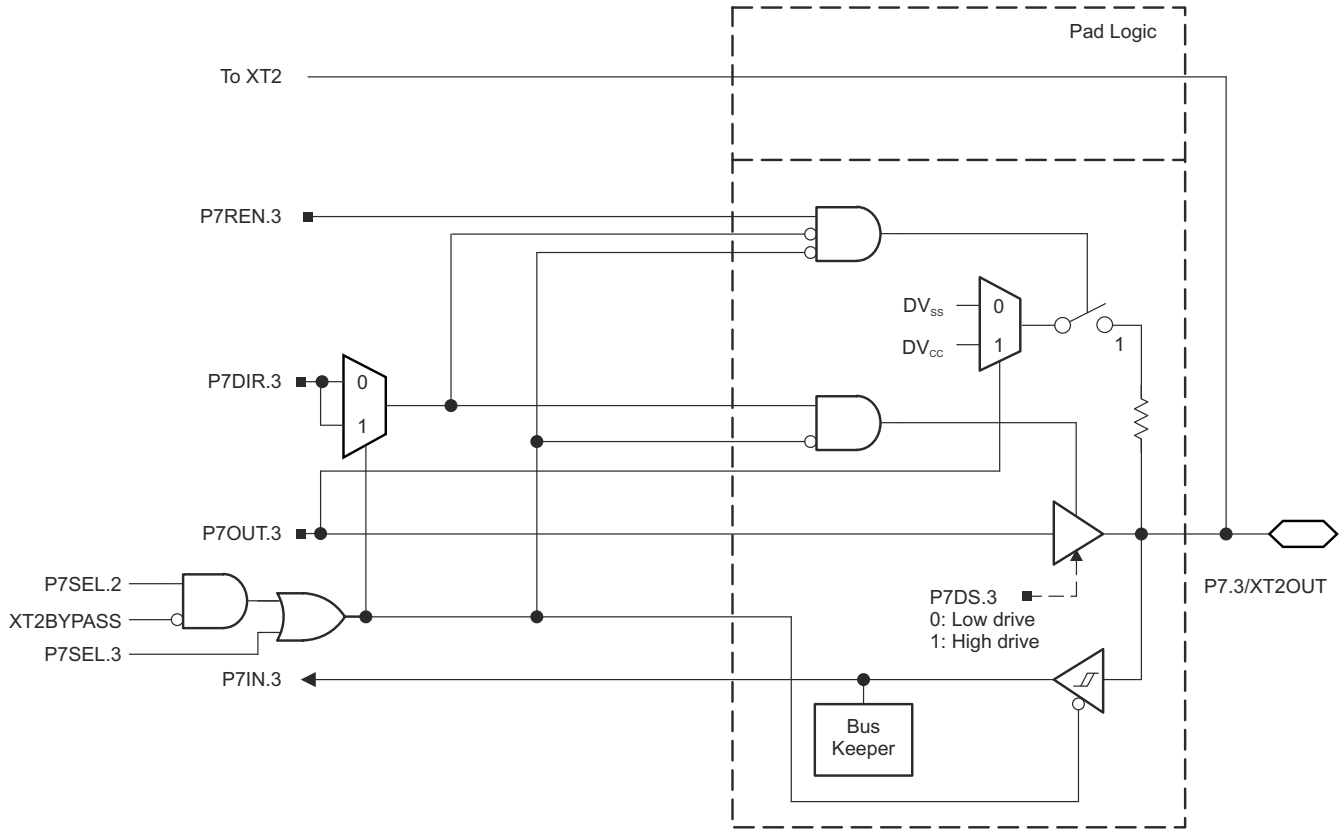


图 9-10. Port P7 (P7.3) Diagram

表 9-59. Port P7 (P7.2 and P7.3) Pin Functions

PIN NAME (P5.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾			
			P7DIR.x	P7SEL.2	P7SEL.3	XT2BYPASS
P7.2/XT2IN	2	P7.2 (I/O)	I: 0; O: 1	0	X	X
		XT2IN crystal mode ⁽¹⁾	X	1	X	0
		XT2IN bypass mode ⁽¹⁾	X	1	X	1
P7.3/XT2OUT	3	P7.3 (I/O)	I: 0; O: 1	0	0	X
		XT2OUT crystal mode ⁽²⁾	X	1	X	0
		P7.3 (I/O) ⁽²⁾	X	1	0	1

(1) Setting P7SEL.2 causes the general-purpose I/O to be disabled. Pending the setting of XT2BYPASS, P7.2 is configured for crystal mode or bypass mode.

(2) Setting P7SEL.2 causes the general-purpose I/O to be disabled in crystal mode. When using bypass mode, P7.3 can be used as general-purpose I/O.

9.13.10 Port P7 (P7.4 to P7.7) Input/Output With Schmitt Trigger

图 9-11 shows the pin diagram. 表 9-60 summarizes how to select the pin function.

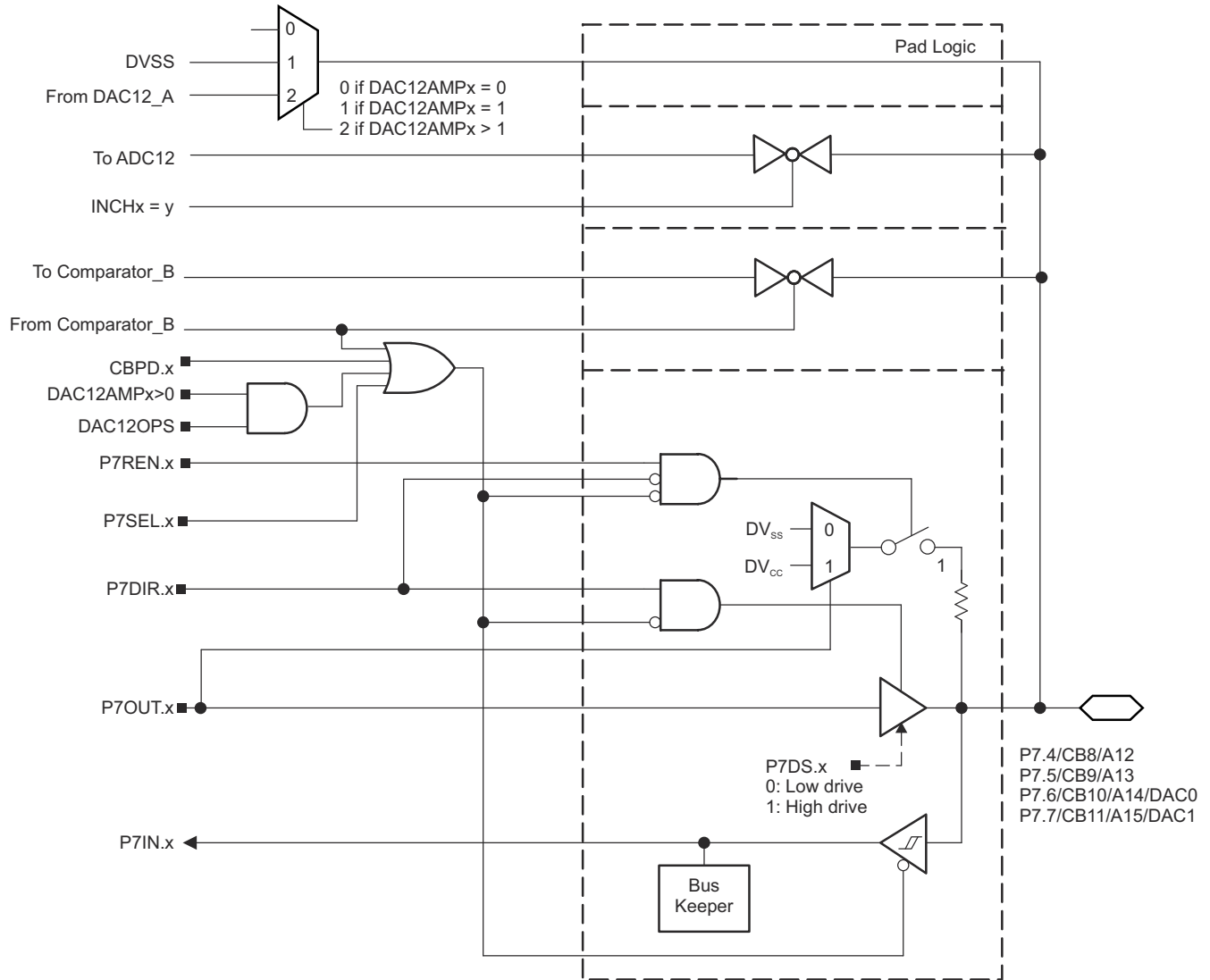


图 9-11. Port P7 (P7.4 to P7.7) Diagram

表 9-60. Port P7 (P7.4 to P7.7) Pin Functions

PIN NAME (P7.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾				
			P7DIR.x	P7SEL.x	CBPD.x	DAC12OPS	DAC12AMPx
P7.4/CB8/A12	4	P7.4 (I/O)	I: 0; O: 1	0	0	n/a	n/a
		Comparator_B input CB8	X	X	1	n/a	n/a
		A12 ^{(1) (2)}	X	1	X	n/a	n/a
P7.5/CB9/A13	5	P7.5 (I/O)	I: 0; O: 1	0	0	n/a	n/a
		Comparator_B input CB9	X	X	1	n/a	n/a
		A13 ^{(1) (2)}	X	1	X	n/a	n/a
P7.6/CB10/A14/DAC0	6	P7.6 (I/O)	I: 0; O: 1	0	0	X	0
		Comparator_B input CB10	X	X	1	X	0
		A14 ^{(1) (2)}	X	1	X	X	0
		DAC12_A output DAC0	X	X	X	1	>1
P7.7/CB11/A15/DAC1	7	P7.7 (I/O)	I: 0; O: 1	0	0	X	0
		Comparator_B input CB11	X	X	1	X	0
		A15 ^{(1) (2)}	X	1	X	X	0
		DAC12_A output DAC1	X	X	X	1	>1

- (1) Setting the P7SEL.x bit disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.
- (2) The ADC12_A channel Ax is connected internally to AV_{SS} if not selected by the respective INCHx bits.

9.13.11 Port P8 (P8.0 to P8.7) Input/Output With Schmitt Trigger

图 9-12 shows the pin diagram. 表 9-61 summarizes how to select the pin function.

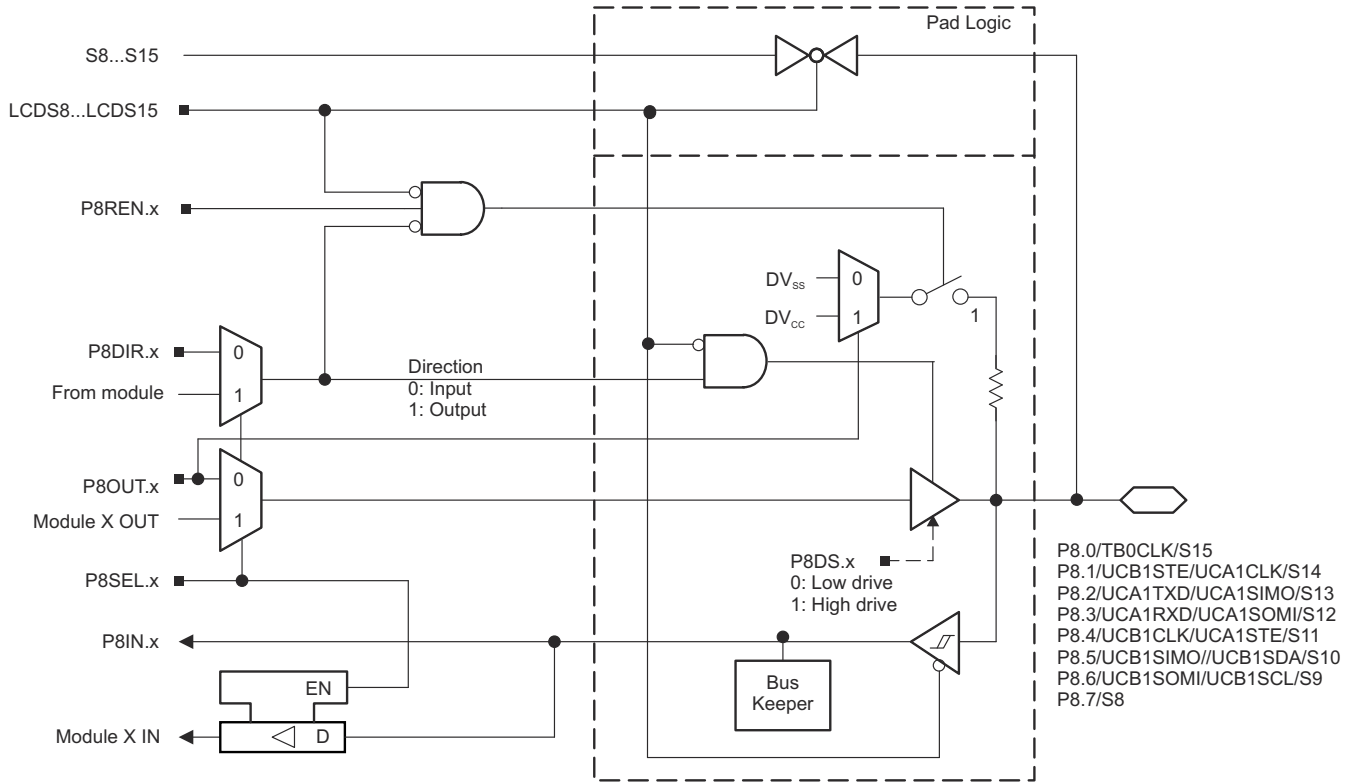


图 9-12. Port P8 (P8.0 to P8.7) Diagram

表 9-61. Port P8 (P8.0 to P8.7) Pin Functions

PIN NAME (P9.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾		
			P8DIR.x	P8SEL.x	LCDS8...16
P8.0/TB0CLK/S15	0	P8.0 (I/O)	I: 0; O: 1	0	0
		Timer TB0.TB0CLK clock input	0	1	0
		S15	X	X	1
P8.1/UCB1STE/UCA1CLK/S14	1	P8.1 (I/O)	I: 0; O: 1	0	0
		UCB1STE/UCA1CLK	X	1	0
		S14	X	X	1
P8.2/UCA1TXD/UCA1SIMO/S13	2	P8.2 (I/O)	I: 0; O: 1	0	0
		UCA1TXD/UCA1SIMO	X	1	0
		S13	X	X	1
P8.3/UCA1RXD/UCA1SOMI/S12	3	P8.3 (I/O)	I: 0; O: 1	0	0
		UCA1RXD/UCA1SOMI	X	1	0
		S12	X	X	1
P8.4/UCB1CLK/UCA1STE/S11	4	P8.4 (I/O)	I: 0; O: 1	0	0
		UCB1CLK/UCA1STE	X	1	0
		S11	X	X	1
P8.5/UCB1SIMO/UCB1SDA/S10	5	P8.5 (I/O)	I: 0; O: 1	0	0
		UCB1SIMO/UCB1SDA	X	1	0
		S10	X	X	1
P8.6/UCB1SOMI/UCB1SCL/S9	6	P8.6 (I/O)	I: 0; O: 1	0	0
		UCB1SOMI/UCB1SCL	X	1	0
		S9	X	X	1
P8.7/S8	7	P8.7 (I/O)	I: 0; O: 1	0	0
		S8	X	X	1

图 9-13 shows the pin diagram. 表 9-62 summarizes how to select the pin function.

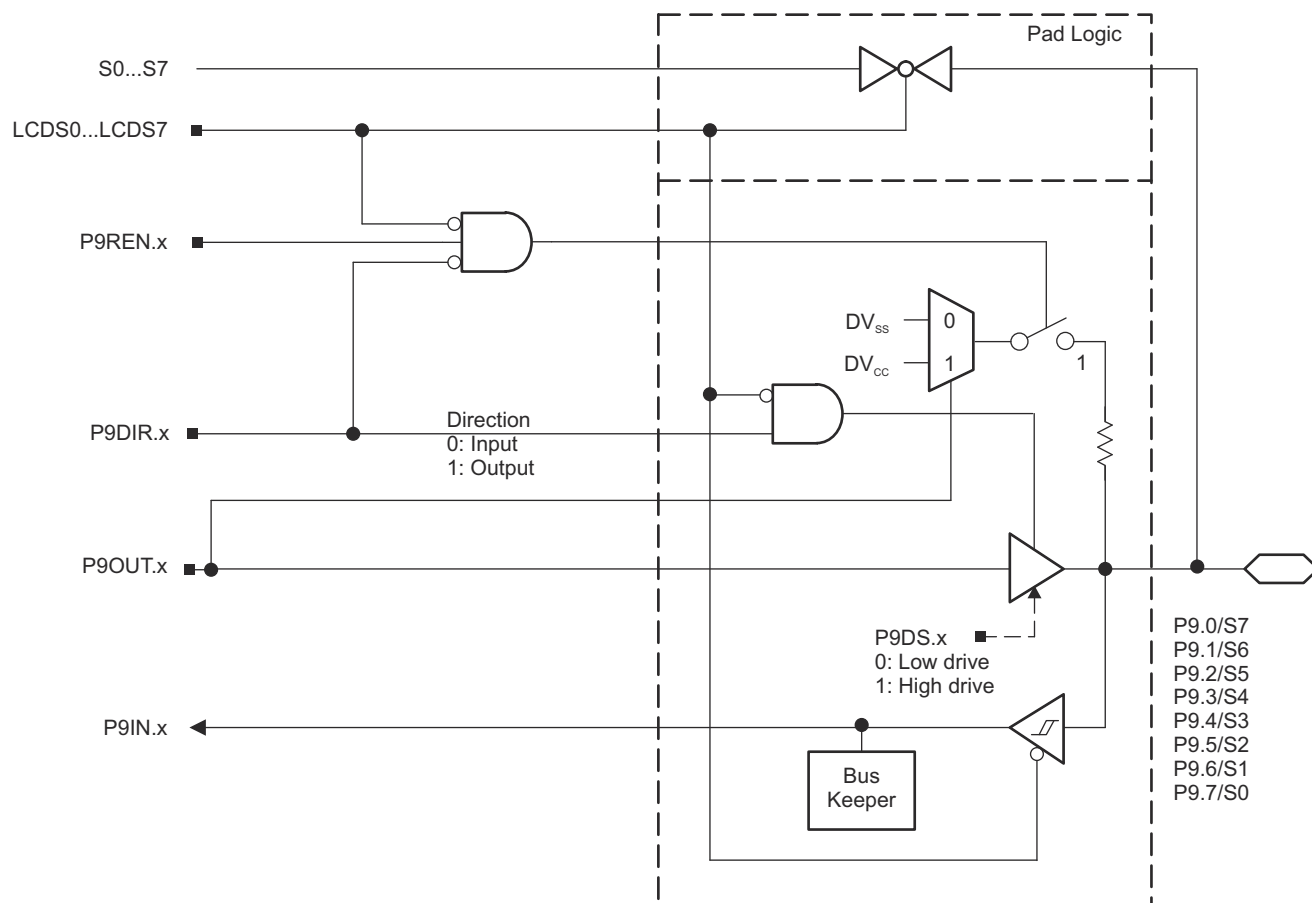


图 9-13. Port P9 (P9.0 to P9.7) Diagram

表 9-62. Port P9 (P9.0 to P9.7) Pin Functions

PIN NAME (P9.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾		
			P9DIR.x	P9SEL.x	LCDS0...7
P9.0/S7	0	P9.0 (I/O)	I: 0; O: 1	0	0
		S7	X	X	1
P9.1/S6	1	P9.1 (I/O)	I: 0; O: 1	0	0
		S6	X	X	1
P9.2/S5	2	P9.2 (I/O)	I: 0; O: 1	0	0
		S5	X	X	1
P9.3/S4	3	P9.3 (I/O)	I: 0; O: 1	0	0
		S4	X	X	1
P9.4/S3	4	P9.4 (I/O)	I: 0; O: 1	0	0
		S3	X	X	1
P9.5/S2	5	P9.5 (I/O)	I: 0; O: 1	0	0
		S2	X	X	1
P9.6/S1	6	P9.6 (I/O)	I: 0; O: 1	0	0
		S1	X	X	1
P9.7/S0	7	P9.7 (I/O)	I: 0; O: 1	0	0
		S0	X	X	1

9.13.13 Port PU (PU.0/DP, PU.1/DM, PUR) USB Ports

图 9-14 shows the pin diagram. 表 9-63 summarizes how to select the pin function.

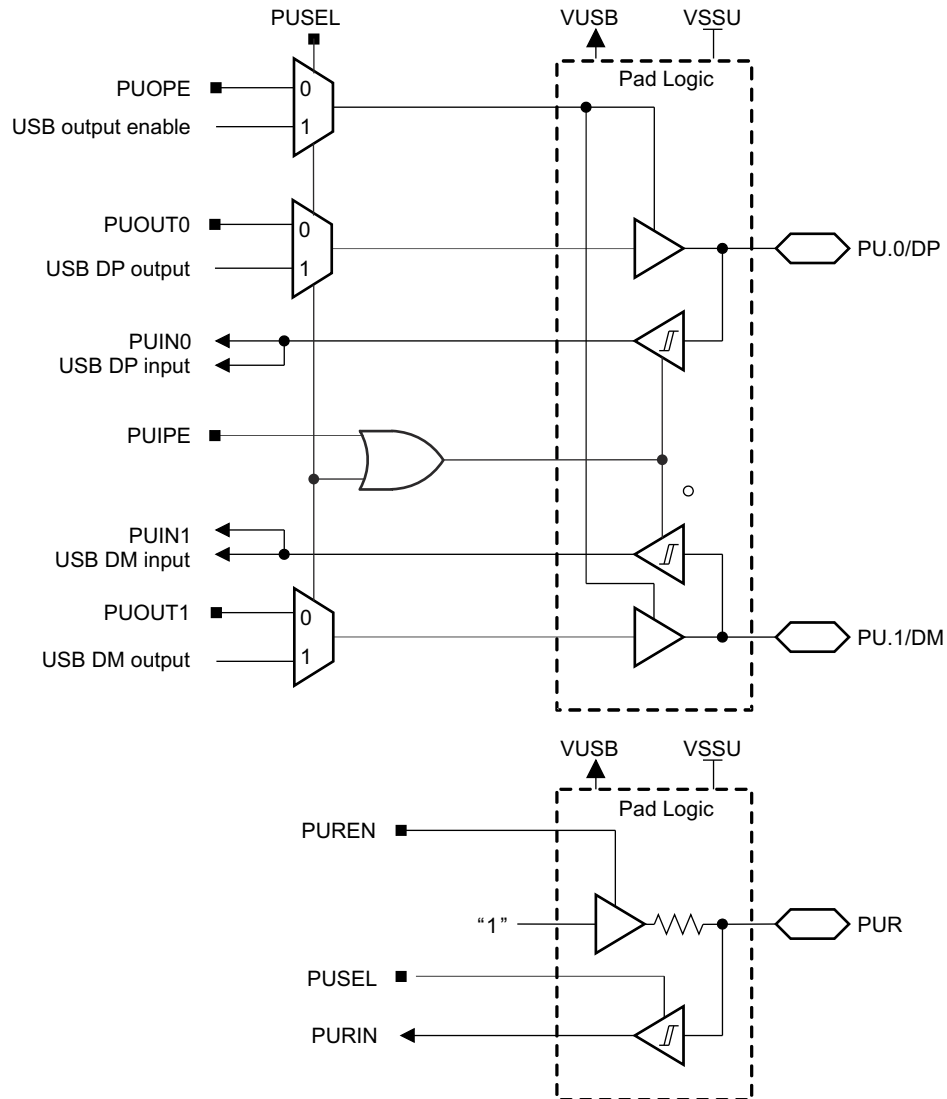


图 9-14. Port PU (PU.0 and PU.1) Diagram

表 9-63. Port PU.0/DP and PU.1/DM Output Functions

CONTROL BITS				PIN NAME		FUNCTION
PUSEL	PUDIR	PUOUT1	PUOUT0	PU.1/DM	PU.0/DP	
0	0	X	X	Hi-Z	Hi-Z	Outputs off
0	1	0	0	0	0	Outputs enabled
0	1	0	1	0	1	Outputs enabled
0	1	1	0	1	0	Outputs enabled
0	1	1	1	1	1	Outputs enabled
1	X	X	X	DM	DP	Direction set by USB module

CONTROL BITS		FUNCTION
PUSEL	PUREN	
0	0	Input disabled Pullup disabled
0	1	Input disabled Pullup enabled
1	0	Input enabled Pullup disabled
1	1	Input enabled Pullup enabled

图 9-15 shows the pin diagram. 表 9-65 summarizes how to select the pin function.

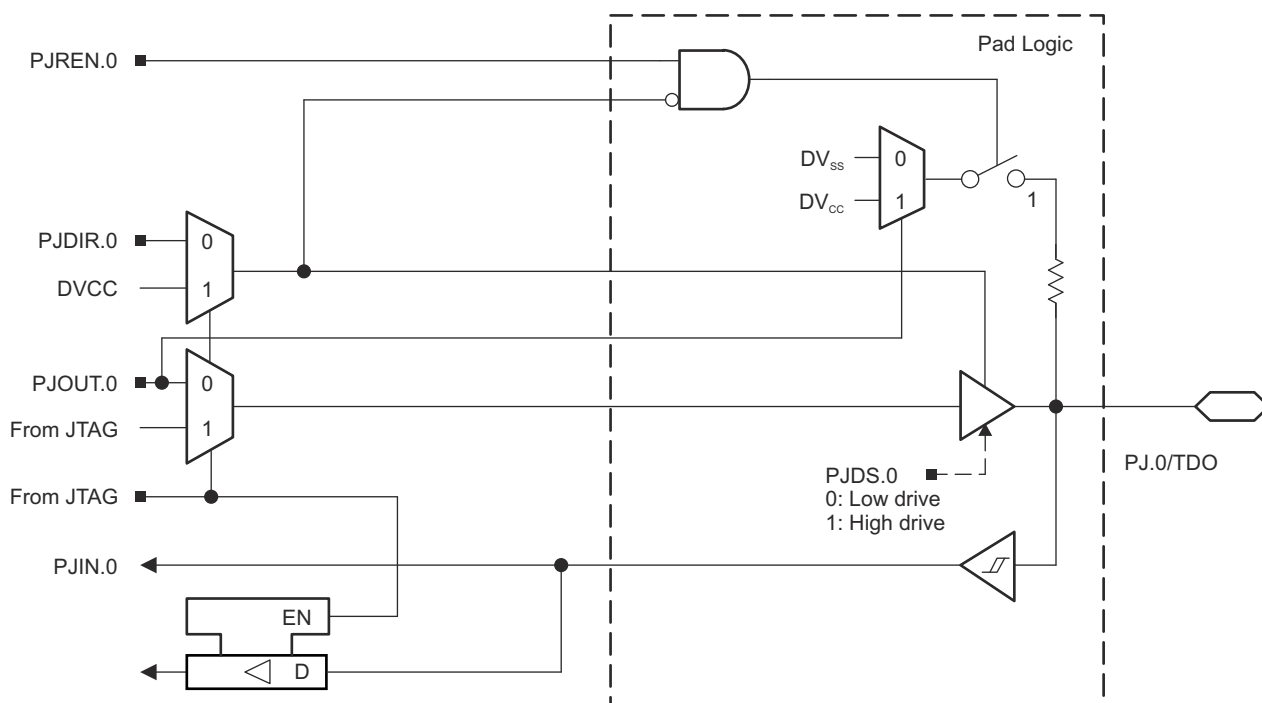


图 9-15. Port J (PJ.0) Diagram

9.13.15 Port PJ (PJ.1 to PJ.3) JTAG Pins TMS, TCK, TDI/TCLK, Input/Output With Schmitt Trigger or Output

图 9-16 shows the pin diagram. 表 9-65 summarizes how to select the pin function.

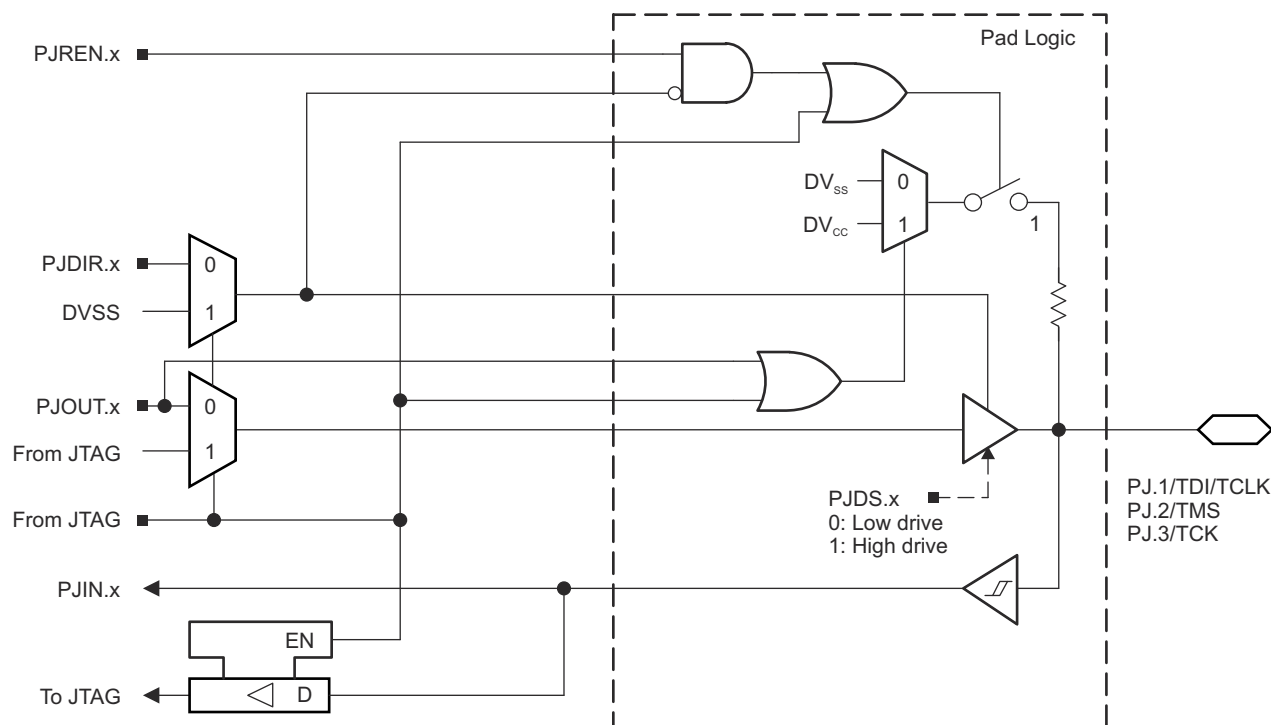


图 9-16. Port PJ (PJ.1 to PJ.3) Diagram

表 9-65. Port PJ (PJ.0 to PJ.3) Pin Functions

PIN NAME (PJ.x)	x	FUNCTION	CONTROL BITS OR SIGNALS ⁽¹⁾
			PJDIR.x
PJ.0/TDO	0	PJ.0 (I/O) ⁽¹⁾	I: 0; O: 1
		TDO ⁽²⁾	X
PJ.1/TDI/TCLK	1	PJ.1 (I/O) ⁽¹⁾	I: 0; O: 1
		TDI/TCLK ^{(2) (3)}	X
PJ.2/TMS	2	PJ.2 (I/O) ⁽¹⁾	I: 0; O: 1
		TMS ^{(2) (3)}	X
PJ.3/TCK	3	PJ.3 (I/O) ⁽¹⁾	I: 0; O: 1
		TCK ^{(2) (3)}	X

(1) Default condition

(2) The pin direction is controlled by the JTAG module.

(3) In JTAG mode, pullups are activated automatically on TMS, TCK, and TDI/TCLK. PJREN.x are don't care.

9.14 Device Descriptors

表 9-66 list the contents of the device descriptor tag-length-value (TLV) structure.

表 9-66. MSP430F663x Device Descriptor Table

DESCRIPTION ⁽¹⁾		ADDRESS	SIZE (bytes)	VALUE								
				F6638	F6637	F6636	F6635	F6634	F6633	F6632	F6631	F6630
Info Block	Info length	01A00h	1	06h	06h	06h	06h	06h	06h	06h	06h	06h
	CRC length	01A01h	1	06h	06h	06h	06h	06h	06h	06h	06h	06h
	CRC value	01A02h	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit
	Device ID	01A04h	2	801Ch	801Ah	8018h	8016h	804Eh	804Ch	804Ah	8048h	8046h
	Hardware revision	01A06h	1	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit
	Firmware revision	01A07h	1	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit
Die Record	Die record tag	01A08h	1	08h	08h	08h	08h	08h	08h	08h	08h	08h
	Die record length	01A09h	1	0Ah	0Ah	0Ah	0Ah	0Ah	0Ah	0Ah	0Ah	0Ah
	Lot/wafer ID	01A0Ah	4	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit
	Die X position	01A0Eh	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit
	Die Y position	01A10h	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit
	Test results	01A12h	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit
ADC12 Calibration	ADC12 calibration tag	01A14h	1	11h	11h	11h	11h	11h	11h	05h	05h	05h
	ADC12 calibration length	01A15h	1	10h	10h	10h	10h	10h	10h	10h	10h	10h
	ADC gain factor	01A16h	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	N/A	N/A	N/A
	ADC offset	01A18h	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	N/A	N/A	N/A
	ADC 1.5-V reference Temperature sensor 30°C	01A1Ah	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	N/A	N/A	N/A
	ADC 1.5-V reference Temperature sensor 85°C	01A1Ch	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	N/A	N/A	N/A
	ADC 2.0-V reference Temperature sensor 30°C	01A1Eh	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	N/A	N/A	N/A
	ADC 2.0-V reference Temperature sensor 85°C	01A20h	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	N/A	N/A	N/A
	ADC 2.5-V reference Temperature sensor 30°C	01A22h	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	N/A	N/A	N/A
	ADC 2.5-V reference Temperature sensor 85°C	01A24h	2	Per unit	Per unit	Per unit	Per unit	Per unit	Per unit	N/A	N/A	N/A

(1) NA = Not applicable

10 Device and Documentation Support

10.1 Getting Started and Next Steps

For more information on the MSP430™ family of devices and the tools and libraries that are available to help with your development, visit the [MSP430 ultra-low-power sensing & measurement MCUs overview](#).

10.2 Device Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all MSP MCU devices. Each MSP MCU commercial family member has one of two prefixes: MSP or XMS. These prefixes represent evolutionary stages of product development from engineering prototypes (XMS) through fully qualified production devices (MSP).

XMS – Experimental device that is not necessarily representative of the final device's electrical specifications

MSP – Fully qualified production device

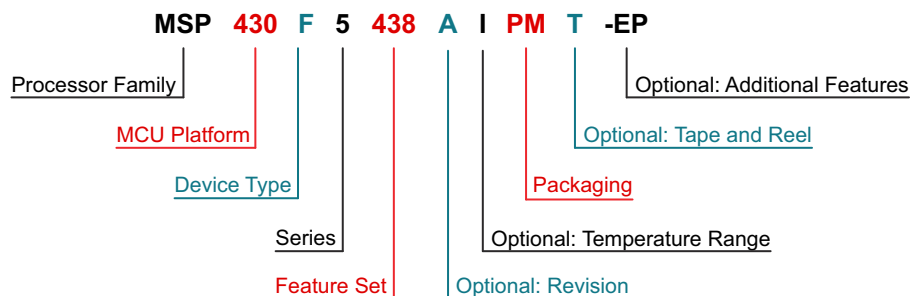
XMS devices are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

MSP devices have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (XMS) have a greater failure rate than the standard production devices. TI recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the temperature range, package type, and distribution format. [图 10-1](#) provides a legend for reading the complete device name.



Processor Family	CC = Embedded RF Radio MSP = Mixed-Signal Processor XMS = Experimental Silicon PMS = Prototype Device	
MCU Platform	430 = MSP430 low-power microcontroller platform	
Device Type	Memory Type C = ROM F = Flash FR = FRAM G = Flash L = No nonvolatile memory	Specialized Application AFE = Analog front end BQ = Contactless power CG = ROM medical FE = Flash energy meter FG = Flash medical FW = Flash electronic flow meter
Series	1 = Up to 8 MHz 2 = Up to 16 MHz 3 = Legacy 4 = Up to 16 MHz with LCD driver	5 = Up to 25 MHz 6 = Up to 25 MHz with LCD driver 0 = Low-voltage series
Feature Set	Various levels of integration within a series	
Optional: Revision	Updated version of the base part number	
Optional: Temperature Range	S = 0°C to 50°C C = 0°C to 70°C I = -40°C to 85°C T = -40°C to 105°C	
Packaging	http://www.ti.com/packaging	
Optional: Tape and Reel	T = Small reel R = Large reel No markings = Tube or tray	
Optional: Additional Features	-EP = Enhanced product (-40°C to 105°C) -HT = Extreme temperature parts (-55°C to 150°C) -Q1 = Automotive Q100 qualified	

图 10-1. Device Nomenclature

10.3 Tools and Software

All MSP microcontrollers are supported by a wide variety of software and hardware development tools. Tools are available from TI and various third parties. See them all at [MSP430 ultra-low-power MCUs – Design & development](#).

表 10-1 lists the debug features of the MSP430F663x MCUs. See the [Code Composer Studio™ IDE for MSP430™ MCUs User's Guide](#) for details on the available features.

表 10-1. Hardware Debug Features

MSP430 ARCHITECTURE	4-WIRE JTAG	2-WIRE JTAG	BREAK- POINTS (N)	RANGE BREAK- POINTS	CLOCK CONTROL	STATE SEQUENCER	TRACE BUFFER	LPMx.5 DEBUGGING SUPPORT
MSP430Xv2	Yes	Yes	8	Yes	Yes	Yes	Yes	Yes

Design Kits and Evaluation Modules

[MSP-TS430PZ100USB - 100-pin Target Development Board for MSP430F5x and MSP430F6x MCUs](#)

The MSP-TS430PZ100USB is a stand-alone 100-pin ZIF socket target board used to program and debug the MSP430 MCU in-system through the JTAG interface or the Spy Bi-Wire (2-wire JTAG) protocol.

[100-pin Target Development Board and MSP-FET Programmer Bundle for MSP430F5x and MSP430F6x MCUs](#)

The MSP-FET is a powerful flash emulation tool to quickly begin application development on the MSP430 MCU. It includes USB debugging interface used to program and debug the MSP430 in-system through the JTAG interface or the pin saving Spy Bi-Wire (2-wire JTAG) protocol. The flash memory can be erased and programmed in seconds with only a few keystrokes, and because the MSP430 flash is ultra-low power, no external power supply is required.

Software

[MSP430Ware™ Software](#)

MSP430Ware software is a collection of code examples, data sheets, and other design resources for all MSP430 devices delivered in a convenient package. In addition to providing a complete collection of existing MSP430 design resources, MSP430Ware software also includes a high-level API called MSP430 Driver Library. This library makes it easy to program MSP430 hardware. MSP430Ware software is available as a component of CCS or as a stand-alone package.

[MSP430F563x, MSP430F663x Code Examples](#)

C code examples are available for every MSP device that configures each of the integrated peripherals for various application needs.

[MSP Driver Library](#)

Driver Library's abstracted API keeps you above the bits and bytes of the MSP430 hardware by providing easy-to-use function calls. Thorough documentation is delivered through a helpful API Guide, which includes details on each function call and the recognized parameters. Developers can use Driver Library functions to write complete projects with minimal overhead.

[MSP EnergyTrace™ Technology](#)

EnergyTrace technology for MSP430 microcontrollers is an energy-based code analysis tool that measures and displays the application's energy profile and helps to optimize it for ultra-low-power consumption.

ULP (Ultra-Low Power) Advisor

ULP Advisor™ software is a tool for guiding developers to write more efficient code to fully utilize the unique ultra-low power features of MSP and MSP432 microcontrollers. Aimed at both experienced and new microcontroller developers, ULP Advisor checks your code against a thorough ULP checklist to squeeze every last nano amp out of your application. At build time, ULP Advisor will provide notifications and remarks to highlight areas of your code that can be further optimized for lower power.

IEC 60730 Software Package

The IEC 60730 MSP430 software package was developed to be useful in assisting customers in complying with IEC 60730-1:2010 (Automatic Electrical Controls for Household and Similar Use - Part 1: General Requirements) for up to Class B products, which includes home appliances, arc detectors, power converters, power tools, e-bikes, and many others. The IEC 60730 MSP430 software package can be embedded in customer applications running on MSP430s to help simplify the customer's certification efforts of functional safety-compliant consumer devices to IEC 60730-1:2010 Class B.

Fixed Point Math Library for MSP

The MSP IQmath and Qmath Libraries are a collection of highly optimized and high-precision mathematical functions for C programmers to seamlessly port a floating-point algorithm into fixed-point code on MSP430 MCUs. These routines are typically used in computationally intensive real-time applications where optimal execution speed, high accuracy, and ultra-low energy are critical. By using the IQmath and Qmath libraries, it is possible to achieve execution speeds considerably faster and energy consumption considerably lower than equivalent code written using floating-point math.

Floating Point Math Library for MSP430

Continuing to innovate in the low-power and low-cost microcontroller space, TI brings you MSPMATHLIB. Leveraging the intelligent peripherals of our devices, this floating point math library of scalar functions brings you up to 26x better performance. Mathlib is easy to integrate into your designs. This library is free and is integrated in both Code Composer Studio and IAR IDEs. Read the user's guide for an in depth look at the math library and relevant benchmarks.

Development Tools

Code Composer Studio™ Integrated Development Environment for MSP Microcontrollers

The Code Composer Studio integrated development environment (IDE) supports all MSP microcontroller devices. The Code Composer Studio IDE comprises a suite of embedded software utilities used to develop and debug embedded applications. It includes an optimizing C/C++ compiler, source code editor, project build environment, debugger, profiler, and many other features. The intuitive IDE provides a single user interface taking you through each step of the application development flow. Familiar utilities and interfaces allow users to get started faster than ever before. The Code Composer Studio IDE combines the advantages of the Eclipse software framework with advanced embedded debug capabilities from TI resulting in a compelling feature-rich development environment for embedded developers. When using the Code Composer Studio IDE with an MSP430 MCU, a unique and powerful set of plugins and embedded software utilities are made available to fully leverage the MSP430 microcontroller.

Command-Line Programmer

MSP Flasher is an open-source shell-based interface for programming MSP microcontrollers through a FET programmer or eZ430 using JTAG or Spy-Bi-Wire (SBW) communication. MSP Flasher can download binary files (.txt or .hex) files directly to the MSP microcontroller without an IDE.

MSP MCU Programmer and Debugger

The MSP-FET is a powerful emulation development tool – often called a debug probe – that lets users quickly begin application development on MSP low-power microcontrollers (MCU). Creating MCU software usually requires downloading the resulting binary program to the MSP device for validation and debugging. The MSP-FET provides a debug communication pathway between a host computer and the target MSP. Furthermore, the MSP-FET also provides a Backchannel UART connection between the computer's USB interface and the MSP UART. This gives the MSP programmer a convenient method to communicate serially between the MSP and a terminal running on the computer. It also supports loading programs (often called firmware) to the MSP target using the BSL (bootloader) through the UART and I²C communication protocols.

MSP-GANG Production Programmer

The MSP Gang Programmer is a device programmer that can program up to eight identical MSP430 or MSP432 flash or FRAM devices at the same time. The MSP Gang Programmer connects to a host PC using a standard RS-232 or USB connection and provides flexible programming options that allow the user to fully customize the process. The MSP Gang Programmer is provided with an expansion board, called the Gang Splitter, that implements the interconnections between the MSP Gang Programmer and multiple target devices. Eight cables are provided that connect the expansion board to eight target devices (through JTAG or Spy-Bi-Wire connectors). The programming can be done with a PC or as a stand-alone device. A PC-side graphical user interface is also available and is DLL-based.

10.4 Documentation Support

The following documents describe the MSP430F663x MCUs. Copies of these documents are available on the Internet at www.ti.com.

Receiving Notification of Document Updates

To receive notification of documentation updates—including silicon errata—go to the product folder for your device on ti.com (for links to the product folders, see [节 10.5](#)). In the upper right corner, click the "Alert me" button. This registers you to receive a weekly digest of product information that has changed (if any). For change details, check the revision history of any revised document.

Errata

[MSP430F6638 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

[MSP430F6637 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

[MSP430F6636 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

[MSP430F6635 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

[MSP430F6634 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

[MSP430F6633 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

[MSP430F6632 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

[MSP430F6631 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

[MSP430F6630 Device Erratasheet](#)

Describes the known exceptions to the functional specifications for this device.

User's Guides

[MSP430x5xx and MSP430x6xx Family User's Guide](#)

Detailed information on the modules and peripherals available in this device family.

[IAR Embedded Workbench IDE for MSP430 MCUs User's Guide](#)

This manual describes the use of IAR Embedded Workbench (EW430) with the MSP430 ultra-low-power microcontrollers.

[MSP430™ Flash Devices Bootloader \(BSL\) User's Guide](#)

The MSP430 BSL lets users communicate with embedded memory in the MSP430 microcontroller during the prototyping phase, final production, and in service. Both the programmable memory (flash memory) and the data memory (RAM) can be modified as required. Do not confuse the bootloader with the bootstrap loader programs found in some digital signal processors (DSPs) that automatically load program code (and data) from external memory to the internal memory of the DSP.

[MSP430 Programming With the JTAG Interface](#)

This document describes the functions that are required to erase, program, and verify the memory module of the MSP430 flash-based and FRAM-based microcontroller families using the JTAG communication port. In addition, it describes how to program the JTAG access security fuse that is available on all MSP430 devices. This document describes device access using both the standard 4-wire JTAG interface and the 2-wire JTAG interface, which is also referred to as Spy-Bi-Wire (SBW).

[MSP430 Hardware Tools User's Guide](#)

This manual describes the hardware of the TI MSP-FET430 Flash Emulation Tool (FET). The FET is the program development tool for the MSP430 ultra-low-power microcontroller. Both available interface types, the parallel port interface and the USB interface, are described.

Application Reports

[MSP430 32-kHz Crystal Oscillators](#)

Selection of the right crystal, correct load circuit, and proper board layout are important for a stable crystal oscillator. This application report summarizes crystal oscillator function and explains the parameters to select the correct crystal for MSP430 ultra-low-power operation. In addition, hints and examples for correct board layout are given. The document also contains detailed information on the possible oscillator tests to ensure stable oscillator operation in mass production.

[MSP430 System-Level ESD Considerations](#)

System-level ESD has become increasingly demanding with silicon technology scaling towards lower voltages and the need for designing cost-effective and ultra-low-power components. This application report addresses three different ESD topics to help board designers and OEMs understand and design robust system-level designs.

10.5 Related Links

表 10-2 lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

表 10-2. Related Links

PARTS	PRODUCT FOLDER	ORDER NOW	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
MSP430F6638	Click here	Click here	Click here	Click here	Click here
MSP430F6637	Click here	Click here	Click here	Click here	Click here
MSP430F6636	Click here	Click here	Click here	Click here	Click here
MSP430F6635	Click here	Click here	Click here	Click here	Click here
MSP430F6634	Click here	Click here	Click here	Click here	Click here
MSP430F6633	Click here	Click here	Click here	Click here	Click here
MSP430F6632	Click here	Click here	Click here	Click here	Click here
MSP430F6631	Click here	Click here	Click here	Click here	Click here
MSP430F6630	Click here	Click here	Click here	Click here	Click here

10.6 支持资源

TI E2E™ 支持论坛是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

10.7 Trademarks

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10.10 术语表

TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
MSP430F6630IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6630
MSP430F6630IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6630
MSP430F6631IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6631
MSP430F6631IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6631
MSP430F6632IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6632
MSP430F6632IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6632
MSP430F6632IPZR	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6632
MSP430F6632IPZR.B	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6632
MSP430F6633IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6633
MSP430F6633IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6633
MSP430F6633IPZR	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6633
MSP430F6633IPZR.B	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6633
MSP430F6634IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6634
MSP430F6634IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6634
MSP430F6634IPZR	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6634
MSP430F6634IPZR.B	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6634
MSP430F6634IZCAR	Active	Production	NFBGA (ZCA) 113	2500 LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	F6634
MSP430F6634IZCAR.B	Active	Production	NFBGA (ZCA) 113	2500 LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	F6634
MSP430F6635IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6635
MSP430F6635IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6635

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
MSP430F6635IPZR	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6635
MSP430F6635IPZR.B	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6635
MSP430F6635IZCAR	Active	Production	NFBGA (ZCA) 113	2500 LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	F6635
MSP430F6635IZCAR.B	Active	Production	NFBGA (ZCA) 113	2500 LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	F6635
MSP430F6636IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6636
MSP430F6636IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6636
MSP430F6636IPZR	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6636
MSP430F6636IPZR.B	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6636
MSP430F6636IZQWR	Obsolete	Production	BGA MICROSTAR JUNIOR (ZQW) 113	-	-	Call TI	Call TI	-40 to 85	M430F6636
MSP430F6637IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6637
MSP430F6637IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6637
MSP430F6638CY	Active	Production	DIESALE (Y) 0	49 null	Yes	Call TI	N/A for Pkg Type	0 to 70	
MSP430F6638CY.B	Active	Production	DIESALE (Y) 0	49 null	Yes	Call TI	N/A for Pkg Type	0 to 70	
MSP430F6638IPZ	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6638
MSP430F6638IPZ.B	Active	Production	LQFP (PZ) 100	90 JEDEC TRAY (10+1)	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6638
MSP430F6638IPZR	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6638
MSP430F6638IPZR.B	Active	Production	LQFP (PZ) 100	1000 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	M430F6638
MSP430F6638IZCAR	Active	Production	NFBGA (ZCA) 113	2500 LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	F6638
MSP430F6638IZCAR.B	Active	Production	NFBGA (ZCA) 113	2500 LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	F6638
MSP430F6638IZCAT	Active	Production	NFBGA (ZCA) 113	250 SMALL T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	F6638
MSP430F6638IZCAT.B	Active	Production	NFBGA (ZCA) 113	250 SMALL T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	F6638
MSP430F6638IZQWR	Obsolete	Production	BGA MICROSTAR JUNIOR (ZQW) 113	-	-	Call TI	Call TI	-40 to 85	M430F6638
MSP430F6638IZQWT	Obsolete	Production	BGA MICROSTAR JUNIOR (ZQW) 113	-	-	Call TI	Call TI	-40 to 85	M430F6638

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

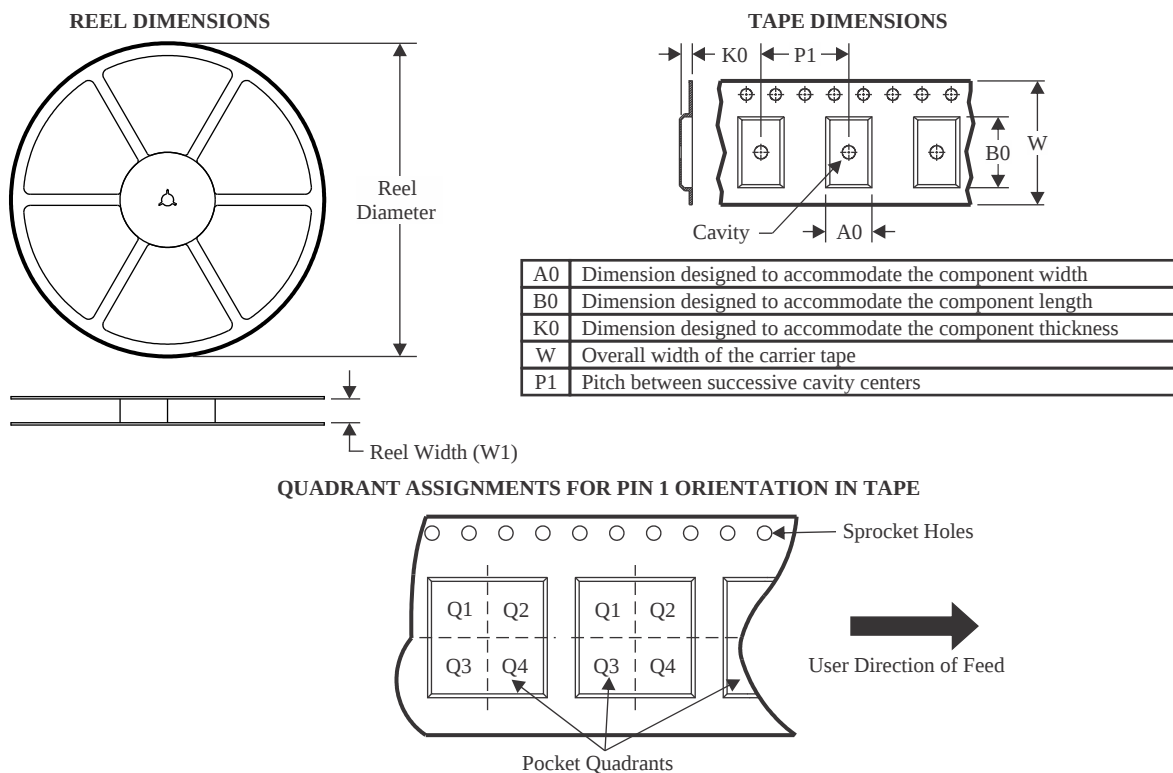
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

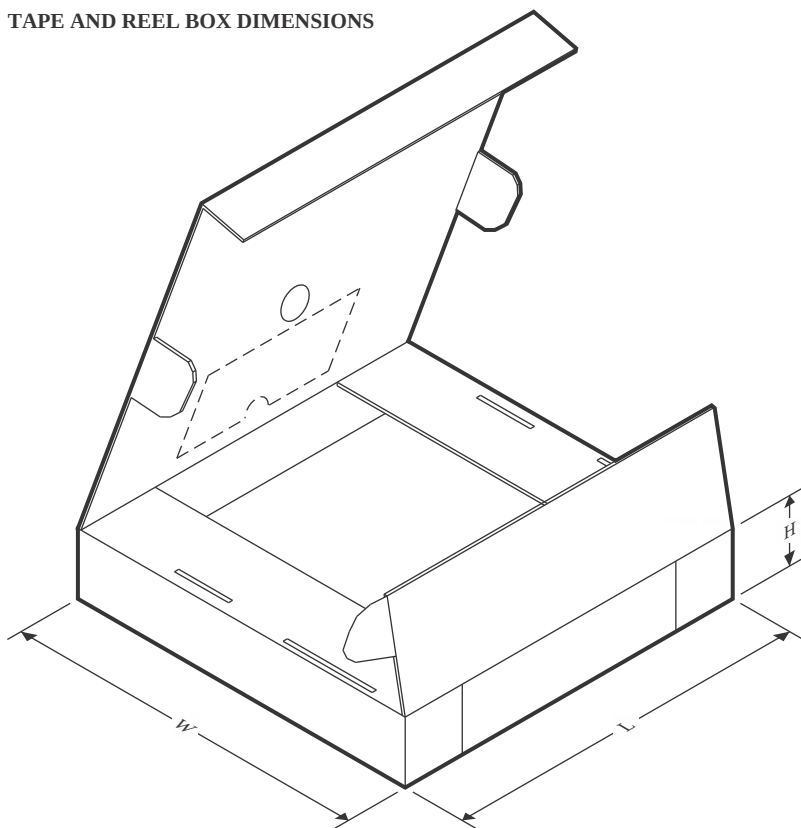
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
MSP430F6632IPZR	LQFP	PZ	100	1000	330.0	24.4	17.0	17.0	2.1	20.0	24.0	Q2
MSP430F6633IPZR	LQFP	PZ	100	1000	330.0	24.4	17.0	17.0	2.1	20.0	24.0	Q2
MSP430F6634IZCAR	NFBGA	ZCA	113	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q1
MSP430F6635IPZR	LQFP	PZ	100	1000	330.0	24.4	17.0	17.0	2.1	20.0	24.0	Q2
MSP430F6635IZCAR	NFBGA	ZCA	113	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q1
MSP430F6638IPZR	LQFP	PZ	100	1000	330.0	24.4	17.0	17.0	2.1	20.0	24.0	Q2
MSP430F6638IZCAR	NFBGA	ZCA	113	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q1
MSP430F6638IZCAR	NFBGA	ZCA	113	2500	330.0	16.4	7.3	7.3	1.5	12.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS

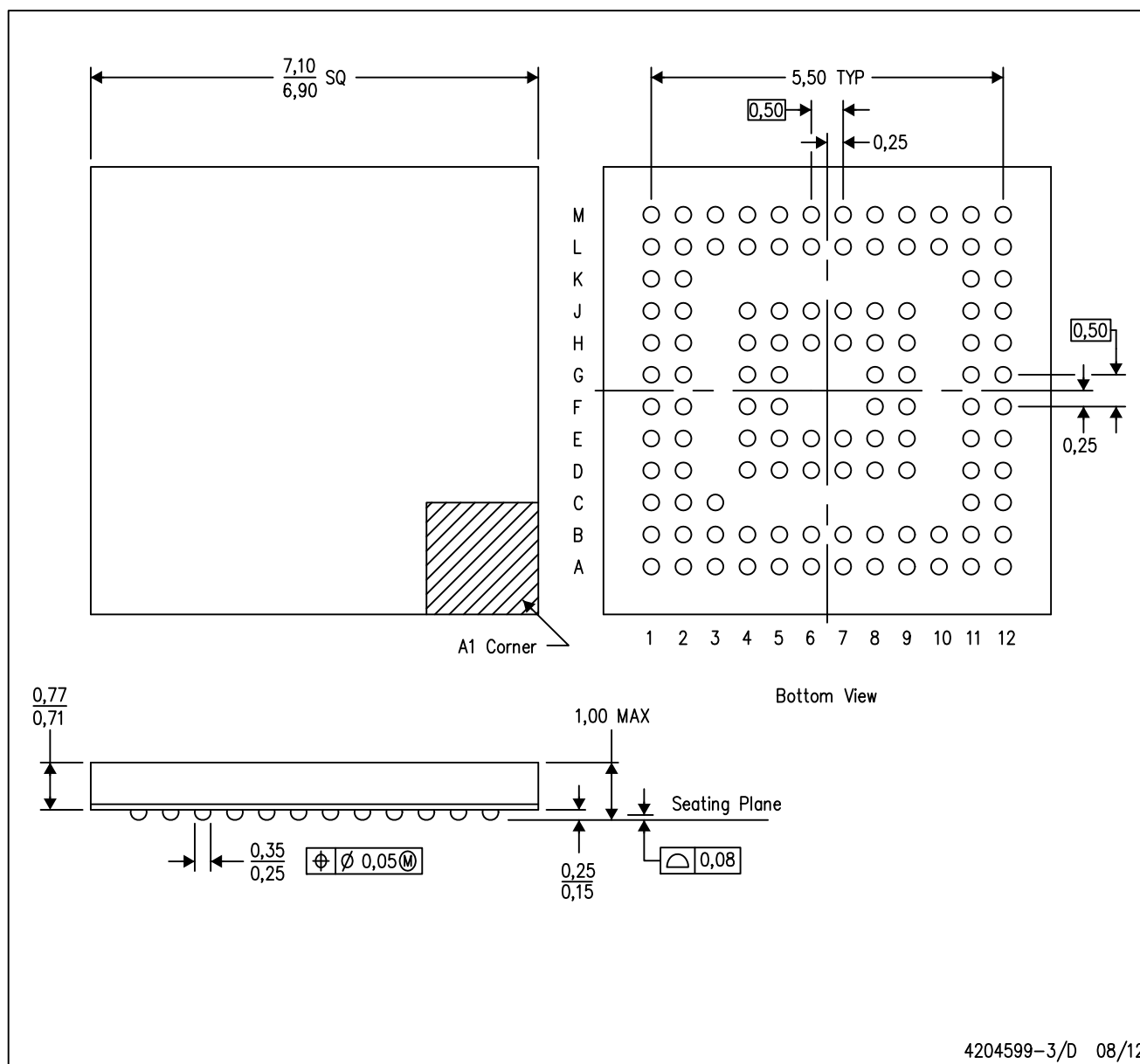


*All dimensions are nominal

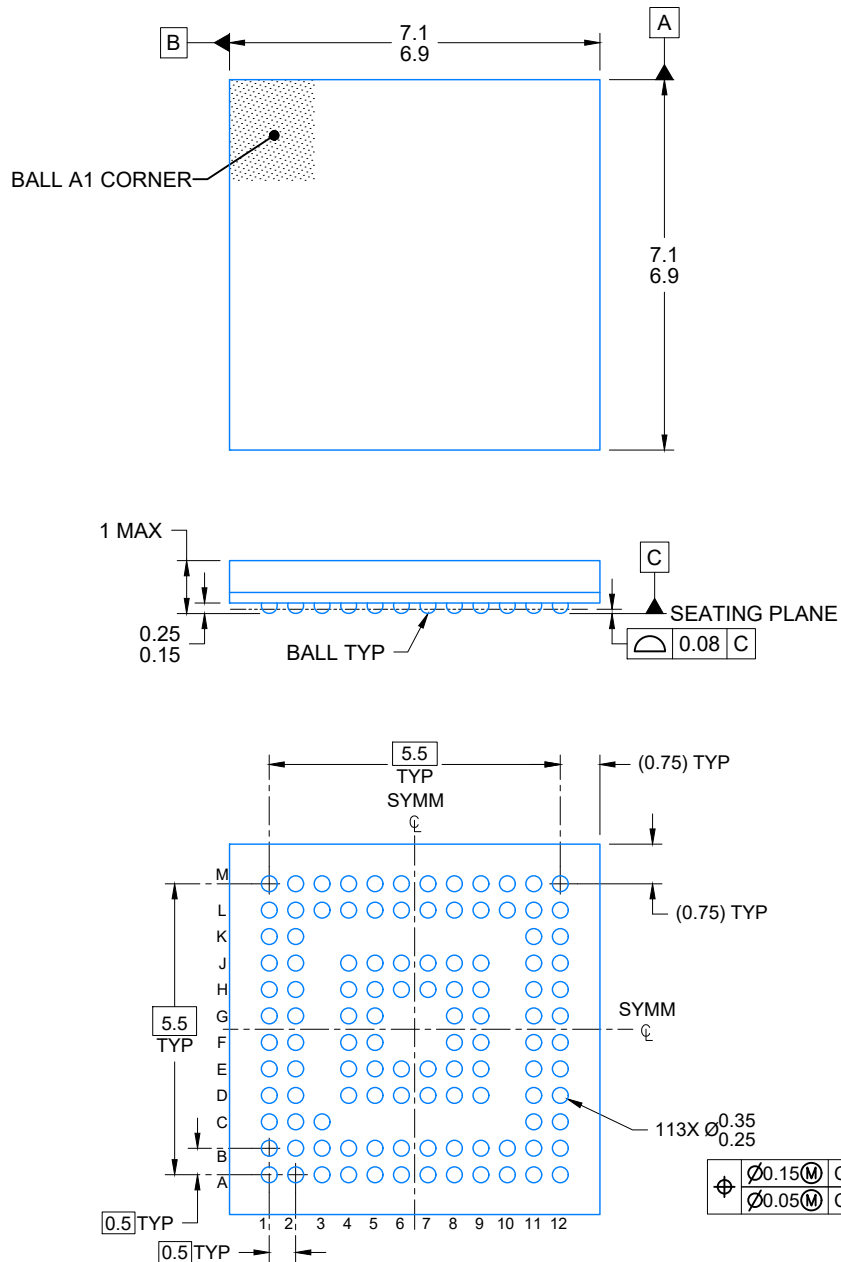
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
MSP430F6632IPZR	LQFP	PZ	100	1000	350.0	350.0	43.0
MSP430F6633IPZR	LQFP	PZ	100	1000	350.0	350.0	43.0
MSP430F6634IZCAR	NFBGA	ZCA	113	2500	350.0	350.0	43.0
MSP430F6635IPZR	LQFP	PZ	100	1000	350.0	350.0	43.0
MSP430F6635IZCAR	NFBGA	ZCA	113	2500	350.0	350.0	43.0
MSP430F6638IPZR	LQFP	PZ	100	1000	350.0	350.0	43.0
MSP430F6638IZCAR	NFBGA	ZCA	113	2500	336.6	336.6	31.8
MSP430F6638IZCAR	NFBGA	ZCA	113	2500	350.0	350.0	43.0

ZQW (S-PBGA-N113)

PLASTIC BALL GRID ARRAY



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MO-225
 - D. This is a Pb-free solder ball design.

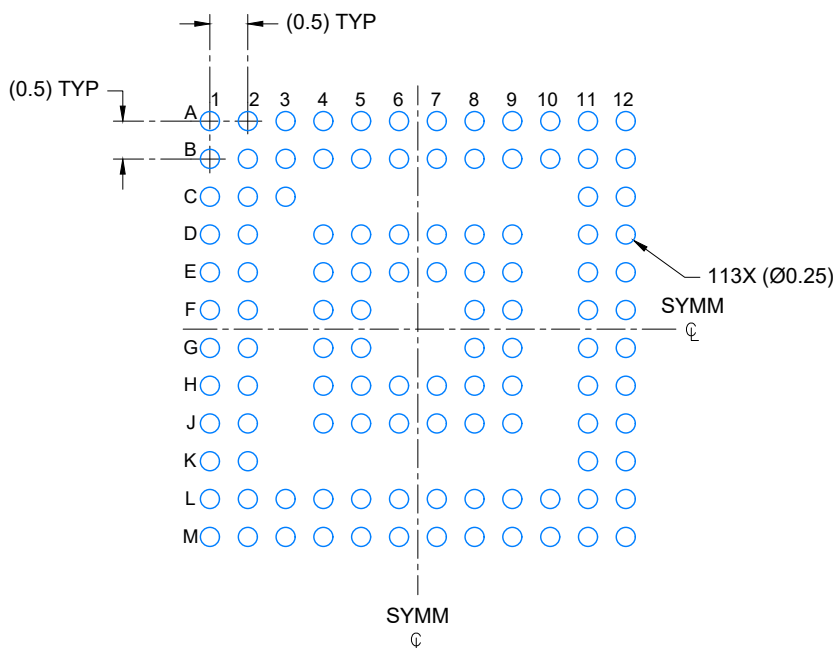


4225149/A 08/2019

NOTES:

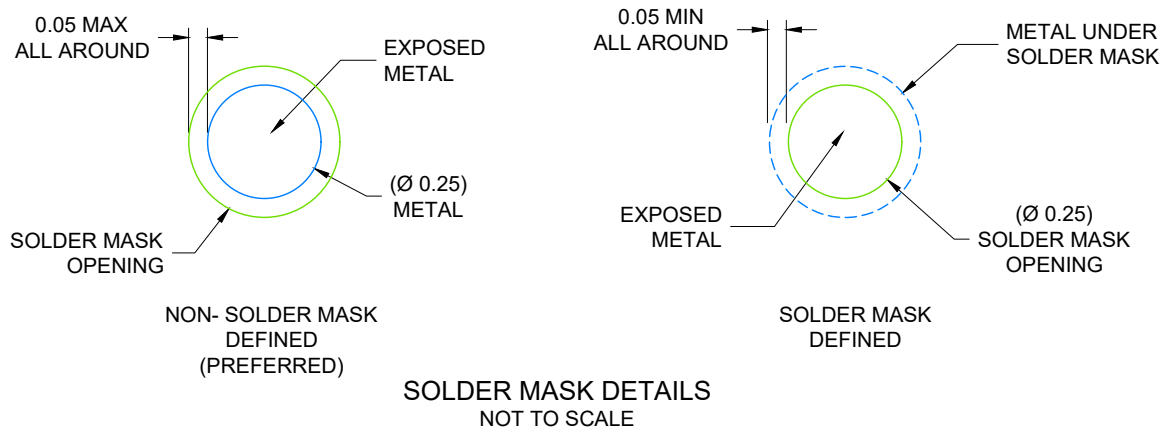
NanoFree is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.



LAND PATTERN EXAMPLE

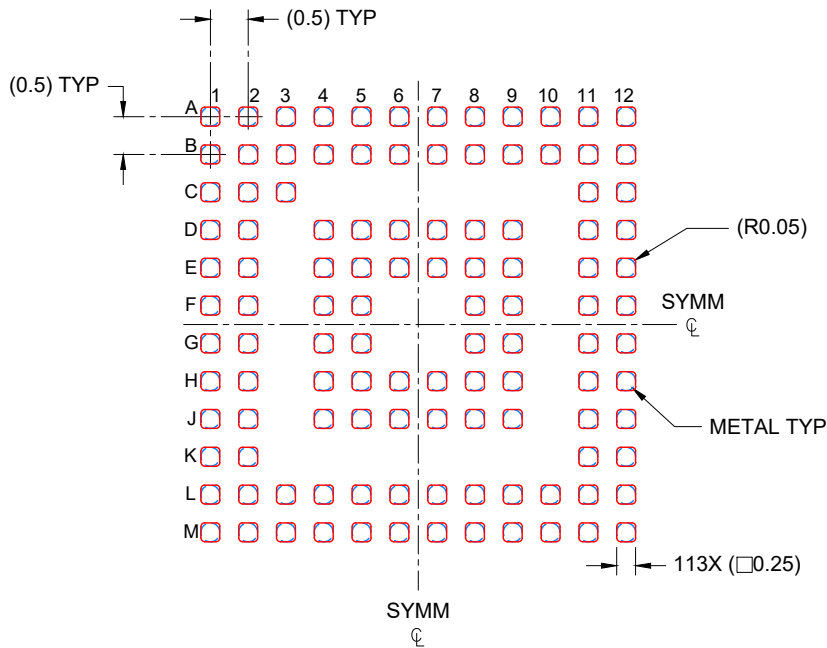
SCALE: 10X

SOLDER MASK DETAILS
NOT TO SCALE

4225149/A 08/2019

NOTES: (continued)

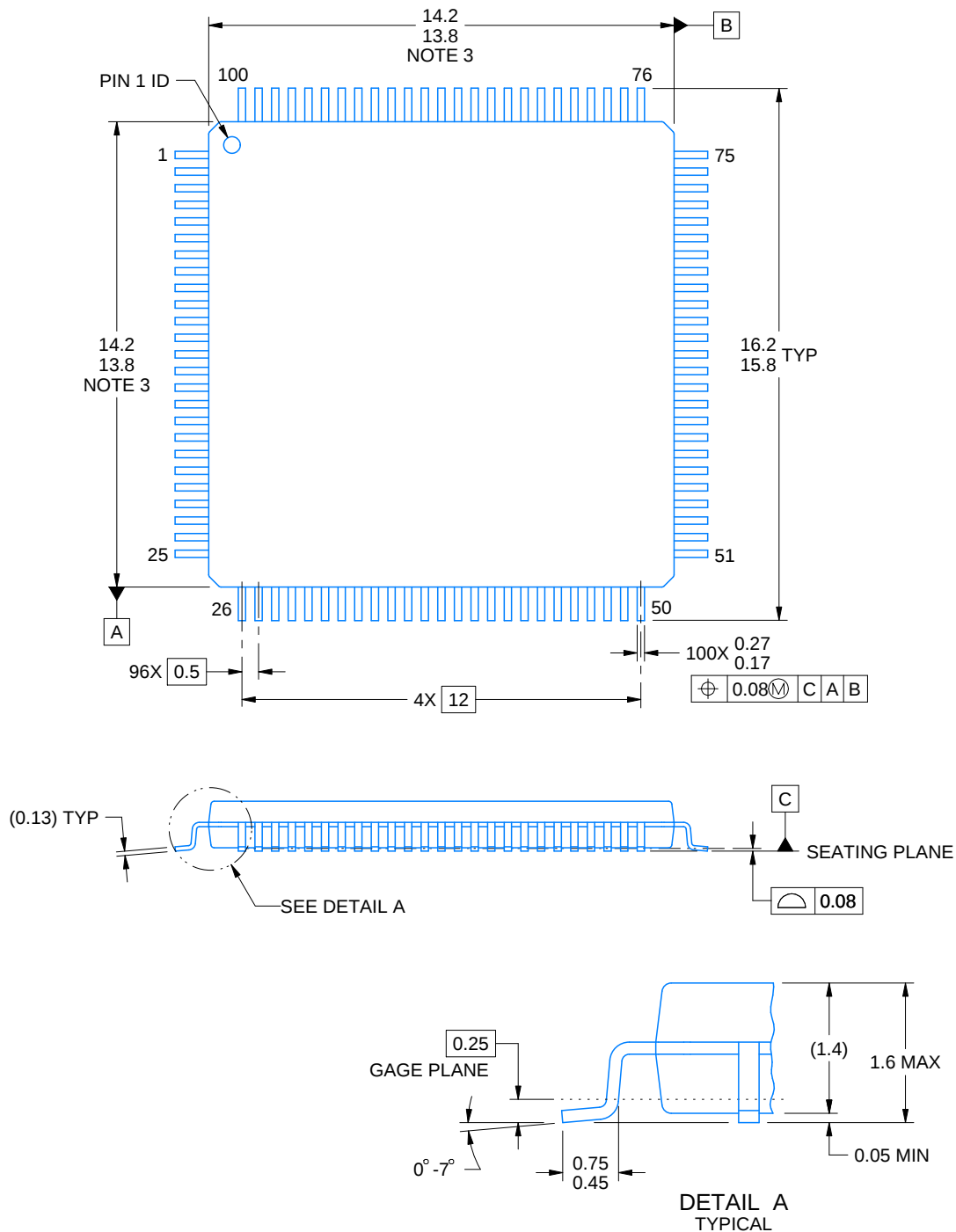
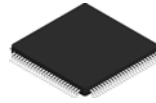
- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. Refer to Texas Instruments Literature number SNVA009 (www.ti.com/lit/snva009).



SOLDER PASTE EXAMPLE
BASED ON 0.100 mm THICK STENCIL
SCALE: 10X

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



4215169/A 03/2017

NOTES:

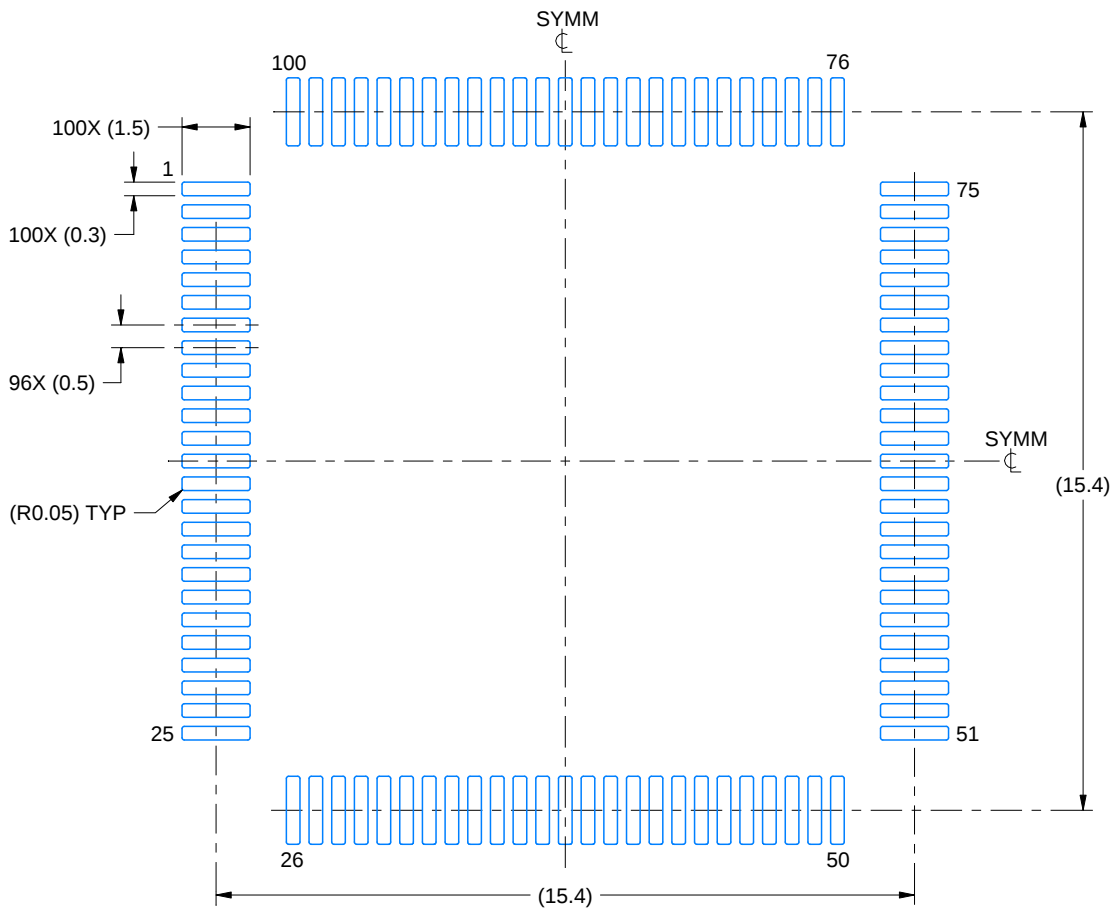
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MS-026.

EXAMPLE BOARD LAYOUT

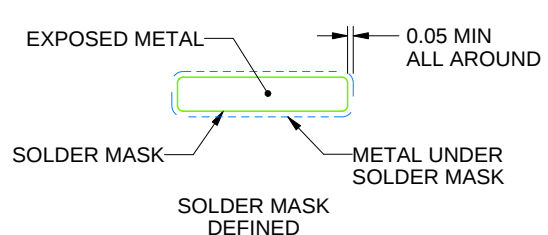
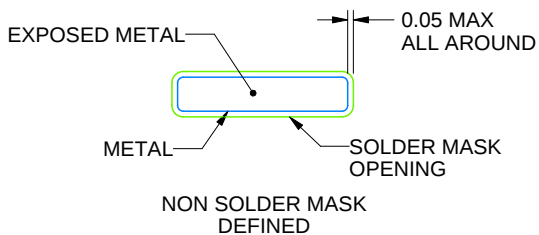
PZ0100A

LQFP - 1.6 mm max height

PLASTIC QUAD FLATPACK



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:6X



SOLDER MASK DETAILS

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NOTES: (continued)

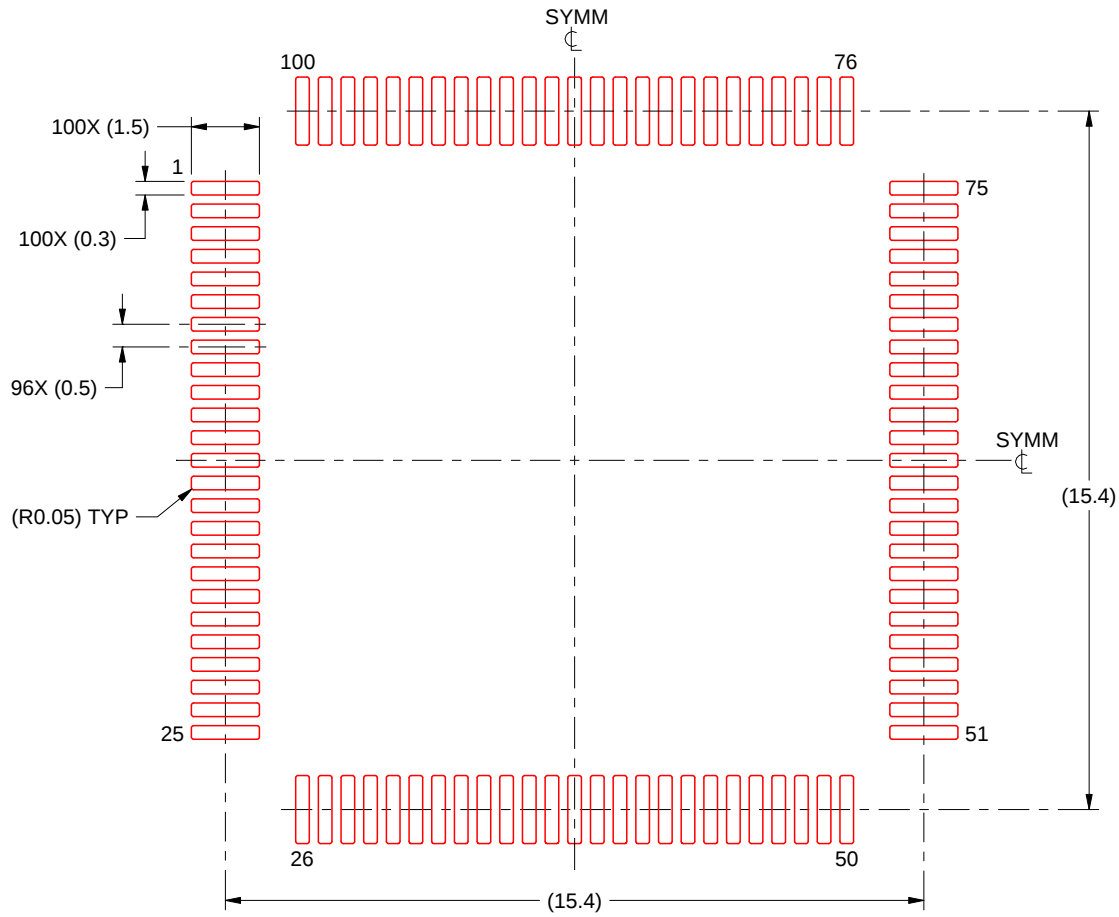
5. Publication IPC-7351 may have alternate designs.
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
7. For more information, see Texas Instruments literature number SLMA004 (www.ti.com/lit/slma004).

EXAMPLE STENCIL DESIGN

PZ0100A

LQFP - 1.6 mm max height

PLASTIC QUAD FLATPACK



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:6X

4215169/A 03/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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最后更新日期：2025 年 10 月